

IGLOO PLUS Low Power Flash FPGAs

with Flash*Freeze Technology

Features and Benefits

Low Power

- 1.2 V to 1.5 V Core Voltage Support for Low Power
- Supports Single-Voltage System Operation
- 5 μW Power Consumption in Flash*Freeze Mode
- Low Power Active FPGA Operation
- Flash*Freeze Technology Enables Ult Consumption while Maintaining FPGA Content Ultra-Low Power
- Configurable Hold Previous State, Tristate, HIGH, or LOW State per I/Ŏ in Flash*Freeze Mode
- Easy Entry To / Exit From Ultra-Low Power Flash*Freeze Mode

Feature Rich

- 30 k to 125 k System Gates
- Up to 36 kbits of True Dual-Port SRAM
- Up to 212 User I/Os

Reprogrammable Flash Technology

- 130-nm, 7-Layer Metal, Flash-Based CMOS Process
- Instant On Level 0 Support
- Single-Chip Solution
- Retains Programmed Design When Powered Off
- 250 MHz (1.5 V systems) and 160 MHz (1.2 V systems) System Performance

In-System Programming (ISP) and Security

- ISP Using On-Chip 128-Bit Advanced Encryption Standard (AES) Decryption via JTAG (IEEE 1532–compliant) FlashLock® Designed to Secure FPGA Contents

High-Performance Routing Hierarchy

Segmented, Hierarchical Routing and Clock Structure

Advanced I/O

- 1.2 V, 1.5 V, 1.8 V, 2.5 V, and 3.3 V Mixed-Voltage Operation
- Bank-Selectable I/O Voltages-4 Banks per Chip on All IGLOO® PLUS Devices
- Single-Ended **LVCMOS** I/O Standards: LVTTL. 3.3 V / 2.5 V / 1.8 V / 1.5 V / 1.2 V
- Selectable Schmitt Trigger Inputs
 Wide Range Power Supply Voltage Support per JESD8-B,
 Allowing I/Os to Operate from 2.7 V to 3.6 V
- Wide Range Power Supply Voltage Support per JESD8-12, Allowing I/Os to Operate from 1.14 V to 1.575 V
- I/O Registers on Input, Output, and Enable Paths
- Hot-Swappable and Cold-Sparing I/Os
- Programmable Output Slew Rate and Drive Strength
- Weak Pull-Up/-Down
- IEEE 1149.1 (JTAG) Boundary Scan Test
- Pin-Compatible Small-Footprint Packages across the IGLOO PLUS Family

Clock Conditioning Circuit (CCC) and PLL[†]

- Six CCC Blocks, One with an Integrated PLL
- Configurable Phase Shift, Multiply/Divide, Delay Capabilities, and External Feedback
- Wide Input Frequency Range (1.5 MHz up to 250 MHz)

Embedded Memory

- 1 kbit of FlashROM User Nonvolatile Memory
- SRAMs and FIFOs with Variable-Aspect-Ratio 4,608-Bit RAM Blocks (×1, ×2, ×4, ×9, and ×18 organizations)
- True Dual-Port SRAM (except ×18)

lable	1 •	IGLOO	PLUS	Product	Family

IGLOO PLUS Devices	AGLP030	AGLP060	AGLP125
System Gates	30,000	60,000	125,000
Typical Equivalent Macrocells	256	512	1,024
VersaTiles (D-flip-flops)	792	1,584	3,120
Flash*Freeze Mode (typical, μW)	5	10	16
RAM Kbits (1,024 bits)	-	18	36
4,608-Bit Blocks	-	4	8
Secure (AES) ISP	-	Yes	Yes
FlashROM Kbits	1	1	1
Integrated PLL in CCCs ¹	-	1	1
VersaNet Globals ²	6	18	18
I/O Banks	4	4	4
Maximum User I/Os	120	157	212
Package Pins CS VQ	CS201, CS289 VQ128	CS201, CS289 VQ176	CS281, CS289

Notes:

- 1. AGLP060 in CS201 does not support the PLL.
- Six chip (main) and twelve quadrant global networks are available for AGLP060 and AGLP125.

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[†] The AGLP030 device does not support this feature.



I/Os Per Package ¹

IGLOO PLUS Devices	AGLP030	AGLP060	AGLP125				
Package		Single-Ended I/Os					
CS201	120	157	_				
CS281	-	-	212				
CS289	120	157	212				
VQ128	101	-	-				
VQ176	-	137	_				

Note: When the Flash*Freeze pin is used to directly enable Flash*Freeze mode and not used as a regular I/O, the number of single-ended user I/Os available is reduced by one.

Table 2 • IGLOO PLUS FPGAs Package Size Dimensions

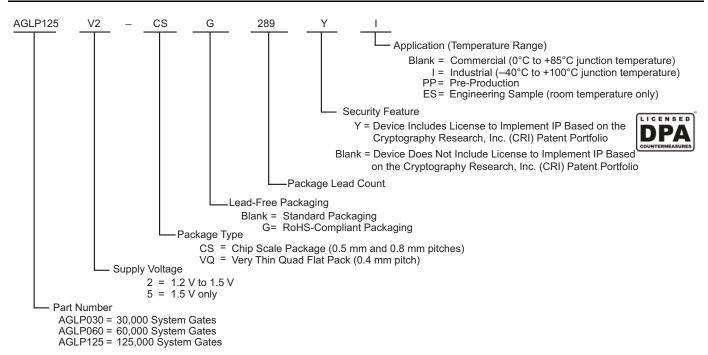
Package	CS201	CS281	CS289	VQ128	VQ176
Length × Width (mm/mm)	8 × 8	10 × 10	14 × 14	14 × 14	20 × 20
Nominal Area (mm2)	64	100	196	196	400
Pitch (mm)	0.5	0.5	0.8	0.4	0.4
Height (mm)	0.89	1.05	1.20	1.0	1.0

IGLOO PLUS Device Status

IGLOO PLUS Device	Status
AGLP030	Production
AGLP060	Production
AGLP125	Production

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IGLOO PLUS Ordering Information



- Marking information: IGLOO PLUS V2 devices do not have a V2 marking, but IGLOO PLUS V5 devices are marked accordingly.
- 2. "G" indicates RoHS-compliant packages.

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Temperature Grade Offerings

Package	AGLP030	AGLP060	AGLP125
CS201	C, I	C, I	-
CS281	-	-	C, I
CS289	C, I	C, I	C, I
VQ128	C, I	-	-
VQ176	-	C, I	-

Notes:

- C = Commercial temperature range: 0°C to 85°C junction temperature.
 I = Industrial temperature range: -40°C to 100°C junction temperature.

Contact your local Microsemi SoC Products Group representative for device availability:

http://www.microsemi.com/soc/company/contact/default.aspx.

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1 – IGLOO PLUS Device Family Overview

General Description

The IGLOO PLUS family of flash FPGAs, based on a 130 nm flash process, offers the lowest power FPGA, a single-chip solution, small-footprint packages, reprogrammability, and an abundance of advanced features.

The Flash*Freeze technology used in IGLOO PLUS devices enables entering and exiting an ultra-low power mode that consumes as little as 5 μ W while retaining the design information, SRAM content, registers, and I/O states. Flash*Freeze technology simplifies power management through I/O and clock management with rapid recovery to operation mode.

The Low Power Active capability (static idle) allows for ultra-low power consumption while the IGLOO PLUS device is completely functional in the system. This allows the IGLOO PLUS device to control system power management based on external inputs (e.g., scanning for keyboard stimulus) while consuming minimal power.

Nonvolatile flash technology gives IGLOO PLUS devices the advantage of being a secure, low power, single-chip solution that is Instant On. IGLOO PLUS is reprogrammable and offers time-to-market benefits at an ASIC-level unit cost.

These features enable designers to create high-density systems using existing ASIC or FPGA design flows and tools.

IGLOO PLUS devices offer 1 kbit of on-chip, reprogrammable, nonvolatile FlashROM storage as well as clock conditioning circuitry based on an integrated phase-locked loop (PLL). IGLOO PLUS devices have up to 125 k system gates, supported with up to 36 kbits of true dual-port SRAM and up to 212 user I/Os. The AGLP030 devices have no PLL or RAM support.

Flash*Freeze Technology

The IGLOO PLUS device offers unique Flash*Freeze technology, allowing the device to enter and exit ultra-low power Flash*Freeze mode. IGLOO PLUS devices do not need additional components to turn off I/Os or clocks while retaining the design information, SRAM content, registers, and I/O states. Flash*Freeze technology is combined with in-system programmability, which enables users to quickly and easily upgrade and update their designs in the final stages of manufacturing or in the field. The ability of IGLOO PLUS V2 devices to support a wide range of core and I/O voltages (1.2 V to 1.5 V) allows further reduction in power consumption, thus achieving the lowest total system power.

During Flash*Freeze mode, each I/O can be set to the following configurations: hold previous state, tristate, or set as HIGH or LOW.

The availability of low power modes, combined with reprogrammability, a single-chip and single-voltage solution, and availability of small-footprint, high-pin-count packages, make IGLOO PLUS devices the best fit for portable electronics.

Flash Advantages

Low Power

IGLOO PLUS devices exhibit power characteristics similar to those of an ASIC, making them an ideal choice for power-sensitive applications. IGLOO PLUS devices have only a very limited power-on current surge and no high-current transition period, both of which occur on many FPGAs.

IGLOO PLUS devices also have low dynamic power consumption to further maximize power savings; power is even further reduced by the use of a 1.2 V core voltage.

Low dynamic power consumption, combined with low static power consumption and Flash*Freeze technology, gives the IGLOO PLUS device the lowest total system power offered by any FPGA.

Security

Nonvolatile, flash-based IGLOO PLUS devices do not require a boot PROM, so there is no vulnerable external bitstream that can be easily copied. IGLOO PLUS devices incorporate FlashLock, which provides a unique combination of reprogrammability and design security without external overhead, advantages that only an FPGA with nonvolatile flash programming can offer.

IGLOO PLUS devices (except AGLP030) utilize a 128-bit flash-based lock and a separate AES key to provide the highest level of security in the FPGA industry for programmed intellectual property and configuration data. In addition, all FlashROM data in IGLOO PLUS devices can be encrypted prior to loading, using the industry-leading AES-128 (FIPS192) bit block cipher encryption standard. AES was adopted by the National Institute of Standards and Technology (NIST) in 2000 and replaces the 1977 DES standard. IGLOO PLUS devices have a built-in AES decryption engine and a flash-based AES key that make them the most comprehensive programmable logic device security solution available today. IGLOO PLUS devices with AES-based security provide a high level of protection for secure, remote field updates over public networks such as the Internet, and ensure that valuable IP remains out of the hands of system overbuilders, system cloners, and IP thieves.

Security, built into the FPGA fabric, is an inherent component of the IGLOO PLUS family. The flash cells are located beneath seven metal layers, and many device design and layout techniques have been used to make invasive attacks extremely difficult. The IGLOO PLUS family, with FlashLock and AES security, is unique in being highly resistant to both invasive and noninvasive attacks. Your valuable IP is protected with industry-standard security, making remote ISP possible. An IGLOO PLUS device provides the best available security for programmable logic designs.

Single Chip

Flash-based FPGAs store their configuration information in on-chip flash cells. Once programmed, the configuration data is an inherent part of the FPGA structure, and no external configuration data needs to be loaded at system power-up (unlike SRAM-based FPGAs). Therefore, flash-based IGLOO PLUS FPGAs do not require system configuration components such as EEPROMs or microcontrollers to load device configuration data. This reduces bill-of-materials costs and PCB area, and increases security and system reliability.

The IGLOO PLUS devices can be operated with a 1.2 V or 1.5 V single-voltage supply for core and I/Os, eliminating the need for additional supplies while minimizing total power consumption.

Instant On

Flash-based IGLOO PLUS devices support Level 0 of the Instant On classification standard. This feature helps in system component initialization, execution of critical tasks before the processor wakes up, setup and configuration of memory blocks, clock generation, and bus activity management. The Instant On feature of flash-based IGLOO PLUS devices greatly simplifies total system design and reduces total system cost, often eliminating the need for CPLDs and clock generation PLLs. In addition, glitches and brownouts in system power will not corrupt the IGLOO PLUS device's flash configuration, and unlike SRAM-based FPGAs, the device will not have to be reloaded when system power is restored. This enables the reduction or complete removal of the configuration PROM, expensive voltage monitor, brownout detection, and clock generator devices from the PCB design. Flash-based IGLOO PLUS devices simplify total system design and reduce cost and design risk while increasing system reliability and improving system initialization time.

IGLOO PLUS flash FPGAs allow the user to quickly enter and exit Flash*Freeze mode. This is done almost instantly (within 1 µs), and the device retains configuration and data in registers and RAM. Unlike SRAM-based FPGAs, the device does not need to reload configuration and design state from external memory components; instead, it retains all necessary information to resume operation immediately.

Reduced Cost of Ownership

Advantages to the designer extend beyond low unit cost, performance, and ease of use. Unlike SRAM-based FPGAs, flash-based IGLOO PLUS devices allow all functionality to be Instant On; no external boot PROM is required. On-board security mechanisms prevent access to all the programming information and enable secure remote updates of the FPGA logic. Designers can perform secure remote in-system reprogramming to support future design iterations and field upgrades with confidence that valuable intellectual property cannot be compromised or copied. Secure ISP can be performed using the industry-standard AES algorithm.

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The IGLOO PLUS family device architecture mitigates the need for ASIC migration at higher user volumes. This makes the IGLOO PLUS family a cost-effective ASIC replacement solution, especially for applications in the consumer, networking/communications, computing, and avionics markets.

Firm-Error Immunity

Firm errors occur most commonly when high-energy neutrons, generated in the upper atmosphere, strike a configuration cell of an SRAM FPGA. The energy of the collision can change the state of the configuration cell and thus change the logic, routing, or I/O behavior in an unpredictable way. These errors are impossible to prevent in SRAM FPGAs. The consequence of this type of error can be a complete system failure. Firm errors do not exist in the configuration memory of IGLOO PLUS flash-based FPGAs. Once it is programmed, the flash cell configuration element of IGLOO PLUS FPGAs cannot be altered by high-energy neutrons and is therefore immune to them. Recoverable (or soft) errors occur in the user data SRAM of all FPGA devices. These can easily be mitigated by using error detection and correction (EDAC) circuitry built into the FPGA fabric.

Advanced Flash Technology

The IGLOO PLUS family offers many benefits, including nonvolatility and reprogrammability, through an advanced flash-based, 130 nm LVCMOS process with seven layers of metal. Standard CMOS design techniques are used to implement logic and control functions. The combination of fine granularity, enhanced flexible routing resources, and abundant flash switches allows for very high logic utilization without compromising device routability or performance. Logic functions within the device are interconnected through a four-level routing hierarchy.

IGLOO PLUS family FPGAs utilize design and process techniques to minimize power consumption in all modes of operation.

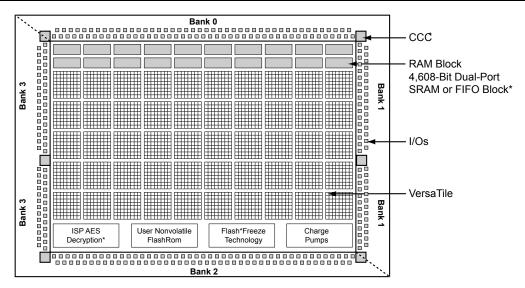
Advanced Architecture

The proprietary IGLOO PLUS architecture provides granularity comparable to standard-cell ASICs. The IGLOO PLUS device consists of five distinct and programmable architectural features (Figure 1-1 on page 1-4):

- Flash*Freeze technology
- FPGA VersaTiles
- Dedicated FlashROM
- Dedicated SRAM/FIFO memory[†]
- Extensive CCCs and PLLs[†]
- · Advanced I/O structure

The FPGA core consists of a sea of VersaTiles. Each VersaTile can be configured as a three-input logic function, a D-flip-flop (with or without enable), or a latch by programming the appropriate flash switch interconnections. The versatility of the IGLOO PLUS core tile as either a three-input lookup table (LUT) equivalent or a D-flip-flop/latch with enable allows for efficient use of the FPGA fabric. The VersaTile capability is unique to the ProASIC® family of third-generation-architecture flash FPGAs. VersaTiles are connected with any of the four levels of routing hierarchy. Flash switches are distributed throughout the device to provide nonvolatile, reconfigurable interconnect programming. Maximum core utilization is possible for virtually any design.

[†] The AGLP030 device does not support PLL or SRAM.



Note: *Not supported by AGLP030 devices

Figure 1-1 • IGLOO PLUS Device Architecture Overview with Four I/O Banks (AGLP030, AGLP060, and **AGLP125)**

Flash*Freeze Technology

The IGLOO PLUS device has an ultra-low power static mode, called Flash*Freeze mode, which retains all SRAM and register information and can still quickly return to normal operation. Flash*Freeze technology enables the user to quickly (within 1 µs) enter and exit Flash*Freeze mode by activating the Flash*Freeze pin while all power supplies are kept at their original values. In addition, I/Os and global I/Os can still be driven and can be toggling without impact on power consumption, clocks can still be driven or can be toggling without impact on power consumption, and the device retains all core registers, SRAM information, and I/O states. I/Os can be individually configured to either hold their previous state or be tristated during Flash*Freeze mode. Alternatively, they can be set to a certain state using weak pullup or pull-down I/O attribute configuration. No power is consumed by the I/O banks, clocks, JTAG pins, or PLL, and the device consumes as little as 5 µW in this mode.

Flash*Freeze technology allows the user to switch to Active mode on demand, thus simplifying the power management of the device.

The Flash*Freeze pin (active low) can be routed internally to the core to allow the user's logic to decide when it is safe to transition to this mode. Refer to Figure 1-2 for an illustration of entering/exiting Flash*Freeze mode. It is also possible to use the Flash*Freeze pin as a regular I/O if Flash*Freeze mode usage is not planned.

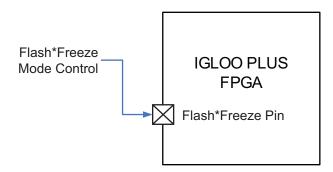


Figure 1-2 • IGLOO PLUS Flash*Freeze Mode

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VersaTiles

The IGLOO PLUS core consists of VersaTiles, which have been enhanced beyond the ProASIC PLUS® core tiles. The IGLOO PLUS VersaTile supports the following:

- · All 3-input logic functions—LUT-3 equivalent
- · Latch with clear or set
- · D-flip-flop with clear or set
- · Enable D-flip-flop with clear or set

Refer to Figure 1-3 for VersaTile configurations.

LUT-3 Equivalent D-Flip-Flop with Clear or Set Data CLK CLR D-FF CLR CLR CLR CLR CLR CLR CLR

Figure 1-3 • VersaTile Configurations

User Nonvolatile FlashROM

IGLOO PLUS devices have 1 kbit of on-chip, user-accessible, nonvolatile FlashROM. The FlashROM can be used in diverse system applications:

- · Internet protocol addressing (wireless or fixed)
- · System calibration settings
- Device serialization and/or inventory control
- Subscription-based business models (for example, set-top boxes)
- Secure key storage for secure communications algorithms
- Asset management/tracking
- · Date stamping
- · Version management

The FlashROM is written using the standard IGLOO PLUS IEEE 1532 JTAG programming interface. The core can be individually programmed (erased and written), and on-chip AES decryption can be used selectively to securely load data over public networks (except in AGLP030 devices), as in security keys stored in the FlashROM for a user design.

The FlashROM can be programmed via the JTAG programming interface, and its contents can be read back either through the JTAG programming interface or via direct FPGA core addressing. Note that the FlashROM can only be programmed from the JTAG interface and cannot be programmed from the internal logic array.

The FlashROM is programmed as 8 banks of 128 bits; however, reading is performed on a byte-by-byte basis using a synchronous interface. A 7-bit address from the FPGA core defines which of the 8 banks and which of the 16 bytes within that bank are being read. The three most significant bits (MSBs) of the FlashROM address determine the bank, and the four least significant bits (LSBs) of the FlashROM address define the byte.

The IGLOO PLUS development software solutions, Libero[®] System-on-Chip (SoC) and Designer, have extensive support for the FlashROM. One such feature is auto-generation of sequential programming files for applications requiring a unique serial number in each part. Another feature allows the inclusion of static data for system version control. Data for the FlashROM can be generated quickly and easily using Libero SoC and Designer software tools. Comprehensive programming file support is also included to allow for easy programming of large numbers of parts with differing FlashROM contents.

SRAM and FIFO

IGLOO PLUS devices (except AGLP030 devices) have embedded SRAM blocks along their north side. Each variable-aspect-ratio SRAM block is 4,608 bits in size. Available memory configurations are 256×18, 512×9, 1k×4, 2k×2, and 4k×1 bits. The individual blocks have independent read and write ports that can be configured with different bit widths on each port. For example, data can be sent through a 4-bit port and read as a single bitstream. The embedded SRAM blocks can be initialized via the device JTAG port (ROM emulation mode) using the UJTAG macro (except in AGLP030 devices).

In addition, every SRAM block has an embedded FIFO control unit. The control unit allows the SRAM block to be configured as a synchronous FIFO without using additional core VersaTiles. The FIFO width and depth are programmable. The FIFO also features programmable Almost Empty (AEMPTY) and Almost Full (AFULL) flags in addition to the normal Empty and Full flags. The embedded FIFO control unit contains the counters necessary for generation of the read and write address pointers. The embedded SRAM/FIFO blocks can be cascaded to create larger configurations.

PLL and CCC

IGLOO PLUS devices provide designers with very flexible clock conditioning circuit (CCC) capabilities. Each member of the IGLOO PLUS family contains six CCCs. One CCC (center west side) has a PLL. The AGLP030 device does not have a PLL or CCCs; it contains only inputs to six globals.

The six CCC blocks are located at the four corners and the centers of the east and west sides. One CCC (center west side) has a PLL.

The four corner CCCs and the east CCC allow simple clock delay operations as well as clock spine access.

The inputs of the six CCC blocks are accessible from the FPGA core or from one of several inputs located near the CCC that have dedicated connections to the CCC block.

The CCC block has these key features:

- Wide input frequency range (f_{IN CCC}) = 1.5 MHz up to 250 MHz
- Output frequency range (f_{OUT CCC}) = 0.75 MHz up to 250 MHz
- · 2 programmable delay types for clock skew minimization
- Clock frequency synthesis (for PLL only)

Additional CCC specifications:

- Internal phase shift = 0°, 90°, 180°, and 270°. Output phase shift depends on the output divider configuration (for PLL only).
- Output duty cycle = 50% ± 1.5% or better (for PLL only)
- Low output jitter: worst case < 2.5% × clock period peak-to-peak period jitter when single global network used (for PLL only)
- Maximum acquisition time is 300 µs (for PLL only)
- Exceptional tolerance to input period jitter—allowable input jitter is up to 1.5 ns (for PLL only)
- Four precise phases; maximum misalignment between adjacent phases (for PLL only) is 40 ps \times 250 MHz / $f_{OUT\ CCC}$

Global Clocking

IGLOO PLUS devices have extensive support for multiple clocking domains. In addition to the CCC and PLL support described above, there is a comprehensive global clock distribution network.

Each VersaTile input and output port has access to nine VersaNets: six chip (main) and three quadrant global networks. The VersaNets can be driven by the CCC or directly accessed from the core via multiplexers (MUXes). The VersaNets can be used to distribute low-skew clock signals or for rapid distribution of high-fanout nets.

I/Os with Advanced I/O Standards

The IGLOO PLUS family of FPGAs features a flexible I/O structure, supporting a range of voltages (1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.0 V wide range, and 3.3 V). IGLOO PLUS FPGAs support many different I/O standards.

The I/Os are organized into four banks. All devices in IGLOO PLUS have four banks. The configuration of these banks determines the I/O standards supported.

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Each I/O module contains several input, output, and output enable registers.

Hot-swap (also called hot-plug, or hot-insertion) is the operation of hot-insertion or hot-removal of a card in a powered-up system.

Cold-sparing (also called cold-swap) refers to the ability of a device to leave system data undisturbed when the system is powered up, while the component itself is powered down, or when power supplies are floating.

Wide Range I/O Support

IGLOO PLUS devices support JEDEC-defined wide range I/O operation. IGLOO PLUS devices support both the JESD8-B specification, covering 3 V and 3.3 V supplies, for an effective operating range of 2.7 V to 3.6 V, and JESD8-12 with its 1.2 V nominal, supporting an effective operating range of 1.14 V to 1.575 V.

Wider I/O range means designers can eliminate power supplies or power conditioning components from the board or move to less costly components with greater tolerances. Wide range eases I/O bank management and provides enhanced protection from system voltage spikes, while providing the flexibility to easily run custom voltage applications.

Specifying I/O States During Programming

You can modify the I/O states during programming in FlashPro. In FlashPro, this feature is supported for PDB files generated from Designer v8.5 or greater. See the *FlashPro User's Guide* for more information.

Note: PDB files generated from Designer v8.1 to Designer v8.4 (including all service packs) have limited display of Pin Numbers only.

- 1. Load a PDB from the FlashPro GUI. You must have a PDB loaded to modify the I/O states during programming.
- 2. From the FlashPro GUI, click PDB Configuration. A FlashPoint Programming File Generator window appears.
- 3. Click the Specify I/O States During Programming button to display the Specify I/O States During Programming dialog box.
- 4. Sort the pins as desired by clicking any of the column headers to sort the entries by that header. Select the I/Os you wish to modify (Figure 1-4 on page 1-8).
- Set the I/O Output State. You can set Basic I/O settings if you want to use the default I/O settings for your pins, or use Custom I/O settings to customize the settings for each pin. Basic I/O state settings:
 - 1 I/O is set to drive out logic High
 - 0 I/O is set to drive out logic Low

Last Known State - I/O is set to the last value that was driven out prior to entering the programming mode, and then held at that value during programming Z -Tri-State: I/O is tristated

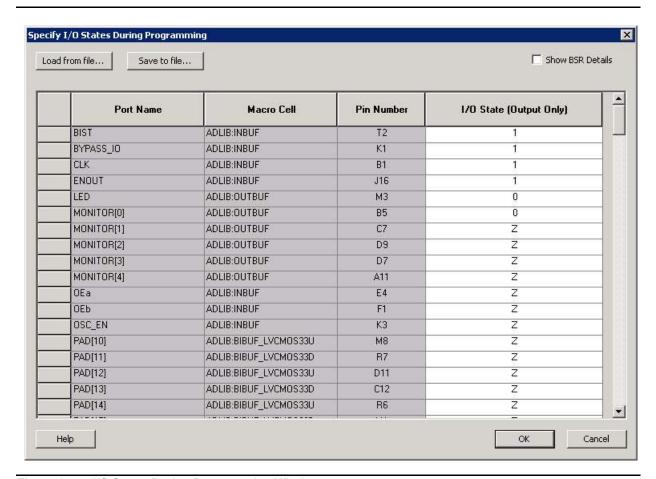


Figure 1-4 • I/O States During Programming Window

6. Click OK to return to the FlashPoint – Programming File Generator window.

Note: I/O States During programming are saved to the ADB and resulting programming files after completing programming file generation.

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2 – IGLOO PLUS DC and Switching Characteristics

General Specifications

Operating Conditions

Stresses beyond those listed in Table 2-1 may cause permanent damage to the device.

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Absolute Maximum Ratings are stress ratings only; functional operation of the device at these or any other conditions beyond those listed under the Recommended Operating Conditions specified in Table 2-2 on page 2-2 is not implied.

Table 2-1 • Absolute Maximum Ratings

Symbol	Parameter	Limits	Units
VCC	DC core supply voltage	-0.3 to 1.65	V
VJTAG	JTAG DC voltage	-0.3 to 3.75	V
VPUMP	Programming voltage	-0.3 to 3.75	V
VCCPLL	Analog power supply (PLL)	-0.3 to 1.65	V
VCCI	DC I/O buffer supply voltage	-0.3 to 3.75	V
VI ¹	I/O input voltage	–0.3 V to 3.6 V	V
T _{STG} ²	Storage temperature	-65 to +150	°C
T_J^2	Junction temperature	+125	°C

Notes:

^{1.} The device should be operated within the limits specified by the datasheet. During transitions, the input signal may undershoot or overshoot according to the limits shown in Table 2-4 on page 2-3.

^{2.} For flash programming and retention maximum limits, refer to Table 2-3 on page 2-3, and for recommended operating limits, refer to Table 2-2 on page 2-2.



IGLOO PLUS DC and Switching Characteristics

Table 2-2 • Recommended Operating Conditions 1,2

Symbol	Pa	rameter	Commercial	Industrial	Units
TJ	Junction temperature ²		0 to + 85	-40 to +100	°C
VCC ³	1.5 V DC core supply voltage ⁴		1.425 to 1.575	1.425 to 1.575	V
	1.2 V-1.5 V wide range core	voltage ^{5,6}	1.14 to 1.575	1.14 to 1.575	V
VJTAG	JTAG DC voltage	1.4 to 3.6	1.4 to 3.6	V	
VPUMP ⁷	Programming voltage	Programming mode	3.15 to 3.45	V	
		Operation	0 to 3.6	0 to 3.6	V
VCCPLL ⁸	Analog power supply (PLL)	1.5 V DC core supply voltage ⁴	1.425 to 1.575	1.425 to 1.575	V
		1.14 to 1.575	1.14 to 1.575	V	
VCCI	1.2 V DC supply voltage ⁵		1.14 to 1.26	1.14 to 1.26	V
	1.2 V DC wide range supply	voltage ⁵	1.14 to 1.575	1.14 to 1.575	V
	1.5 V DC supply voltage		1.425 to 1.575	1.425 to 1.575	V
	1.8 V DC supply voltage		1.7 to 1.9	1.7 to 1.9	V
	2.5 V DC supply voltage		2.3 to 2.7	2.3 to 2.7	V
	3.3 V wide range DC supply	voltage ⁹	2.7 to 3.6	2.7 to 3.6	V
	3.3 V DC supply voltage		3.0 to 3.6	3.0 to 3.6	V

Notes:

- 1. All parameters representing voltages are measured with respect to GND unless otherwise specified.
- 2. To ensure targeted reliability standards are met across ambient and junction operating temperatures, Microsemi recommends that the user follow best design practices using Microsemi's timing and power simulation tools.
- 3. The ranges given here are for power supplies only. The recommended input voltage ranges specific to each I/O standard are given in Table 2-21 on page 2-19. VCCI should be at the same voltage within a given I/O bank.
- 4. For IGLOO® PLUS V5 devices
- 5. For IGLOO PLUS V2 devices only, operating at VCCI ≥ VCC.
- 6. All IGLOO PLUS devices (V5 and V2) must be programmed with the VCC core voltage at 1.5 V. Applications using V2 devices powered by a 1.2 V supply must switch the core supply to 1.5 V for in-system programming.
- 7. VPUMP can be left floating during operation (not programming mode).
- 8. VCCPLL pins should be tied to VCC pins. See the Pin Descriptions chapter of the IGLOO PLUS FPGA Fabric User's Guide for further information.
- 9. 3.3 V wide range is compliant to the JDEC8b specification and supports 3.0 V VCCI operation.
- 10. VMV pins must be connected to the corresponding VCCI pins. See the "Pin Descriptions" chapter of the IGLOO FPGA Fabric User's Guide for further information.
- 11. Software Default Junction Temperature Range in the Libero SoC software is set to 0°C to +70°C for commercial, and -40°C to +85°C for industrial. To ensure targeted reliability standards are met across the full range of junction temperatures, Microsemi recommends using custom settings for temperature range before running timing and power analysis tools. For more information regarding custom settings, refer to the New Project Dialog Box in the Libero SoC Online Help.

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Table 2-3 • Flash Programming Limits - Retention, Storage, and Operating Temperature 1

Product Grade	Programming Cycles	Program Retention (biased/unbiased)	Maximum Storage Temperature T _{STG} (°C) ²	Maximum Operating Junction Temperature T _J (°C) ²
Commercial	500	20 years	110	100
Industrial	500	20 years	110	100

Notes:

- 1. This is a stress rating only; functional operation at any condition other than those indicated is not implied.
- 2. These limits apply for program/data retention only. Refer to Table 2-1 on page 2-1 and Table 2-2 for device operating conditions and absolute limits.

Table 2-4 • Overshoot and Undershoot Limits 1

vccı	Average VCCI–GND Overshoot or Undershoot Duration as a Percentage of Clock Cycle ²	Maximum Overshoot/ Undershoot ²
2.7 V or less	10%	1.4 V
	5%	1.49 V
3 V	10%	1.1 V
	5%	1.19 V
3.3 V	10%	0.79 V
	5%	0.88 V
3.6 V	10%	0.45 V
	5%	0.54 V

Notes:

- 1. Based on reliability requirements at 85°C.
- 2. The duration is allowed at one out of six clock cycles. If the overshoot/undershoot occurs at one out of two cycles, the maximum overshoot/undershoot has to be reduced by 0.15 V.

I/O Power-Up and Supply Voltage Thresholds for Power-On Reset (Commercial and Industrial)

Sophisticated power-up management circuitry is designed into every IGLOO PLUS device. These circuits ensure easy transition from the powered-off state to the powered-up state of the device. The many different supplies can power up in any sequence with minimized current spikes or surges. In addition, the I/O will be in a known state through the power-up sequence. The basic principle is shown in Figure 2-1 on page 2-4.

There are five regions to consider during power-up.

IGLOO PLUS I/Os are activated only if ALL of the following three conditions are met:

- 1. VCC and VCCI are above the minimum specified trip points (Figure 2-1 and Figure 2-2 on page 2-5).
- 2. VCCI > VCC 0.75 V (typical)
- 3. Chip is in the operating mode.

VCCI Trip Point:

Ramping up (V5 devices): 0.6 V < trip_point_up < 1.2 V Ramping down (V5 devices): 0.5 V < trip_point_down < 1.1 V Ramping up (V2 devices): 0.75 V < trip_point_up < 1.05 V Ramping down (V2 devices): 0.65 V < trip_point_down < 0.95 V

VCC Trip Point:

Ramping up (V5 devices): 0.6 V < trip_point_up < 1.1 V Ramping down (V5 devices): 0.5 V < trip_point_down < 1.0 V

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Ramping up (V2 devices): $0.65 \text{ V} < \text{trip_point_up} < 1.05 \text{ V}$ Ramping down (V2 devices): $0.55 \text{ V} < \text{trip_point_down} < 0.95 \text{ V}$

VCC and VCCI ramp-up trip points are about 100 mV higher than ramp-down trip points. This specifically built-in hysteresis prevents undesirable power-up oscillations and current surges. Note the following:

- During programming, I/Os become tristated and weakly pulled up to VCCI.
- JTAG supply, PLL power supplies, and charge pump VPUMP supply have no influence on I/O behavior.

PLL Behavior at Brownout Condition

Microsemi recommends using monotonic power supplies or voltage regulators to ensure proper powerup behavior. Power ramp-up should be monotonic at least until VCC and VCCPLX exceed brownout activation levels (see Figure 2-1 and Figure 2-2 on page 2-5 for more details).

When PLL power supply voltage and/or VCC levels drop below the VCC brownout levels (0.75 V \pm 0.25 V for V5 devices, and 0.75 V \pm 0.2 V for V2 devices), the PLL output lock signal goes Low and/or the output clock is lost. Refer to the "Brownout Voltage" section in the "Power-Up/-Down Behavior of Low Power Flash Devices" chapter of the *IGLOO PLUS Device Family User's Guide* for information on clock and lock recovery.

Internal Power-Up Activation Sequence

- 1. Core
- 2. Input buffers
- 3. Output buffers, after 200 ns delay from input buffer activation

To make sure the transition from input buffers to output buffers is clean, ensure that there is no path longer than 100 ns from input buffer to output buffer in your design.

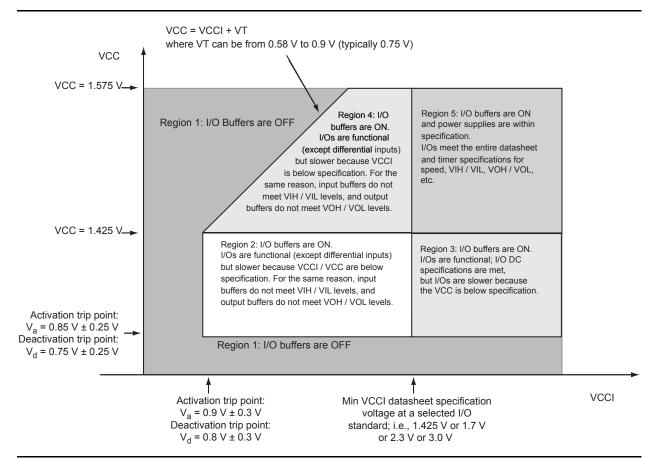


Figure 2-1 • V5 Devices - I/O State as a Function of VCCI and VCC Voltage Levels

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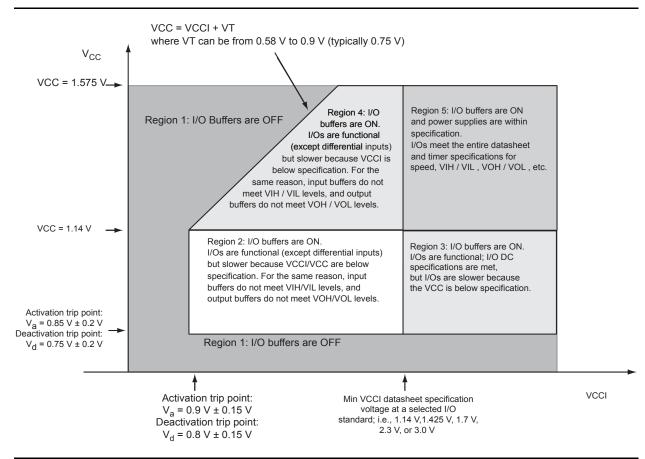


Figure 2-2 • V2 Devices - I/O State as a Function of VCCI and VCC Voltage Levels

Thermal Characteristics

Introduction

The temperature variable in the Microsemi Designer software refers to the junction temperature, not the ambient temperature. This is an important distinction because dynamic and static power consumption cause the chip junction temperature to be higher than the ambient temperature.

EQ 1 can be used to calculate junction temperature.

 T_J = Junction Temperature = $\Delta T + T_A$

EQ 1

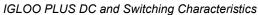
where:

T_A = Ambient temperature

 ΔT = Temperature gradient between junction (silicon) and ambient ΔT = θ_{ia} * P

 θ_{ia} = Junction-to-ambient of the package. θ_{ia} numbers are located in Figure 2-5.

P = Power dissipation



Package Thermal Characteristics

The device junction-to-case thermal resistivity is θ_{jc} and the junction-to-ambient air thermal resistivity is θ_{ja} . The thermal characteristics for θ_{ja} are shown for two air flow rates. The maximum operating junction temperature is 100°C. EQ 2 shows a sample calculation of the maximum operating power dissipation allowed for a 484-pin FBGA package at commercial temperature and in still air.

$$\text{Maximum Power Allowed } = \frac{\text{Max. junction temp. (°C)} - \text{Max. ambient temp. (°C)}}{\theta_{ja}(°\text{C/W})} = \frac{100°\text{C} - 70°\text{C}}{20.5°\text{C/W}} = 1.46~\text{W}$$

EQ 2

Table 2-5 • Package Thermal Resistivities

		Pin				θ_{ja}		
Package Type	Device	Count	$\theta_{ extsf{jc}}$	θ_{jb}	Still Air	1 m/s	2.5 m/s	Unit
Chip Scale Package (CSP)	AGLP030	CS201	-	-	46.3	-	-	C/W
	AGLP060	CS201	7.1	19.7	40.5	35.1	32.9	C/W
	AGLP060	CS289	13.9	34.1	48.7	43.5	41.9	C/W
	AGLP125	CS289	10.8	27.9	42.2	37.1	35.5	C/W
	AGLP125	CS281	11.3	17.6	-	-	-	C/W
Thin Quad Flat Package (VQ)	AGLP030	VQ128	18.0	50.0	56.0	49.0	47.0	C/W
	AGLP060	VQ176	21.0	55.0	58.0	52.0	50.0	C/W

Temperature and Voltage Derating Factors

Table 2-6 • Temperature and Voltage Derating Factors for Timing Delays (normalized to T_J = 70°C, VCC = 1.425 V)

For IGLOO PLUS V2 or V5 devices, 1.5 V DC Core Supply Voltage

Array Voltage	Junction Temperature (°C)							
ACC (A)	-40°C	0°C	25°C	70°C	85°C	100°C		
1.425	0.934	0.953	0.971	1.000	1.007	1.013		
1.5	0.855	0.874	0.891	0.917	0.924	0.929		
1.575	0.799	0.816	0.832	0.857	0.864	0.868		

Table 2-7 • Temperature and Voltage Derating Factors for Timing Delays (normalized to $T_J = 70^{\circ}\text{C}$, VCC = 1.14 V)
For IGLOO PLUS V2, 1.2 V DC Core Supply Voltage

Array Voltage VCC (V)	Junction Temperature (°C)							
	-40°C	0°C	25°C	70°C	85°C	100°C		
1.14	0.963	0.975	0.989	1.000	1.007	1.011		
1.2	0.853	0.865	.0877	0.893	0.893	0.897		
1.26	0.781	0.792	0.803	0.813	0.819	0.822		

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Calculating Power Dissipation

Quiescent Supply Current

Quiescent supply current (I_{DD}) calculation depends on multiple factors, including operating voltages (VCC, VCCI, and VJTAG), operating temperature, system clock frequency, and power mode usage. Microsemi recommends using the Power Calculator and SmartPower software estimation tools to evaluate the projected static and active power based on the user design, power mode usage, operating voltage, and temperature.

Table 2-8 • Power Supply State per Mode

	Power Supply Configurations					
Modes/Power Supplies	vcc	VCCPLL	VCCI	VJTAG	VPUMP	
Flash*Freeze	On	On	On	On	On/off/floating	
Sleep	Off	Off	On	Off	Off	
Shutdown	Off	Off	Off	Off	Off	
No Flash*Freeze	On	On	On	On	On/off/floating	

Note: Off: Power Supply level = 0 V

Table 2-9 • Quiescent Supply Current (IDD) Characteristics, IGLOO PLUS Flash*Freeze Mode*

	Core Voltage	AGLP030	AGLP060	AGLP125	Units
Typical (25°C)	1.2 V	4	8	13	μΑ
	1.5 V	6	10	18	μΑ

Note: *IDD includes VCC, VPUMP, VCCI, VJTAG, and VCCPLL currents.

Table 2-10 • Quiescent Supply Current (IDD) Characteristics, IGLOO PLUS Sleep Mode*

ICCI Current	Core Voltage	AGLP030	AGLP060	AGLP125	Units
VCCI = 1.2 V (per bank) Typical (25°C)	1.2 V	1.7	1.7	1.7	μA
VCCI = 1.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.8	1.8	1.8	μΑ
VCCI = 1.8 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.9	1.9	1.9	μΑ
VCCI = 2.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.2	2.2	2.2	μA
VCCI = 3.3 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.5	2.5	2.5	μΑ

Note: *IDD = N_{BANKS} * ICCI

Table 2-11 • Quiescent Supply Current (IDD) Characteristics, IGLOO PLUS Shutdown Mode

	Core Voltage	AGLP030	AGLP060	AGLP125	Units
Typical (25°C)	1.2 V / 1.5 V	0	0	0	μΑ



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Table 2-12 • Quiescent Supply Current (IDD), No IGLOO PLUS Flash*Freeze Mode ¹

·	Core Voltage	AGLP030	AGLP060	AGLP125	Units
ICCA Current ²	1	1			
Typical (25°C)	1.2 V	6	10	13	μA
	1.5 V	16	20	28	μA
ICCI or IJTAG Current	•	•	•	•	
VCCI / VJTAG = 1.2 V (per bank) Typical (25°C)	1.2 V	1.7	1.7	1.7	μΑ
VCCI / VJTAG = 1.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.8	1.8	1.8	μA
VCCI / VJTAG = 1.8 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.9	1.9	1.9	μΑ
VCCI / VJTAG = 2.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.2	2.2	2.2	μA
VCCI / VJTAG = 3.3 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.5	2.5	2.5	μΑ

Notes:

- IDD = N_{BANKS} * ICCI + ICCA. JTAG counts as one bank when powered.
 Includes VCC, VCCPLL, and VPUMP currents.

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Power per I/O Pin

Table 2-13 • Summary of I/O Input Buffer Power (per pin) - Default I/O Software Settings

	VCCI (V)	Dynamic Power PAC9 (μW/MHz) ¹
Single-Ended		-
3.3 V LVTTL / 3.3 V LVCMOS	3.3	16.26
3.3 V LVTTL / 3.3 V LVCMOS – Schmitt Trigger	3.3	18.95
3.3 V LVCMOS Wide Range ²	3.3	16.26
3.3 V LVCMOS Wide Range ² – Schmitt Trigger	3.3	18.95
2.5 V LVCMOS	2.5	4.59
2.5 V LVCMOS – Schmitt Trigger	2.5	6.01
1.8 V LVCMOS	1.8	1.61
1.8 V LVCMOS – Schmitt Trigger	1.8	1.70
1.5 V LVCMOS (JESD8-11)	1.5	0.96
1.5 V LVCMOS (JESD8-11) – Schmitt Trigger	1.5	0.90
1.2 V LVCMOS ³	1.2	0.55
1.2 V LVCMOS ³ – Schmitt Trigger	1.2	0.47
1.2 V LVCMOS Wide Range ³	1.2	0.55
1.2 V LVCMOS Wide Range ³ – Schmitt Trigger	1.2	0.47

Notes:

- 1. PAC9 is the total dynamic power measured on VCCI.
- 2. All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range as specified in the JESD-8B specification.
- 3. Applicable for IGLOO PLUS V2 devices only, operating at VCCI ≥ VCC.

Table 2-14 • Summary of I/O Output Buffer Power (per pin) - Default I/O Software Settings¹

	C _{LOAD} (pF)	VCCI (V)	Dynamic Power PAC10 (μW/MHz) ²
Single-Ended			
3.3 V LVTTL / 3.3 V LVCMOS	5	3.3	127.11
3.3 V LVCMOS Wide Range ³	5	3.3	127.11
2.5 V LVCMOS	5	2.5	70.71
1.8 V LVCMOS	5	1.8	35.57
1.5 V LVCMOS (JESD8-11)	5	1.5	24.30
1.2 V LVCMOS ⁴	5	1.2	15.22
1.2 V LVCMOS Wide Range ⁴	5	1.2	15.22

Notes:

- 1. Dynamic power consumption is given for standard load and software default drive strength and output slew.
- 2. PAC10 is the total dynamic power measured on VCCI.
- 3. All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range as specified in the JESD-8B specification.
- 4. Applicable for IGLOO PLUS V2 devices only, operating at VCCI ≥ VCC.



Power Consumption of Various Internal Resources

Table 2-15 • Different Components Contributing to Dynamic Power Consumption in IGLOO PLUS Devices For IGLOO PLUS V2 or V5 Devices, 1.5 V Core Supply Voltage

		Device Specific Dynamic Power (µW/MHz)			
Parameter	Definition	AGLP125	AGLP060	AGLP030	
PAC1	Clock contribution of a Global Rib	4.489	2.696	0.000 ¹	
PAC2	Clock contribution of a Global Spine	1.991	1.962	3.499	
PAC3	Clock contribution of a VersaTile row	1.510	1.523	1.537	
PAC4	Clock contribution of a VersaTile used as a sequential module	0.153	0.151	0.151	
PAC5	First contribution of a VersaTile used as a sequential module	0.029	0.029	0.029	
PAC6	Second contribution of a VersaTile used as a sequential module	0.323	0.323	0.323	
PAC7	Contribution of a VersaTile used as a combinatorial module	0.280	0.300	0.278	
PAC8	Average contribution of a routing net	1.097	1.081	1.130	
PAC9	Contribution of an I/O input pin (standard-dependent)	See Ta	ble 2-13 on	page 2-9.	
PAC10	Contribution of an I/O output pin (standard-dependent)	See Ta	See Table 2-14 on page 2-9.		
PAC11	Average contribution of a RAM block during a read operation	25.00			
PAC12	Average contribution of a RAM block during a write operation	30.00			
PAC13	Dynamic contribution for PLL		2.70		

Note: 1. There is no Center Global Rib present in AGLP030, and thus it starts directly at the spine resulting in $0\mu W/MHz$.

Table 2-16 • Different Components Contributing to the Static Power Consumption in IGLOO PLUS Devices For IGLOO PLUS V2 or V5 Devices, 1.5 V Core Supply Voltage

		Device-Specific Static Power (mW)				
Parameter	Definition	AGLP125	AGLP060	AGLP030		
PDC1	Array static power in Active mode	See Ta	See Table 2-12 on page 2-8			
PDC2	Array static power in Static (Idle) mode	See Ta	See Table 2-11 on page 2-7			
PDC3	Array static power in Flash*Freeze mode	See Ta	See Table 2-9 on page 2-7			
PDC4	Static PLL contribution		1.84 ¹			
PDC5	Bank quiescent power (VCCI-dependent)	See Ta	See Table 2-12 on page 2-8			

Notes:

- 1. This is the minimum contribution of the PLL when operating at lowest frequency.
- 2. For a different output load, drive strength, or slew rate, Microsemi recommends using the Microsemi power spreadsheet calculator or the SmartPower tool in Libero SoC software.

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Table 2-17 • Different Components Contributing to Dynamic Power Consumption in IGLOO PLUS Devices For IGLOO PLUS V2 Devices, 1.2 V Core Supply Voltage

		Device-Sp	Device-Specific Dynamic Power (μW/MHz)			
Parameter	Definition	AGLP125	AGLP060	AGLP030		
PAC1	Clock contribution of a Global Rib	2.874	1.727	0.000 ¹		
PAC2	Clock contribution of a Global Spine	1.264	1.244	2.241		
PAC3	Clock contribution of a VersaTile row	0.963	0.975	0.981		
PAC4	Clock contribution of a VersaTile used as a sequential module	0.098	0.096	0.096		
PAC5	First contribution of a VersaTile used as a sequential module	0.018	0.018	0.018		
PAC6	Second contribution of a VersaTile used as a sequential module	0.203	0.203	0.203		
PAC7	Contribution of a VersaTile used as a combinatorial module	0.160	0.170	0.158		
PAC8	Average contribution of a routing net	0.679	0.686	0.748		
PAC9	Contribution of an I/O input pin (standard-dependent)	See Tab	le 2-13 on p	age 2-9		
PAC10	Contribution of an I/O output pin (standard-dependent)	See Tab	See Table 2-14 on page 2-9			
PAC11	Average contribution of a RAM block during a read operation		25.00			
PAC12	Average contribution of a RAM block during a write operation		30.00			
PAC13	Dynamic contribution for PLL		2.10			

Note: 1. There is no Center Global Rib present in AGLP030, and thus it starts directly at the spine resulting in $0\mu W/MHz$.

Table 2-18 • Different Components Contributing to the Static Power Consumption in IGLOO PLUS Devices For IGLOO PLUS V2 Devices, 1.2 V Core Supply Voltage

		Device-S	Device-Specific Static Power (mW)								
Parameter	Definition	AGLP125	AGLP060	AGLP030							
PDC1	Array static power in Active mode	See 7	See Table 2-12 on page 2-8								
PDC2	Array static power in Static (Idle) mode	See ⁻	See Table 2-11 on page 2-7								
PDC3	Array static power in Flash*Freeze mode	See	See Table 2-9 on page 2-7								
PDC4	Static PLL contribution		0.90 ¹								
PDC5	Bank quiescent power (VCCI-dependent)	See	Table 2-12 on pa	ge 2-8							

Notes:

- 1. This is the minimum contribution of the PLL when operating at lowest frequency.
- 2. For a different output load, drive strength, or slew rate, Microsemi recommends using the Microsemi power spreadsheet calculator or the SmartPower tool in Libero SoC software.



Power Calculation Methodology

This section describes a simplified method to estimate power consumption of an application. For more accurate and detailed power estimations, use the SmartPower tool in Libero SoC software.

The power calculation methodology described below uses the following variables:

- · The number of PLLs as well as the number and the frequency of each output clock generated
- · The number of combinatorial and sequential cells used in the design
- · The internal clock frequencies
- · The number and the standard of I/O pins used in the design
- · The number of RAM blocks used in the design
- Toggle rates of I/O pins as well as VersaTiles—guidelines are provided in Table 2-19 on page 2-14.
- Enable rates of output buffers—guidelines are provided for typical applications in Table 2-20 on page 2-14.
- Read rate and write rate to the memory—guidelines are provided for typical applications in Table 2-20 on page 2-14. The calculation should be repeated for each clock domain defined in the design.

Methodology

Total Power Consumption—P_{TOTAL}

 $P_{TOTAL} = P_{STAT} + P_{DYN}$

P_{STAT} is the total static power consumption.

P_{DYN} is the total dynamic power consumption.

Total Static Power Consumption—PSTAT

P_{STAT} = (PDC1 or PDC2 or PDC3) + N_{BANKS} * PDC5

N_{BANKS} is the number of I/O banks powered in the design.

Total Dynamic Power Consumption—PDYN

PDYN = PCLOCK + PS-CELL + PC-CELL + PNET + PINPUTS + POUTPUTS + PMEMORY + PPLL

Global Clock Contribution—P_{CLOCK}

```
P<sub>CLOCK</sub> = (PAC1 + N<sub>SPINE</sub>*PAC2 + N<sub>ROW</sub>*PAC3 + N<sub>S-CELL</sub>* PAC4) * F<sub>CLK</sub>
```

N_{SPINE} is the number of global spines used in the user design—guidelines are provided in the "Spine Architecture" section of the Global Resources chapter in the *IGLOO PLUS FPGA Fabric User's Guide*.

N_{ROW} is the number of VersaTile rows used in the design—guidelines are provided in the "Spine Architecture" section of the Global Resources chapter in the *IGLOO PLUS FPGA Fabric User's Guide*.

F_{CLK} is the global clock signal frequency.

N_{S-CFLL} is the number of VersaTiles used as sequential modules in the design.

PAC1, PAC2, PAC3, and PAC4 are device-dependent.

Sequential Cells Contribution—P_{S-CELL}

```
P_{S-CELL} = N_{S-CELL} * (PAC5 + \alpha_1 / 2 * PAC6) * F_{CLK}
```

 N_{S-CELL} is the number of VersaTiles used as sequential modules in the design. When a multi-tile sequential cell is used, it should be accounted for as 1.

 α_1 is the toggle rate of VersaTile outputs—guidelines are provided in Table 2-19 on page 2-14.

F_{CLK} is the global clock signal frequency.

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Combinatorial Cells Contribution—P_{C-CELL}

 $P_{C-CELL} = N_{C-CELL} * \alpha_1 / 2 * PAC7 * F_{CLK}$

N_{C-CFLL} is the number of VersaTiles used as combinatorial modules in the design.

 α_1 is the toggle rate of VersaTile outputs—guidelines are provided in Table 2-19 on page 2-14.

F_{CLK} is the global clock signal frequency.

Routing Net Contribution—P_{NET}

 $P_{NET} = (N_{S-CELL} + N_{C-CELL}) * \alpha_1 / 2 * PAC8 * F_{CLK}$

N_{S-CELL} is the number of VersaTiles used as sequential modules in the design.

N_{C-CELL} is the number of VersaTiles used as combinatorial modules in the design.

 α_1 is the toggle rate of VersaTile outputs—guidelines are provided in Table 2-19 on page 2-14.

F_{CLK} is the global clock signal frequency.

I/O Input Buffer Contribution—PINPUTS

 $P_{INPUTS} = N_{INPUTS} * \alpha_2 / 2 * P_{AC9} * F_{CLK}$

N_{INPLITS} is the number of I/O input buffers used in the design.

 α_2 is the I/O buffer toggle rate—guidelines are provided in Table 2-19 on page 2-14.

F_{CLK} is the global clock signal frequency.

I/O Output Buffer Contribution—POUTPUTS

 $P_{OUTPUTS} = N_{OUTPUTS} * \alpha_2 / 2 * \beta_1 * PAC10 * F_{CLK}$

 $N_{\mbox{OUTPUTS}}$ is the number of I/O output buffers used in the design.

 α_2 is the I/O buffer toggle rate—guidelines are provided in Table 2-19 on page 2-14.

 β_1 is the I/O buffer enable rate—guidelines are provided in Table 2-20 on page 2-14.

F_{CLK} is the global clock signal frequency.

RAM Contribution—P_{MEMORY}

 $\mathsf{P}_{\mathsf{MEMORY}} = \mathsf{P}_{\mathsf{AC}11} * \mathsf{N}_{\mathsf{BLOCKS}} * \mathsf{F}_{\mathsf{READ\text{-}CLOCK}} * \beta_2 + \mathsf{PAC}12 * \mathsf{N}_{\mathsf{BLOCK}} * \mathsf{F}_{\mathsf{WRITE\text{-}CLOCK}} * \beta_3$

N_{BLOCKS} is the number of RAM blocks used in the design.

F_{READ-CLOCK} is the memory read clock frequency.

 β_2 is the RAM enable rate for read operations.

 $F_{WRITE\text{-}CLOCK}$ is the memory write clock frequency.

 β_3 is the RAM enable rate for write operations—guidelines are provided in Table 2-20 on page 2-14.

PLL Contribution—Ppl I

P_{PLL} = PDC4 + PAC1₃ *F_{CLKOUT}

F_{CLKOUT} is the output clock frequency.¹

Guidelines

Toggle Rate Definition

A toggle rate defines the frequency of a net or logic element relative to a clock. It is a percentage. If the toggle rate of a net is 100%, this means that this net switches at half the clock frequency. Below are some examples:

- The average toggle rate of a shift register is 100% because all flip-flop outputs toggle at half of the clock frequency.
- The average toggle rate of an 8-bit counter is 25%:

If a PLL is used to generate more than one output clock, include each output clock in the formula by adding its corresponding contribution (P_{AC13}* F_{CLKOUT} product) to the total PLL contribution.



IGLOO PLUS DC and Switching Characteristics

- Bit 0 (LSB) = 100% - Bit 1 = 50% - Bit 2 = 25%

- Bit 7 (MSB) = 0.78125%

– Average toggle rate = (100% + 50% + 25% + 12.5% + . . . + 0.78125%) / 8

Enable Rate Definition

Output enable rate is the average percentage of time during which tristate outputs are enabled. When nontristate output buffers are used, the enable rate should be 100%.

Table 2-19 • Toggle Rate Guidelines Recommended for Power Calculation

Component	Definition	Guideline
α_1	Toggle rate of VersaTile outputs	10%
α_2	I/O buffer toggle rate	10%

Table 2-20 • Enable Rate Guidelines Recommended for Power Calculation

Component	Definition	Guideline
β_1	I/O output buffer enable rate	100%
β_2	RAM enable rate for read operations	12.5%
β_3	RAM enable rate for write operations	12.5%

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User I/O Characteristics

Timing Model

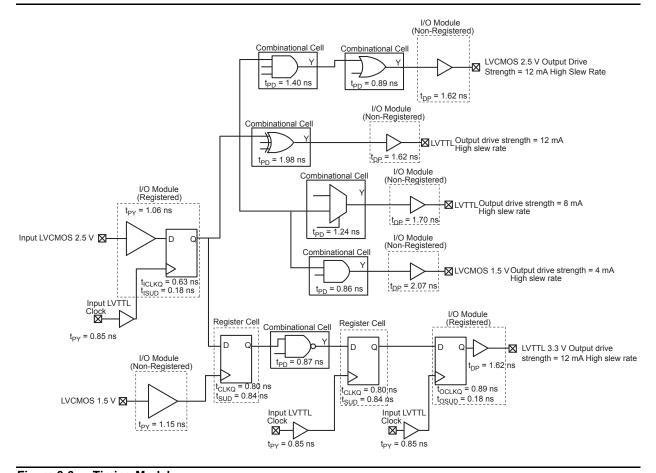


Figure 2-3 • Timing Model
Operating Conditions: STD Speed, Commercial Temperature Range (T_J = 70°C), Worst-Case
VCC = 1.425 V, for DC 1.5 V Core Voltage, Applicable to V2 and V5 Devices



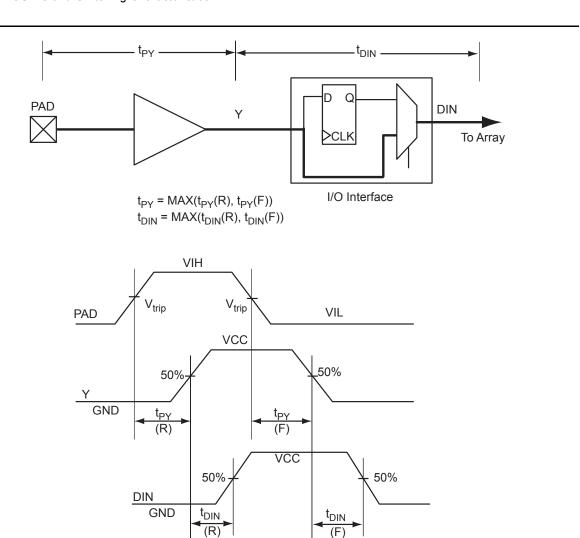


Figure 2-4 • Input Buffer Timing Model and Delays (example)

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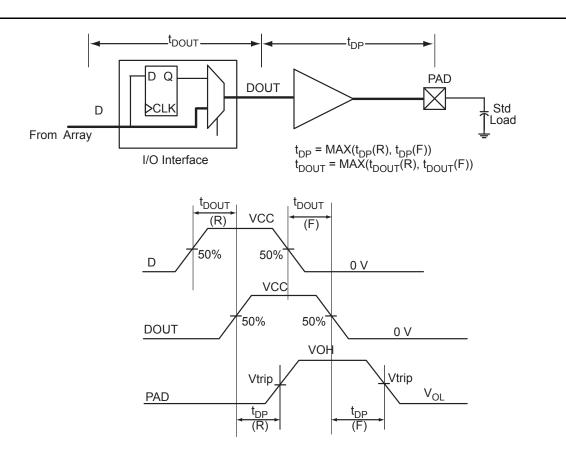


Figure 2-5 • Output Buffer Model and Delays (example)



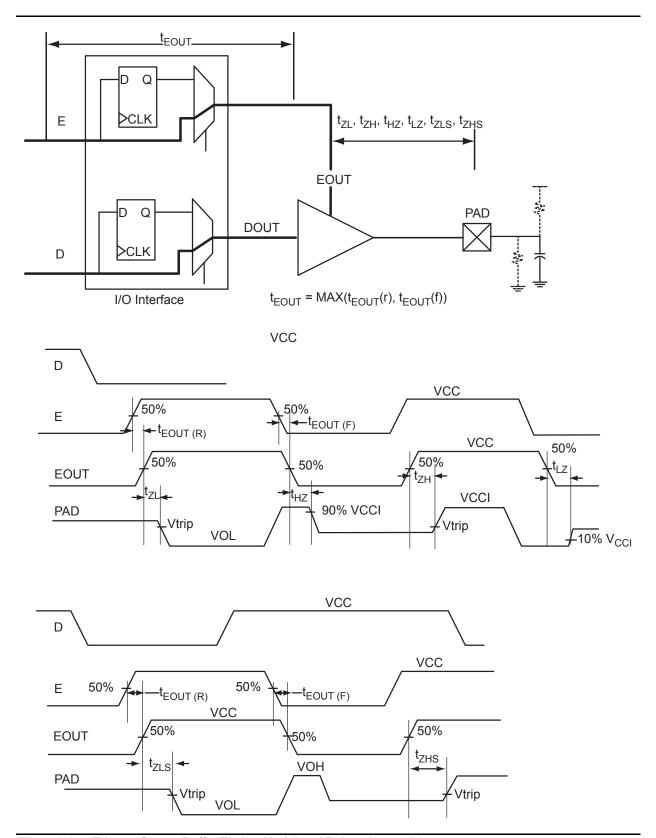


Figure 2-6 • Tristate Output Buffer Timing Model and Delays (example)

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Overview of I/O Performance

Summary of I/O DC Input and Output Levels – Default I/O Software Settings

Table 2-21 • Summary of Maximum and Minimum DC Input and Output Levels Applicable to Commercial and Industrial Conditions—Software Default Settings

	Equiv.		•		VIL	VIH		VOL	VOH	IOL ¹	IOH ¹
I/O Standard	Drive Strength	Software Default Drive Strength Option ²	Slew		Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA
3.3 V LVTTL / 3.3 V LVCMOS	12 mA	12 mA	High	-0.3	0.8	2	3.6	0.4	2.4	12	12
3.3 V LVCMOS Wide Range ³	100 μΑ	12 mA	High	-0.3	0.8	2	3.6	0.2	VDD 3 0.2	0.1	0.1
2.5 V LVCMOS	12 mA	12 mA	High	-0.3	0.7	1.7	3.6	0.7	1.7	12	12
1.8 V LVCMOS	8 mA	8 mA	High	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.45	VCCI - 0.45	8	8
1.5 V LVCMOS	4 mA	4 mA	High	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.25 * VCCI	0.75 * VCCI	4	4
1.2 V LVCMOS ⁴	2 mA	2 mA	High	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.25 * VCCI	0.75 * VCCI	2	2
1.2 V LVCMOS Wide Range ^{4,5}	100 μΑ	2 mA	High	-0.3	0.3 * VCCI	0.7 * VCCI	3.6	0.1	VCCI - 0.1	0.1	0.1

Notes:

- 1. Currents are measured at 85°C junction temperature.
- 2. Note that 1.2 V LVCMOS and 3.3 V LVCMOS wide range are applicable to 100 μ A drive strength only. The configuration will not operate at the equivalent software default drive strength. These values are for normal ranges only.
- 3. All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range as specified in the JESD-8B specification.
- 4. Applicable to IGLOO PLUS V2 devices operating at $VCC_1 \ge VCC$.
- 5. All LVCMOS 1.2 V software macros support LVCMOS 1.2 V wide range as specified in the JESD8-12 specification.



IGLOO PLUS DC and Switching Characteristics

Table 2-22 • Summary of Maximum and Minimum DC Input Levels
Applicable to Commercial and Industrial Conditions

	Com	mercial ¹	Industrial ²			
	IIL ³	IIH ⁴	IIL ³	IIH ⁴		
DC I/O Standards	μA	μΑ	μΑ	μΑ		
3.3 V LVTTL / 3.3 V LVCMOS	10	10	15	15		
3.3 V LVCMOS Wide Range	10	10	15	15		
2.5 V LVCMOS	10	10	15	15		
1.8 V LVCMOS	10	10	15	15		
1.5 V LVCMOS	10	10	15	15		
1.2 V LVCMOS ⁵	10	10	15	15		
1.2 V LVCMOS Wide Range ⁵	10	10	15	15		

Notes:

- 1. Commercial range (0°C < T_A < 70°C)
- 2. Industrial range $(-40^{\circ}\text{C} < T_A < 85^{\circ}\text{C})$
- 3. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 4. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 5. Applicable to IGLOO PLUS V2 devices operating at VCCI 3 VCC.

Summary of I/O Timing Characteristics – Default I/O Software Settings

Table 2-23 • Summary of AC Measuring Points

Standard	Measuring Trip Point (Vtrip)
3.3 V LVTTL / 3.3 V LVCMOS	1.4 V
3.3 V LVCMOS Wide Range	1.4 V
2.5 V LVCMOS	1.2 V
1.8 V LVCMOS	0.90 V
1.5 V LVCMOS	0.75 V
1.2 V LVCMOS	0.60 V
1.2 V LVCMOS Wide Range	0.60 V

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Table 2-24 • I/O AC Parameter Definitions

Parameter	Parameter Definition
t _{DP}	Data to Pad delay through the Output Buffer
t _{PY}	Pad to Data delay through the Input Buffer
t _{DOUT}	Data to Output Buffer delay through the I/O interface
t _{EOUT}	Enable to Output Buffer Tristate Control delay through the I/O interface
t _{DIN}	Input Buffer to Data delay through the I/O interface
t_{HZ}	Enable to Pad delay through the Output Buffer—High to Z
t _{ZH}	Enable to Pad delay through the Output Buffer—Z to High
t_{LZ}	Enable to Pad delay through the Output Buffer—Low to Z
t _{ZL}	Enable to Pad delay through the Output Buffer—Z to Low
t _{ZHS}	Enable to Pad delay through the Output Buffer with delayed enable—Z to High
t _{ZLS}	Enable to Pad delay through the Output Buffer with delayed enable—Z to Low



IGLOO PLUS DC and Switching Characteristics

Table 2-25 • Summary of I/O Timing Characteristics—Software Default Settings, STD Speed Grade,
Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V

I/O Standard	Drive Strength	Equivalent Software Default Drive Strength Option ¹	Slew Rate	Capacitive Load (pF)	External Resistor (\O)	[‡] роит	t _{DP}	t _{DIN}	tpy	tpys	teour	t _{ZL}	tzн	t _{LZ}	t _{HZ}	Units
3.3 V LVTTL / 3.3 V LVCMOS	12 mA	12 mA	High	5 pF	ı	0.97	1.76	0.18	0.85	1.15	0.66	1.80	1.39	2.20	2.64	ns
3.3 V LVCMOS Wide Range ²	100 μΑ	12 mA	High	5 pF	1	0.97	2.47	0.18	1.18	1.64	0.66	2.48	1.91	3.16	3.76	ns
2.5 V LVCMOS	12 mA	12 mA	High	5 pF	-	0.97	1.77	0.18	1.06	1.22	0.66	1.81	1.51	2.22	2.56	ns
1.8 V LVCMOS	8 mA	8 mA	High	5 pF	1	0.97	2.00	0.18	1.00	1.43	0.66	2.04	1.76	2.29	2.55	ns
1.5 V LVCMOS	4 mA	4 mA	High	5 pF	1	0.97	2.29	0.18	1.16	1.62	0.66	2.33	2.00	2.37	2.57	ns

Notes:

- 1. Note that 3.3 V LVCMOS wide range is applicable to 100 μ A drive strength only. The configuration will not operate at the equivalent software default drive strength. These values are for normal ranges only.
- 2. All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range as specified in the JESD-8B specification.
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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Table 2-26 • Summary of I/O Timing Characteristics—Software Default Settings, STD Speed Grade Commercial-Case Conditions: $T_J = 70^{\circ}$ C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 3.0 V

I/O Standard	Drive Strength	Equivalent Software Default Drive Strength Option ¹	Slew Rate	Capacitive Load (pF)	External Resistor (\O)	tвоит	t _{DP}	[‡] DIN	t _{PY})	tpys	teour	t _{ZL}	t _Z н	t _{LZ}	t _{HZ}	Units
3.3 V LVTTL / 3.3 V LVCMOS	12 mA	12 mA	High	5 pF	-	0.98	2.31	0.19	0.99	1.37	0.67	2.34	1.86	2.65	3.38	ns
3.3 V LVCMOS Wide Range ²	100 µA	12 mA	High	5 pF	-	0.98	3.21	0.19	1.32	1.92	0.67	3.21	2.52	3.73	4.73	ns
2.5 V LVCMOS	12 mA	12 mA	High	5 pF	_	0.98	2.29	0.19	1.19	1.40	0.67	2.32	1.94	2.65	3.27	ns
1.8 V LVCMOS	8 mA	8 mA	High	5 pF	_	0.98	2.45	0.19	1.12	1.61	0.67	2.48	2.16	2.71	3.16	ns
1.5 V LVCMOS	4 mA	4 mA	High	5 pF	-	0.98	2.71	0.19	1.26	1.80	0.67	2.75	2.39	2.78	3.15	ns
1.2 V LVCMOS	2 mA	2 mA	High	5 pF	_	0.98	3.38	0.19	1.57	2.34	0.67	3.26	2.78	2.99	3.24	ns
1.2 V LVCMOS Wide Range ³	100 µA	2 mA	High	5 pF	-	0.98	3.38	0.19	1.57	2.34	0.67	3.26	2.78	2.99	3.24	ns

Notes:

- 1. The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is $\pm 100~\mu A$. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 2. All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range as specified in the JESD-8B specification.
- 3. All LVCMOS 1.2 V software macros support LVCMOS 1.2 V wide range as specified in the JESD8-12 specification.
- 4. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Detailed I/O DC Characteristics

Table 2-27 • Input Capacitance

Symbol	Definition	Conditions	Min.	Max.	Units
C _{IN}	Input capacitance	VIN = 0, f = 1.0 MHz		8	pF
C _{INCLK}	Input capacitance on the clock pin	VIN = 0, f = 1.0 MHz		8	pF

Table 2-28 • I/O Output Buffer Maximum Resistances 1

Standard	Drive Strength	R _{PULL-DOWN} (Ω) ²	R _{PULL-UP} (Ω) ³
3.3 V LVTTL / 3.3V LVCMOS	2 mA	100	300
	4 mA	100	300
	6 mA	50	150
	8 mA	50	150
	12 mA	25	75
	16 mA	25	75
3.3 V LVCMOS Wide Range	100 μΑ	Same as equivalen	t software default drive
2.5 V LVCMOS	2 mA	100	200
	4 mA	100	200
	6 mA	50	100
	8 mA	50	100
	12 mA	25	50
1.8 V LVCMOS	2 mA	200	225
	4 mA	100	112
	6 mA	50	56
	8 mA	50	56
1.5 V LVCMOS	2 mA	200	224
	4 mA	100	112
1.2 V LVCMOS	2 mA	157.5	163.8
1.2 V LVCMOS Wide Range ⁴	100 μΑ	157.5	163.8

Notes:

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^{1.} These maximum values are provided for informational reasons only. Minimum output buffer resistance values depend on VCC_I, drive strength selection, temperature, and process. For board design considerations and detailed output buffer resistances, use the corresponding IBIS model on the Microsemi SoC Products Group website at http://www.microsemi.com/soc/download/ibis/default.aspx.

^{2.} $R_{(PULL-DOWN-MAX)} = (VOLspec) / IOLspec$

^{3.} $R_{(PULL-UP-MAX)} = (VCCImax - VOHspec) / IOHspec$

^{4.} Applicable to IGLOO PLUS V2 devices operating at VCCI ≥ VCC.



Table 2-29 • I/O Weak Pull-Up/Pull-Down Resistances Minimum and Maximum Weak Pull-Up/Pull-Down Resistance Values

	R _{(WEAK I}	PULL-UP) ¹ 2)	$R_{(WEAK\;PULL-DOWN)}^2 \ (\Omega)$			
VCCI	Min.	Max.	Min.	Max.		
3.3 V	10 K	45 K	10 K	45 K		
3.3 V (wide range I/Os)	10 K	45 K	10 K	45 K		
2.5 V	11 K	55 K	12 K	74 K		
1.8 V	18 K	70 K	17 K	110 K		
1.5 V	19 K	90 K	19 K	140 K		
1.2 V	25 K	110 K	25 K	150 K		
1.2 V (wide range I/Os)	19 K	110 K	19 K	150 K		

Notes:

- 1. $R_{(WEAK\ PULL-UP-MAX)} = (VCCImax VOHspec) / I_{(WEAK\ PULL-UP-MIN)}$ 2. $R_{(WEAK\ PULLDOWN-MAX)} = (VOLspec) / I_{(WEAK\ PULLDOWN-MIN)}$

Table 2-30 • I/O Short Currents IOSH/IOSL

	Drive Strength	IOSL (mA)*	IOSH (mA)*
3.3 V LVTTL / 3.3 V LVCMOS	2 mA	27	25
	4 mA	27	25
	6 mA	54	51
	8 mA	54	51
	12 mA	109	103
	16 mA	109	103
3.3 V LVCMOS Wide Range	100 μΑ	Same as equivalent	software default drive
2.5 V LVCMOS	2 mA	18	16
	4 mA	18	16
	6 mA	37	32
	8 mA	37	32
	12 mA	74	65
1.8 V LVCMOS	2 mA	11	9
	4 mA	22	17
	6 mA	44	35
	8 mA	44	35
1.5 V LVCMOS	2 mA	16	13
	4 mA	33	25
1.2 V LVCMOS	2 mA	26	20
1.2 V LVCMOS Wide Range	100 μΑ	26	20

Note: $*T_J = 100$ °C



The length of time an I/O can withstand IOSH/IOSL events depends on the junction temperature. The reliability data below is based on a 3.3 V, 12 mA I/O setting, which is the worst case for this type of analysis.

For example, at 100°C, the short current condition would have to be sustained for more than six months to cause a reliability concern. The I/O design does not contain any short circuit protection, but such protection would only be needed in extremely prolonged stress conditions.

Table 2-31 • Duration of Short Circuit Event before Failure

Temperature	Time before Failure
-40°C	> 20 years
0°C	> 20 years
25°C	> 20 years
70°C	5 years
85°C	2 years
100°C	6 months

Table 2-32 • Schmitt Trigger Input Hysteresis
Hysteresis Voltage Value (Typ.) for Schmitt Mode Input Buffers

Input Buffer Configuration	Hysteresis Value (typ.)
3.3 V LVTTL/LVCMOS (Schmitt trigger mode)	240 mV
2.5 V LVCMOS (Schmitt trigger mode)	140 mV
1.8 V LVCMOS (Schmitt trigger mode)	80 mV
1.5 V LVCMOS (Schmitt trigger mode)	60 mV
1.2 V LVCMOS (Schmitt trigger mode)	40 mV

Table 2-33 • I/O Input Rise Time, Fall Time, and Related I/O Reliability

Input Buffer			Input Rise/Fall Time (min.)	Input Rise/Fall Time (max.)	Reliability
LVTTL/LVCMOS disabled)	(Schmitt	trigger	No requirement	10 ns *	20 years (100°C)
LVTTL/LVCMOS enabled)	(Schmitt	trigger	No requirement	No requirement, but input noise voltage cannot exceed Schmitt hysteresis.	20 years (100°C)

Note: *The maximum input rise/fall time is related to the noise induced into the input buffer trace. If the noise is low, then the rise time and fall time of input buffers can be increased beyond the maximum value. The longer the rise/fall times, the more susceptible the input signal is to the board noise. Microsemi recommends signal integrity evaluation/characterization of the system to ensure that there is no excessive noise coupling into input signals.

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Single-Ended I/O Characteristics

3.3 V LVTTL / 3.3 V LVCMOS

Low-Voltage Transistor–Transistor Logic (LVTTL) is a general-purpose standard (EIA/JESD) for 3.3 V applications. It uses an LVTTL input buffer and push-pull output buffer.

Table 2-34 • Minimum and Maximum DC Input and Output Levels

3.3 V LVTTL / 3.3 V LVCMOS	٧	TL.	v	IH	VOL	VOH	IOL	ЮН	IOSL	IOSH	IIL ¹	IIH ²
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ³	Max. mA ³	μ Α ⁴	μ Α ⁴
2 mA	-0.3	0.8	2	3.6	0.4	2.4	2	2	25	27	10	10
4 mA	-0.3	0.8	2	3.6	0.4	2.4	4	4	25	27	10	10
6 mA	-0.3	0.8	2	3.6	0.4	2.4	6	6	51	54	10	10
8 mA	-0.3	0.8	2	3.6	0.4	2.4	8	8	51	54	10	10
12 mA	-0.3	0.8	2	3.6	0.4	2.4	12	12	103	109	10	10
16 mA	-0.3	0.8	2	3.6	0.4	2.4	16	16	103	109	10	10

Notes:

- 1. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 2. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 4. Currents are measured at 85°C junction temperature.
- 5. Software default selection highlighted in gray.

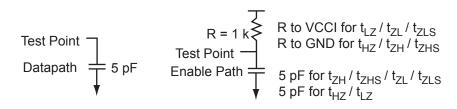


Figure 2-7 • AC Loading

Table 2-35 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	3.3	1.4	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

Timing Characteristics

Applies to 1.5 V DC Core Voltage

Table 2-36 • 3.3 V LVTTL / 3.3 V LVCMOS Low Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	3.94	0.18	0.85	1.15	0.66	4.02	3.46	1.82	1.87	ns
4 mA	STD	0.97	3.94	0.18	0.85	1.15	0.66	4.02	3.46	1.82	1.87	ns
6 mA	STD	0.97	3.20	0.18	0.85	1.15	0.66	3.27	2.94	2.04	2.27	ns
8 mA	STD	0.97	3.20	0.18	0.85	1.15	0.66	3.27	2.94	2.04	2.27	ns
12 mA	STD	0.97	2.72	0.18	0.85	1.15	0.66	2.78	2.57	2.20	2.53	ns
16 mA	STD	0.97	2.72	0.18	0.85	1.15	0.66	2.78	2.57	2.20	2.53	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-37 • 3.3 V LVTTL / 3.3 V LVCMOS High Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	2.36	0.18	0.85	1.15	0.66	2.41	1.90	1.82	1.98	ns
4 mA	STD	0.97	2.36	0.18	0.85	1.15	0.66	2.41	1.90	1.82	1.98	ns
6 mA	STD	0.97	1.96	0.18	0.85	1.15	0.66	2.01	1.56	2.04	2.38	ns
8 mA	STD	0.97	1.96	0.18	0.85	1.15	0.66	2.01	1.56	2.04	2.38	ns
12 mA	STD	0.97	1.76	0.18	0.85	1.15	0.66	1.80	1.39	2.20	2.64	ns
16 mA	STD	0.97	1.76	0.18	0.85	1.15	0.66	1.80	1.39	2.20	2.64	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

Applies to 1.2 V DC Core Voltage

Table 2-38 • 3.3 V LVTTL / 3.3 V LVCMOS Low Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 3.0 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.98	4.56	0.19	0.99	1.37	0.67	4.63	3.98	2.26	2.57	ns
4 mA	STD	0.98	4.56	0.19	0.99	1.37	0.67	4.63	3.98	2.26	2.57	ns
6 mA	STD	0.98	3.80	0.19	0.99	1.37	0.67	3.96	3.45	2.49	2.98	ns
8 mA	STD	0.98	3.80	0.19	0.99	137	0.67	3.86	3.45	2.49	2.98	ns
12 mA	STD	0.98	3.31	0.19	0.99	1.37	0.67	3.36	3.07	2.65	3.25	ns
16 mA	STD	0.98	3.31	0.19	0.99	1.37	0.67	3.36	3.07	2.65	3.25	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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Table 2-39 • 3.3 V LVTTL / 3.3 V LVCMOS High Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 3.0 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.98	2.92	0.19	0.99	1.37	0.67	2.97	2.38	2.25	2.70	ns
4 mA	STD	0.98	2.92	0.19	0.99	1.37	0.67	2.97	2.38	2.25	2.70	ns
6 mA	STD	0.98	2.52	0.19	0.99	1.37	0.67	2.56	2.03	2.49	3.11	ns
8 mA	STD	0.98	2.52	0.19	0.99	1.37	0.67	2.56	2.03	2.49	3.11	ns
12 mA	STD	0.98	2.31	0.19	0.99	1.37	0.67	2.34	1.86	2.65	3.38	ns
16 mA	STD	0.98	2.31	0.19	0.99	1.37	0.67	2.34	1.86	2.65	3.38	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray

3.3 V LVCMOS Wide Range

Table 2-40 • Minimum and Maximum DC Input and Output Levels

3.3 V LVCMOS Wide Range	Equivalent Software Default Drive Strength Option ¹		ΊL	v	IH	VOL	VOH	IOL	ЮН	IOSL	IOSH	IIL ²	IIH ³
Drive Strength		Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	μΑ	μΑ	Max. μΑ ⁴	Max. μA ⁴	μΑ ⁵	μ Α ⁵
100 μΑ	2 mA	-0.3	0.8	2	3.6	0.2	VDD – 0.2	100	100	25	27	10	10
100 μΑ	4 mA	-0.3	0.8	2	3.6	0.4	VDD – 0.2	100	100	25	27	10	10
100 μΑ	6 mA	-0.3	0.8	2	3.6	0.4	VDD – 0.2	100	100	51	54	10	10
100 μΑ	8 mA	-0.3	0.8	2	3.6	0.4	VDD – 0.2	100	100	51	54	10	10
100 μΑ	12 mA	-0.3	0.8	2	3.6	0.4	VDD - 0.2	100	100	103	109	10	10
100 μΑ	16 mA	-0.3	0.8	2	3.6	0.4	VDD – 0.2	100	100	103	109	10	10

Notes:

- 1. The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 2. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 3. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < V CCI. Input current is larger when operating outside recommended ranges.
- 4. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 5. Currents are measured at 85°C junction temperature.
- 6. Software default selection highlighted in gray.

Table 2-41 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	3.3	1.4	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

Timing Characteristics

Applies to 1.5 V DC Core Voltage

Table 2-42 • 3.3 V LVCMOS Wide Range Low Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.7 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	4 mA	STD	0.97	5.85	0.18	1.18	1.64	0.66	5.86	5.05	2.57	2.57	ns
100 μΑ	6 mA	STD	0.97	4.70	0.18	1.18	1.64	0.66	4.72	4.27	2.92	3.19	ns
100 μΑ	8 mA	STD	0.97	4.70	0.18	1.18	1.64	0.66	4.72	4.27	2.92	3.19	ns
100 μΑ	12 mA	STD	0.97	3.96	0.18	1.18	1.64	0.66	3.98	3.70	3.16	3.59	ns
100 μΑ	16 mA	STD	0.97	3.96	0.18	1.18	1.64	0.66	3.98	3.70	3.16	3.59	ns

Notes:

Table 2-43 • 3.3 V LVCMOS Wide Range High Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.7 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	4 mA	STD	0.97	3.39	0.18	1.18	1.64	0.66	3.41	2.69	2.57	2.73	ns
100 μΑ	6 mA	STD	0.97	2.79	0.18	1.18	1.64	0.66	2.80	2.17	2.92	3.36	ns
100 μΑ	8 mA	STD	0.97	2.79	0.18	1.18	1.64	0.66	2.80	2.17	2.92	3.36	ns
100 μΑ	12 mA	STD	0.97	2.47	0.18	1.18	1.64	0.66	2.48	1.91	3.16	3.76	ns
100 μΑ	16 mA	STD	0.97	2.47	0.18	1.18	1.64	0.66	2.48	1.91	3.16	3.76	ns

Notes:

- 1. The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 3. Software default selection highlighted in gray.

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^{1.} The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.

^{2.} For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.



Applies to 1.2 V DC Core Voltage

Table 2-44 • 3.3 V LVCMOS Wide Range Low Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.7 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	4 mA	STD	0.98	6.68	0.19	1.32	1.92	0.67	6.68	5.74	3.13	3.47	ns
100 μΑ	6 mA	STD	0.98	5.51	0.19	1.32	1.92	0.67	5.51	4.94	3.48	4.11	ns
100 μΑ	8 mA	STD	0.98	5.51	0.19	1.32	1.92	0.67	5.51	4.94	3.48	4.11	ns
100 μΑ	12 mA	STD	0.98	4.75	0.19	1.32	1.92	0.67	4.75	4.36	3.73	4.52	ns
100 μΑ	16 mA	STD	0.98	4.75	0.19	1.32	1.92	0.67	4.75	4.36	3.73	4.52	ns

Notes:

Table 2-45 • 3.3 V LVCMOS Wide Range High Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.7 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	4 mA	STD	0.98	4.16	0.19	1.32	1.92	0.67	4.16	3.32	3.12	3.66	ns
100 μΑ	6 mA	STD	0.98	3.54	0.19	1.32	1.92	0.67	3.54	2.79	3.48	4.31	ns
100 μΑ	8 mA	STD	0.98	3.54	0.19	1.32	1.92	0.67	3.54	2.79	3.48	4.31	ns
100 μΑ	12 mA	STD	0.98	3.21	0.19	1.32	1.92	0.67	3.21	2.52	3.73	4.73	ns
100 μΑ	16 mA	STD	0.98	3.21	0.19	1.32	1.92	0.67	3.21	2.52	3.73	4.73	ns

Notes:

- 1. The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 3. Software default selection highlighted in gray.

^{1.} The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.

^{2.} For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

2.5 V LVCMOS

Low-Voltage CMOS for 2.5 V is an extension of the LVCMOS standard (JESD8-5) used for general-purpose 2.5 V applications.

Table 2-46 • Minimum and Maximum DC Input and Output Levels

2.5 V LVCMOS	٧	TL.	v	IH	VOL	VOH	IOL	ЮН	IOSL	IOSH	IIL ¹	IIH ²
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ³	Max. mA ³	μ Α ⁴	μ Α ⁴
2 mA	-0.3	0.7	1.7	3.6	0.7	1.7	2	2	16	18	10	10
4 mA	-0.3	0.7	1.7	3.6	0.7	1.7	4	4	16	18	10	10
6 mA	-0.3	0.7	1.7	3.6	0.7	1.7	6	6	32	37	10	10
8 mA	-0.3	0.7	1.7	3.6	0.7	1.7	8	8	32	37	10	10
12 mA	-0.3	0.7	1.7	3.6	0.7	1.7	12	12	65	74	10	10

Notes:

- 1. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 2. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 4. Currents are measured at 85°C junction temperature.
- 5. Software default selection highlighted in gray.

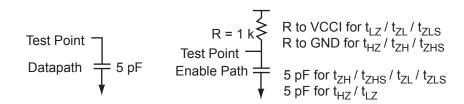


Figure 2-8 • AC Loading

Table 2-47 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	2.5	1.2	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

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Timing Characteristics

Applies to 1.5 V DC Core Voltage

Table 2-48 • 2.5 V LVCMOS Low Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.3 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
4 mA	STD	0.97	4.44	0.18	1.06	1.22	0.66	4.53	4.15	1.80	1.70	ns
6 mA	STD	0.97	3.61	0.18	1.06	1.22	0.66	3.69	3.50	2.05	2.18	ns
8 mA	STD	0.97	3.61	0.18	1.06	1.22	0.66	3.69	3.50	2.05	2.18	ns
12 mA	STD	0.97	3.07	0.18	1.06	1.22	0.66	3.14	3.03	2.22	2.48	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-49 • 2.5 V LVCMOS High Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.3 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
4 mA	STD	0.97	2.41	0.18	1.06	1.22	0.66	2.47	2.22	1.79	1.77	ns
6 mA	STD	0.97	1.99	0.18	1.06	1.22	0.66	2.04	1.75	2.04	2.25	ns
8 mA	STD	0.97	1.99	0.18	1.06	1.22	0.66	2.04	1.75	2.04	2.25	ns
12 mA	STD	0.97	1.77	0.18	1.06	1.22	0.66	1.81	1.51	2.22	2.56	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

Applies to 1.2 V DC Core Voltage

Table 2-50 • 2.5 LVCMOS Low Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCC_I = 2.3 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
4 mA	STD	0.98	5.04	0.19	1.19	1.40	0.67	5.12	4.65	2.22	2.36	ns
6 mA	STD	0.98	4.19	0.19	1.19	1.40	0.67	4.25	3.98	2.48	2.85	ns
8 mA	STD	0.98	4.19	0.19	1.19	1.40	0.67	4.25	3.98	2.48	2.85	ns
12 mA	STD	0.98	3.63	0.19	1.19	1.40	0.67	3.69	3.50	2.66	3.16	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-51 • 2.5 V LVCMOS High Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 2.3 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
4 mA	STD	0.98	2.96	0.19	1.19	1.40	0.67	3.00	2.67	2.22	2.46	ns
6 mA	STD	0.98	2.52	0.19	1.19	1.40	0.67	2.56	2.18	2.47	2.95	ns
8 mA	STD	0.98	2.52	0.19	1.19	1.40	0.67	2.56	2.18	2.47	2.95	ns
12 mA	STD	0.98	2.29	0.19	1.19	1.40	0.67	2.32	1.94	2.65	3.27	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

1.8 V LVCMOS

Low-voltage CMOS for 1.8 V is an extension of the LVCMOS standard (JESD8-5) used for general-purpose 1.8 V applications. It uses a 1.8 V input buffer and a push-pull output buffer.

Table 2-52 • Minimum and Maximum DC Input and Output Levels

1.8 V LVCMOS		VIL	VIH		VOL	VOH	IOL	ЮН	IOSL	IOSH	IIL ¹	IIH ²
Drive Strength	Min., V	Max., V	Min., V	Max., V	Max., V	Min., V	mA	mA	Max., mA ³	Max., mA ³	μ Α ⁴	μ Α ⁴
2 mA	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.45	VCCI - 0.45	2	2	9	11	10	10
4 mA	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.45	VCCI - 0.45	4	4	17	22	10	10
6 mA	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.45	VCCI-0.45	6	6	35	44	10	10
8 mA	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.45	VCCI-0.45	8	8	35	44	10	10

Notes:

- 1. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 2. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 4. Currents are measured at 85°C junction temperature.
- 5. Software default selection highlighted in gray.

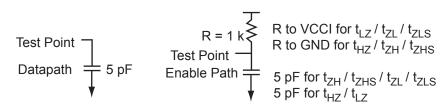


Figure 2-9 • AC Loading

Table 2-53 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	1.8	0.9	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

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Timing Characteristics

Applies to 1.5 V DC Core Voltage

Table 2-54 • 1.8 V LVCMOS Low Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 1.7 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t_{ZL}	t _{ZH}	t_{LZ}	t _{HZ}	Units
2 mA	STD	0.97	5.89	0.18	1.00	1.43	0.66	6.01	5.43	1.78	1.30	ns
4 mA	STD	0.97	4.82	0.18	1.00	1.43	0.66	4.92	4.56	2.08	2.08	ns
6 mA	STD	0.97	4.13	0.18	1.00	1.43	0.66	4.21	3.96	2.30	2.46	ns
8 mA	STD	0.97	4.13	0.18	1.00	1.43	0.66	4.21	3.96	2.30	2.46	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-55 • 1.8 V LVCMOS High Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_{.J} = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 1.7 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	2.82	0.18	1.00	1.43	0.66	2.88	2.78	1.78	1.35	ns
4 mA	STD	0.97	2.30	0.18	1.00	1.43	0.66	2.35	2.11	2.08	2.15	ns
6 mA	STD	0.97	2.00	0.18	1.00	1.43	0.66	2.04	1.76	2.29	2.55	ns
8 mA	STD	0.97	2.00	0.18	1.00	1.43	0.66	2.04	1.76	2.29	2.55	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

Applies to 1.2 V DC Core Voltage

Table 2-56 • 1.8 V LVCMOS Low Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.7 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.98	6.43	0.19	1.12	1.61	0.67	6.54	5.93	2.19	1.88	ns
4 mA	STD	0.98	5.33	0.19	1.12	1.61	0.67	5.41	5.03	2.50	2.68	ns
6 mA	STD	0.98	4.61	0.19	1.12	1.61	0.67	4.69	4.41	2.72	3.07	ns
8 mA	STD	0.98	4.61	0.19	1.12	1.61	0.67	4.69	4.41	2.72	3.07	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-57 • 1.8 V LVCMOS High Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.7 V

Drive Strength	Speed Grade	t	t	t	t	t	t	f	t	t	f	Units
Drive Ottength	opeed Grade	t _{DOUT}	t _{DP}	τ _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	τ _{LZ}	τ _{HZ}	Office
2 mA	STD	0.98	3.30	0.19	1.12	1.61	0.67	3.34	3.21	2.19	1.93	ns
4 mA	STD	0.98	2.76	0.19	1.12	1.61	0.67	2.79	2.51	2.50	2.76	ns
6 mA	STD	0.98	2.45	0.19	1.12	1.61	0.67	2.48	2.16	2.71	3.16	ns
8 mA	STD	0.98	2.45	0.19	1.12	1.61	0.67	2.48	2.16	2.71	3.16	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

1.5 V LVCMOS (JESD8-11)

Low-Voltage CMOS for 1.5 V is an extension of the LVCMOS standard (JESD8-5) used for general-purpose 1.5 V applications. It uses a 1.5 V input buffer and a push-pull output buffer.

Table 2-58 • Minimum and Maximum DC Input and Output Levels

1.5 V LVCMOS		VIL	VIH		VOL	VOH	IOL	ЮН	IOSL	IOSH	IIL ¹	IIH ²
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ³	Max. mA ³	μ Α ⁴	μ Α ⁴
2 mA	-0.3	0.35 * VCCI	0.7 * VCCI	3.6	0.25 * VCCI	0.75 * VCCI	2	2	13	16	10	10
4 mA	-0.3	0.35 * VCCI	0.7 * VCCI	3.6	0.25 * VCCI	0.75 * VCCI	4	4	25	33	10	10

Notes:

- 1. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 2. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 4. Currents are measured at 85°C junction temperature.
- 5. Software default selection highlighted in gray.

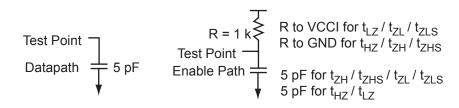


Figure 2-10 • AC Loading

Table 2-59 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	1.5	0.75	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

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Timing Characteristics

Applies to 1.5 V DC Core Voltage

Table 2-60 • 1.5 V LVCMOS Low Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 1.4 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	6.07	0.18	1.16	1.62	0.66	6.19	5.53	2.13	2.02	ns
4 mA	STD	0.97	5.24	0.18	1.16	1.62	0.66	5.34	4.81	2.37	2.47	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-61 • 1.5 V LVCMOS High Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 1.4 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	2.65	0.18	1.16	1.62	0.66	2.71	2.43	2.13	2.11	ns
4 mA	STD	0.97	2.29	0.18	1.16	1.62	0.66	2.33	2.00	2.37	2.57	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

Applies to 1.2 V DC Core Voltage

Table 2-62 • 1.5 V LVCMOS Low Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.98	6.57	0.19	1.26	1.80	0.67	6.68	6.01	2.54	2.59	ns
4 mA	STD	0.98	5.72	0.19	1.26	1.80	0.67	5.81	5.27	2.79	3.05	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-63 • 1.5 V LVCMOS High Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.98	3.08	0.19	1.26	1.80	0.67	3.13	2.82	2.53	2.68	ns
4 mA	STD	0.98	2.71	0.19	1.26	1.80	0.67	2.75	2.39	2.78	3.15	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

1.2 V LVCMOS (JESD8-12A)

Low-Voltage CMOS for 1.2 V complies with the LVCMOS standard JESD8-12A for general purpose 1.2 V applications. It uses a 1.2 V input buffer and a push-pull output buffer.

Table 2-64 • Minimum and Maximum DC Input and Output Levels

1.2 V LVCMOS ¹		VIL	VIH		VOL	VOH	IOL	ЮН	IOSL	IOSH	IIL ²	IIH ³
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ⁴	Max. mA ⁴	μ Α ⁵	μ Α ⁵
2 mA	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.25 * VCCI	0.75 * VCCI	2	2	20	26	10	10

Notes:

- 1. Applicable to IGLOO nano V2 devices operating at VCCI ≥ VCC.
- 2. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 3. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 4. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 5. Currents are measured at 85°C junction temperature.
- 6. Software default selection highlighted in gray.

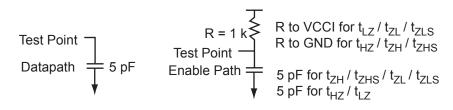


Figure 2-11 • AC Loading

Table 2-65 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	1.2	0.6	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

Timing Characteristics

Applies to 1.2 V DC Core Voltage

Table 2-66 • 1.2 V LVCMOS Low Slew

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.14 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.98	8.27	0.19	1.57	2.34	0.67	7.94	6.77	3.00	3.11	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-67 • 1.2 V LVCMOS High Slew

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.14 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.98	3.38	0.19	1.57	2.34	0.67	3.26	2.78	2.99	3.24	ns

Notes:

- 1. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 2. Software default selection highlighted in gray.

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1.2 V LVCMOS Wide Range

Table 2-68 • Minimum and Maximum DC Input and Output Levels

1.2 V LVCMOS Range ¹	Wide		VIL	VIH		VOL	VOH	IOL	ЮН	IOSL	юзн	IIL ³	IIH ⁴
Drive Strength	Equivalent Software Default Drive Strength Option ²	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ⁵	Max mA ⁵	μ Α ⁶	μ Α ⁶
100 μΑ	2 mA	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.25 * VCCI	0.75 * VCCI	2	2	20	26	10	10

Notes:

- 1. Applicable to V2 devices only.
- 2. The minimum drive strength for any LVCMOS 1.2 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 3. IIL is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.
- 4. IIH is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 5. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 6. Currents are measured at 85°C junction temperature.
- 7. Software default selection highlighted in gray.

Table 2-69 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	1.2	0.6	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.



Timing Characteristics

Applies to 1.2 V DC Core Voltage

Table 2-70 • 1.2 V LVCMOS Wide Range Low Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.14 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	2 mA	STD	0.98	8.27	0.19	1.57	2.34	0.67	7.94	6.77	3.00	3.11	ns

Notes:

- 1. The minimum drive strength for any LVCMOS 1.2 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-71 • 1.2 V LVCMOS Wide Range High Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.14 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	2 mA	STD	0.98	3.38	0.19	1.57	2.34	0.67	3.26	2.78	2.99	3.24	ns

Notes:

- The minimum drive strength for any LVCMOS 1.2 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 3. Software default selection highlighted in gray.

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I/O Register Specifications

Fully Registered I/O Buffers with Asynchronous Preset

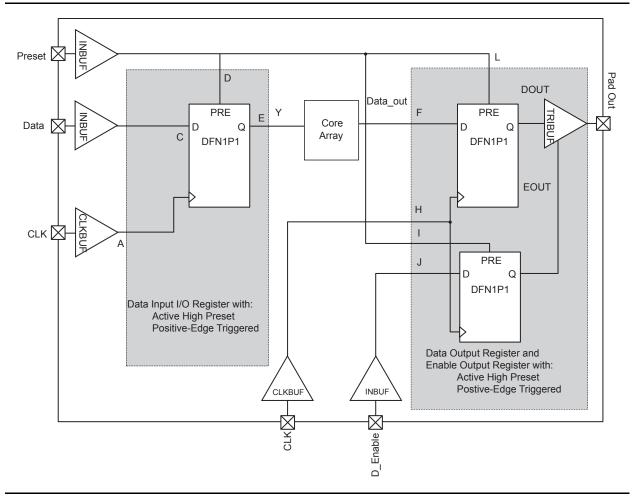


Figure 2-12 • Timing Model of Registered I/O Buffers with Asynchronous Preset

Table 2-72 • Parameter Definition and Measuring Nodes

Parameter Name	Parameter Definition	Measuring Nodes (from, to)*
t _{OCLKQ}	Clock-to-Q of the Output Data Register	H, DOUT
tosup	Data Setup Time for the Output Data Register	F, H
t _{OHD}	Data Hold Time for the Output Data Register	F, H
t _{OPRE2Q}	Asynchronous Preset-to-Q of the Output Data Register	L, DOUT
t _{OREMPRE}	Asynchronous Preset Removal Time for the Output Data Register	L, H
t _{ORECPRE}	Asynchronous Preset Recovery Time for the Output Data Register	L, H
t _{OECLKQ}	Clock-to-Q of the Output Enable Register	H, EOUT
t _{OESUD}	Data Setup Time for the Output Enable Register	J, H
t _{OEHD}	Data Hold Time for the Output Enable Register	J, H
t _{OEPRE2Q}	Asynchronous Preset-to-Q of the Output Enable Register	I, EOUT
t _{OEREMPRE}	Asynchronous Preset Removal Time for the Output Enable Register	I, H
t _{OERECPRE}	Asynchronous Preset Recovery Time for the Output Enable Register	I, H
t _{ICLKQ}	Clock-to-Q of the Input Data Register	A, E
t _{ISUD}	Data Setup Time for the Input Data Register	C, A
t _{IHD}	Data Hold Time for the Input Data Register	C, A
t _{IPRE2Q}	Asynchronous Preset-to-Q of the Input Data Register	D, E
t _{IREMPRE}	Asynchronous Preset Removal Time for the Input Data Register	D, A
t _{IRECPRE}	Asynchronous Preset Recovery Time for the Input Data Register	D, A

Note: *See Figure 2-12 on page 2-41 for more information.

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Fully Registered I/O Buffers with Asynchronous Clear

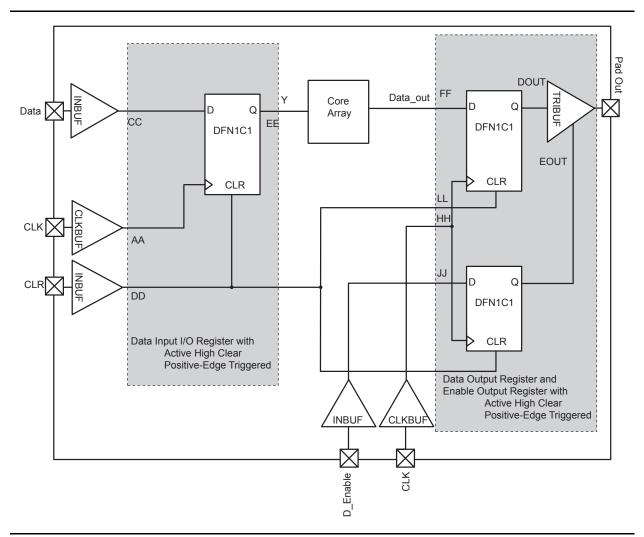


Figure 2-13 • Timing Model of the Registered I/O Buffers with Asynchronous Clear

Table 2-73 • Parameter Definition and Measuring Nodes

Parameter Name	Parameter Definition	Measuring Nodes (from, to)*
t _{oclkQ}	Clock-to-Q of the Output Data Register	HH, DOUT
t _{OSUD}	Data Setup Time for the Output Data Register	FF, HH
t _{OHD}	Data Hold Time for the Output Data Register	FF, HH
t _{OCLR2Q}	Asynchronous Clear-to-Q of the Output Data Register	LL, DOUT
toremclr	Asynchronous Clear Removal Time for the Output Data Register	LL, HH
t _{ORECCLR}	Asynchronous Clear Recovery Time for the Output Data Register	LL, HH
t _{OECLKQ}	Clock-to-Q of the Output Enable Register	HH, EOUT
t _{OESUD}	Data Setup Time for the Output Enable Register	JJ, HH
t _{OEHD}	Data Hold Time for the Output Enable Register	JJ, HH
t _{OECLR2Q}	Asynchronous Clear-to-Q of the Output Enable Register	II, EOUT
t _{OEREMCLR}	Asynchronous Clear Removal Time for the Output Enable Register	II, HH
toerecclr	Asynchronous Clear Recovery Time for the Output Enable Register	II, HH
t _{ICLKQ}	Clock-to-Q of the Input Data Register	AA, EE
t _{ISUD}	Data Setup Time for the Input Data Register	CC, AA
t _{IHD}	Data Hold Time for the Input Data Register	CC, AA
t _{ICLR2Q}	Asynchronous Clear-to-Q of the Input Data Register	DD, EE
t _{IREMCLR}	Asynchronous Clear Removal Time for the Input Data Register	DD, AA
t _{IRECCLR}	Asynchronous Clear Recovery Time for the Input Data Register	DD, AA

Note: *See Figure 2-13 on page 2-43 for more information.

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Input Register

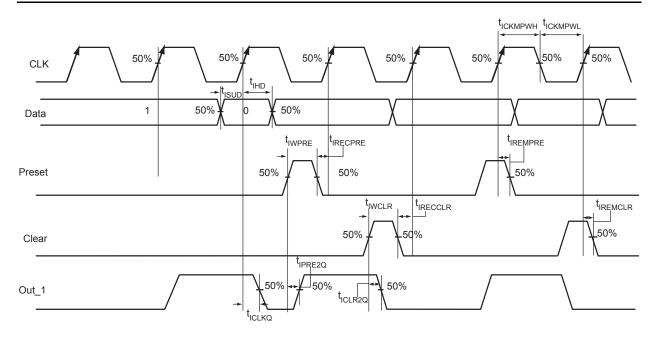


Figure 2-14 • Input Register Timing Diagram

Timing Characteristics

1.5 V DC Core Voltage

Table 2-74 • Input Data Register Propagation Delays

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

Parameter	Description	Std.	Units
t _{ICLKQ}	Clock-to-Q of the Input Data Register	0.41	ns
t _{ISUD}	Data Setup Time for the Input Data Register	0.32	ns
t _{IHD}	Data Hold Time for the Input Data Register	0.00	ns
t _{ICLR2Q}	Asynchronous Clear-to-Q of the Input Data Register	0.57	ns
t _{IPRE2Q}	Asynchronous Preset-to-Q of the Input Data Register	0.57	ns
t _{IREMCLR}	Asynchronous Clear Removal Time for the Input Data Register	0.00	ns
t _{IRECCLR}	Asynchronous Clear Recovery Time for the Input Data Register	0.24	ns
t _{IREMPRE}	Asynchronous Preset Removal Time for the Input Data Register	0.00	ns
t _{IRECPRE}	Asynchronous Preset Recovery Time for the Input Data Register	0.24	ns
t _{IWCLR}	Asynchronous Clear Minimum Pulse Width for the Input Data Register	0.19	ns
t _{IWPRE}	Asynchronous Preset Minimum Pulse Width for the Input Data Register	0.19	ns
t _{ICKMPWH}	Clock Minimum Pulse Width High for the Input Data Register	0.31	ns
t _{ICKMPWL}	Clock Minimum Pulse Width Low for the Input Data Register	0.28	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-75 • Input Data Register Propagation Delays
Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{ICLKQ}	Clock-to-Q of the Input Data Register	0.66	ns
t _{ISUD}	Data Setup Time for the Input Data Register	0.43	ns
t _{IHD}	Data Hold Time for the Input Data Register	0.00	ns
t _{ICLR2Q}	Asynchronous Clear-to-Q of the Input Data Register	0.86	ns
t _{IPRE2Q}	Asynchronous Preset-to-Q of the Input Data Register	0.86	ns
t _{IREMCLR}	Asynchronous Clear Removal Time for the Input Data Register	0.00	ns
t _{IRECCLR}	Asynchronous Clear Recovery Time for the Input Data Register	0.24	ns
t _{IREMPRE}	Asynchronous Preset Removal Time for the Input Data Register	0.00	ns
t _{IRECPRE}	Asynchronous Preset Recovery Time for the Input Data Register	0.24	ns
t _{IWCLR}	Asynchronous Clear Minimum Pulse Width for the Input Data Register	0.19	ns
t _{IWPRE}	Asynchronous Preset Minimum Pulse Width for the Input Data Register	0.19	ns
t _{ICKMPWH}	Clock Minimum Pulse Width High for the Input Data Register	0.31	ns
t _{ICKMPWL}	Clock Minimum Pulse Width Low for the Input Data Register	0.28	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

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Output Register

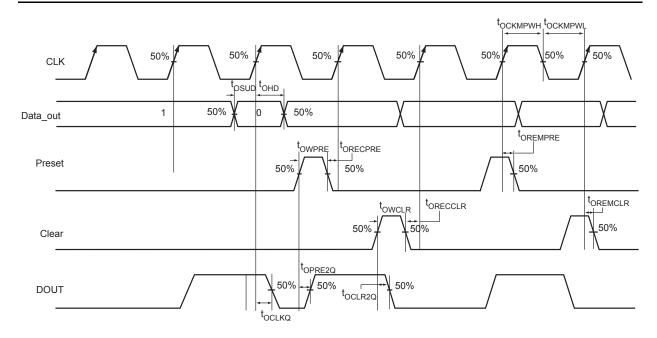


Figure 2-15 • Output Register Timing Diagram

Timing Characteristics

1.5 V DC Core Voltage

Table 2-76 • Output Data Register Propagation Delays
Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

Parameter	Description	Std.	Units
t _{OCLKQ}	Clock-to-Q of the Output Data Register	0.66	ns
tosud	Data Setup Time for the Output Data Register	0.33	ns
t _{OHD}	Data Hold Time for the Output Data Register	0.00	ns
t _{OCLR2Q}	Asynchronous Clear-to-Q of the Output Data Register	0.82	ns
t _{OPRE2Q}	Asynchronous Preset-to-Q of the Output Data Register	0.88	ns
t _{OREMCLR}	Asynchronous Clear Removal Time for the Output Data Register	0.00	ns
torecclr	Asynchronous Clear Recovery Time for the Output Data Register	0.24	ns
t _{OREMPRE}	Asynchronous Preset Removal Time for the Output Data Register	0.00	ns
t _{ORECPRE}	Asynchronous Preset Recovery Time for the Output Data Register	0.24	ns
towclr	Asynchronous Clear Minimum Pulse Width for the Output Data Register	0.19	ns
t _{OWPRE}	Asynchronous Preset Minimum Pulse Width for the Output Data Register	0.19	ns
t _{OCKMPWH}	Clock Minimum Pulse Width High for the Output Data Register	0.31	ns
t _{OCKMPWL}	Clock Minimum Pulse Width Low for the Output Data Register	0.28	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-77 • Output Data Register Propagation Delays
Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{OCLKQ}	Clock-to-Q of the Output Data Register	1.03	ns
tosup	Data Setup Time for the Output Data Register	0.52	ns
t _{OHD}	Data Hold Time for the Output Data Register	0.00	ns
t _{OCLR2Q}	Asynchronous Clear-to-Q of the Output Data Register	1.22	ns
t _{OPRE2Q}	Asynchronous Preset-to-Q of the Output Data Register	1.31	ns
toremclr	Asynchronous Clear Removal Time for the Output Data Register	0.00	ns
torecclr	Asynchronous Clear Recovery Time for the Output Data Register	0.24	ns
t _{OREMPRE}	Asynchronous Preset Removal Time for the Output Data Register	0.00	ns
torecpre	Asynchronous Preset Recovery Time for the Output Data Register	0.24	ns
towclr	Asynchronous Clear Minimum Pulse Width for the Output Data Register	0.19	ns
t _{OWPRE}	Asynchronous Preset Minimum Pulse Width for the Output Data Register	0.19	ns
tockmpwh	Clock Minimum Pulse Width High for the Output Data Register	0.31	ns
tockmpwl	Clock Minimum Pulse Width Low for the Output Data Register	0.28	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

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Output Enable Register

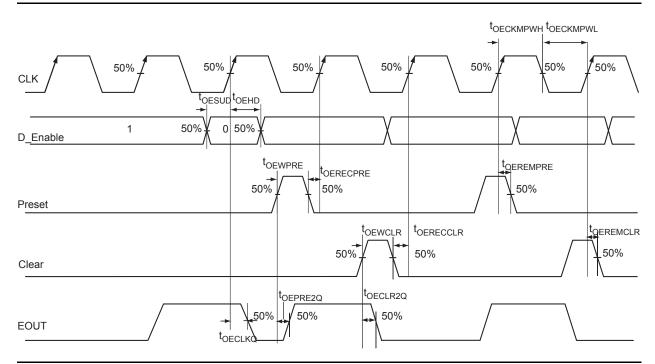


Figure 2-16 • Output Enable Register Timing Diagram

Timing Characteristics

1.5 V DC Core Voltage

Table 2-78 • Output Enable Register Propagation Delays

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

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Asynchronous Preset Minimum Pulse Width for the Output Enable Register 0.19	ns
OEWPRE 1. 1971-1911-1911-1911-1911-1911-1911-1911	ns
t _{OECKMPWH} Clock Minimum Pulse Width High for the Output Enable Register 0.31	ns
t _{OECKMPWL} Clock Minimum Pulse Width Low for the Output Enable Register 0.28	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-79 • Output Enable Register Propagation Delays Commercial-Case Conditions: $T_J = 70^{\circ}\text{C}$, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{OECLKQ}	Clock-to-Q of the Output Enable Register	1.06	ns
t _{OESUD}	Data Setup Time for the Output Enable Register	0.52	ns
t _{OEHD}	Data Hold Time for the Output Enable Register	0.00	ns
t _{OECLR2Q}	Asynchronous Clear-to-Q of the Output Enable Register	1.25	ns
t _{OEPRE2Q}	Asynchronous Preset-to-Q of the Output Enable Register	1.36	ns
t _{OEREMCLR}	Asynchronous Clear Removal Time for the Output Enable Register	0.00	ns
toerecclr	Asynchronous Clear Recovery Time for the Output Enable Register	0.24	ns
t _{OEREMPRE}	Asynchronous Preset Removal Time for the Output Enable Register	0.00	ns
t _{OERECPRE}	Asynchronous Preset Recovery Time for the Output Enable Register	0.24	ns
t _{OEWCLR}	Asynchronous Clear Minimum Pulse Width for the Output Enable Register	0.19	ns
t _{OEWPRE}	Asynchronous Preset Minimum Pulse Width for the Output Enable Register	0.19	ns
t _{OECKMPWH}	Clock Minimum Pulse Width High for the Output Enable Register	0.31	ns
t _{OECKMPWL}	Clock Minimum Pulse Width Low for the Output Enable Register	0.28	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

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VersaTile Characteristics

VersaTile Specifications as a Combinatorial Module

The IGLOO PLUS library offers all combinations of LUT-3 combinatorial functions. In this section, timing characteristics are presented for a sample of the library. For more details, refer to the *Fusion, IGLOO/e, and ProASIC3/ E Macro Library Guide*.

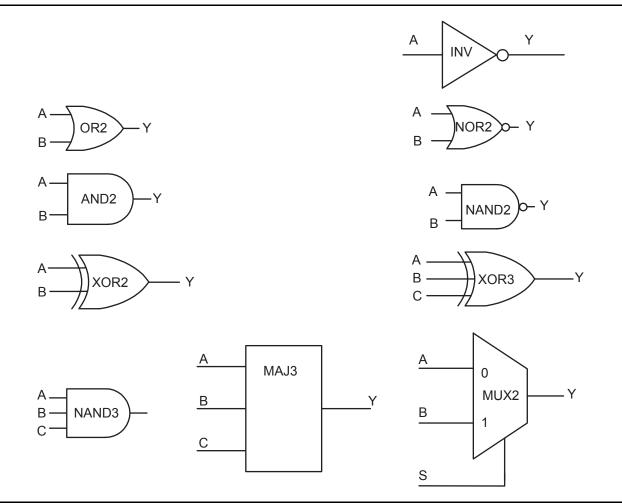


Figure 2-17 • Sample of Combinatorial Cells

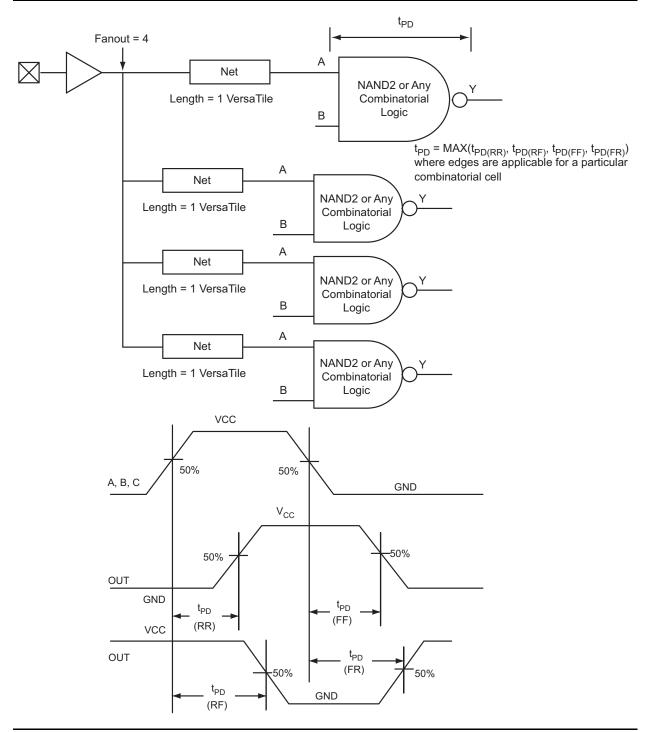


Figure 2-18 • Timing Model and Waveforms

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Timing Characteristics 1.5 V DC Core Voltage

Table 2-80 • Combinatorial Cell Propagation Delays Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

Combinatorial Cell	Equation	Parameter	Std.	Units
INV	Y = !A	t _{PD}	0.72	ns
AND2	Y = A · B	t _{PD}	0.86	ns
NAND2	Y = !(A · B)	t _{PD}	1.00	ns
OR2	Y = A + B	t _{PD}	1.26	ns
NOR2	Y = !(A + B)	t _{PD}	1.16	ns
XOR2	Y = A ⊕ B	t _{PD}	1.46	ns
MAJ3	Y = MAJ(A, B, C)	t _{PD}	1.47	ns
XOR3	Y = A ⊕ B ⊕ C	t _{PD}	2.12	ns
MUX2	Y = A !S + B S	t _{PD}	1.24	ns
AND3	$Y = A \cdot B \cdot C$	t _{PD}	1.40	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-81 • Combinatorial Cell Propagation Delays

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V

Combinatorial Cell	Equation	Parameter	Std.	Units
INV	Y = !A	t _{PD}	1.26	ns
AND2	Y = A · B	t _{PD}	1.46	ns
NAND2	Y = !(A · B)	t _{PD}	1.78	ns
OR2	Y = A + B	t _{PD}	2.47	ns
NOR2	Y = !(A + B)	t _{PD}	2.17	ns
XOR2	Y = A ⊕ B	t _{PD}	2.62	ns
MAJ3	Y = MAJ(A, B, C)	t _{PD}	2.66	ns
XOR3	Y = A ⊕ B ⊕ C	t _{PD}	3.77	ns
MUX2	Y = A !S + B S	t _{PD}	2.20	ns
AND3	$Y = A \cdot B \cdot C$	t _{PD}	2.49	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.



VersaTile Specifications as a Sequential Module

The IGLOO PLUS library offers a wide variety of sequential cells, including flip-flops and latches. Each has a data input and optional enable, clear, or preset. In this section, timing characteristics are presented for a representative sample from the library. For more details, refer to the *Fusion, IGLOO/e, and ProASIC3/E Macro Library Guide*.

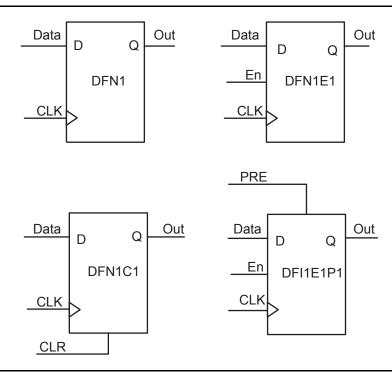


Figure 2-19 • Sample of Sequential Cells

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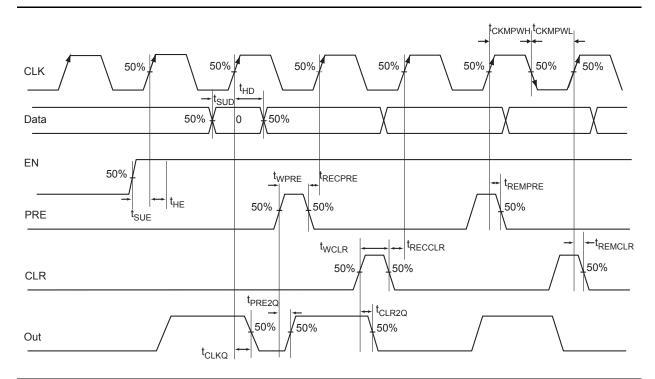


Figure 2-20 • Timing Model and Waveforms

Timing Characteristics 1.5 V DC Core Voltage

Table 2-82 • Register Delays Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

Parameter	Description	Std.	Units
t _{CLKQ}	Clock-to-Q of the Core Register	0.89	ns
t _{SUD}	Data Setup Time for the Core Register	0.81	ns
t _{HD}	Data Hold Time for the Core Register	0.00	ns
t _{SUE}	Enable Setup Time for the Core Register	0.73	ns
t _{HE}	Enable Hold Time for the Core Register	0.00	ns
t _{CLR2Q}	Asynchronous Clear-to-Q of the Core Register	0.60	ns
t _{PRE2Q}	Asynchronous Preset-to-Q of the Core Register	0.62	ns
t _{REMCLR}	Asynchronous Clear Removal Time for the Core Register	0.00	ns
t _{RECCLR}	Asynchronous Clear Recovery Time for the Core Register	0.24	ns
t _{REMPRE}	Asynchronous Preset Removal Time for the Core Register	0.00	ns
t _{RECPRE}	Asynchronous Preset Recovery Time for the Core Register	0.23	ns
t _{WCLR}	Asynchronous Clear Minimum Pulse Width for the Core Register	0.30	ns
t _{WPRE}	Asynchronous Preset Minimum Pulse Width for the Core Register	0.30	ns
t _{CKMPWH}	Clock Minimum Pulse Width High for the Core Register	0.56	ns
t _{CKMPWL}	Clock Minimum Pulse Width Low for the Core Register	0.56	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-83 • Register Delays

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{CLKQ}	Clock-to-Q of the Core Register	1.61	ns
t _{SUD}	Data Setup Time for the Core Register	1.17	ns
t _{HD}	Data Hold Time for the Core Register	0.00	ns
t _{SUE}	Enable Setup Time for the Core Register	1.29	ns
t _{HE}	Enable Hold Time for the Core Register	0.00	ns
t _{CLR2Q}	Asynchronous Clear-to-Q of the Core Register	0.87	ns
t _{PRE2Q}	Asynchronous Preset-to-Q of the Core Register	0.89	ns
t _{REMCLR}	Asynchronous Clear Removal Time for the Core Register	0.00	ns
t _{RECCLR}	Asynchronous Clear Recovery Time for the Core Register	0.24	ns
t _{REMPRE}	Asynchronous Preset Removal Time for the Core Register	0.00	ns
t _{RECPRE}	Asynchronous Preset Recovery Time for the Core Register	0.24	ns
t _{WCLR}	Asynchronous Clear Minimum Pulse Width for the Core Register	0.46	ns
t _{WPRE}	Asynchronous Preset Minimum Pulse Width for the Core Register	0.46	ns
t _{CKMPWH}	Clock Minimum Pulse Width High for the Core Register	0.95	ns
t _{CKMPWL}	Clock Minimum Pulse Width Low for the Core Register	0.95	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

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Global Resource Characteristics

AGLP125 Clock Tree Topology

Clock delays are device-specific. Figure 2-21 is an example of a global tree used for clock routing. The global tree presented in Figure 2-21 is driven by a CCC located on the west side of the AGLP125 device. It is used to drive all D-flip-flops in the device.

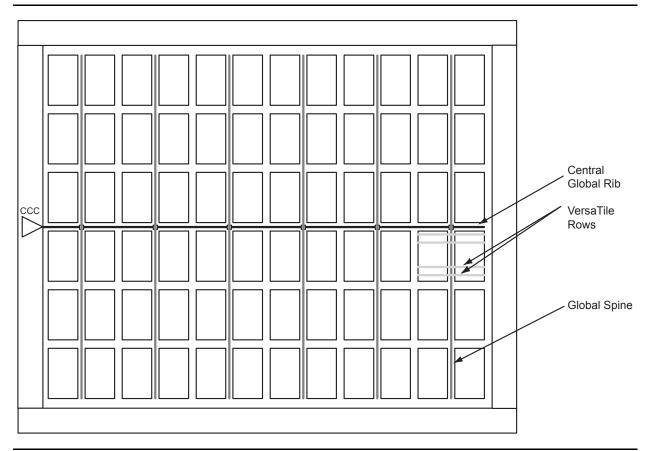


Figure 2-21 • Example of Global Tree Use in an AGLP125 Device for Clock Routing



Global Tree Timing Characteristics

Global clock delays include the central rib delay, the spine delay, and the row delay. Delays do not include I/O input buffer clock delays, as these are I/O standard–dependent, and the clock may be driven and conditioned internally by the CCC module. For more details on clock conditioning capabilities, refer to the "Clock Conditioning Circuits" section on page 2-61. Table 2-84 to Table 2-89 on page 2-60 present minimum and maximum global clock delays within each device. Minimum and maximum delays are measured with minimum and maximum loading.

Timing Characteristics

1.5 V DC Core Voltage

Table 2-84 • AGLP030 Global Resource

Commercial-Case Conditions: T_{.I} = 70°C, VCC = 1.425 V

			Std.	
Parameter	Description	Min.	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	1.2	1.42	ns
t _{RCKH}	Input High Delay for Global Clock	1.23	1.49	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.18		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.15		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.27	ns

Notes:

- 1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-85 • AGLP060 Global Resource
Commercial-Case Conditions: T_{,I} = 70°C, VCC = 1.425 V

			Sto	d.	
Parameter	Description	Min	.1	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	1.3	2	1.62	ns
t _{RCKH}	Input High Delay for Global Clock	1.3	4	1.72	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.1	8		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.1	5		ns
t _{RCKSW}	Maximum Skew for Global Clock			0.38	ns

Notes:

- 1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- 2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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Table 2-86 • AGLP125 Global Resource

Commercial-Case Conditions: $T_J = 70^{\circ}C$, VCC = 1.425 V

		5	Std.	
Parameter	Description	Min. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	1.36	1.71	ns
t _{RCKH}	Input High Delay for Global Clock	1.39	1.82	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.18		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.15		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.43	ns

Notes:

- 1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- 2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-87 • AGLP030 Global Resource

Commercial-Case Conditions: T_J = 70°C, VCC = 1.14 V

			Std.		
Parameter	Description	Mir	ո. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	1.8	30	2.09	ns
t _{RCKH}	Input High Delay for Global Clock	1.8	38	2.27	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.4	10		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.0	35		ns
t _{RCKSW}	Maximum Skew for Global Clock			0.39	ns

Notes:

- 1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- 2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.



IGLOO PLUS DC and Switching Characteristics

Table 2-88 • AGLP060 Global Resource

Commercial-Case Conditions: T_J = 70°C, VCC = 1.14 V

		Std.		
Parameter	Description	Min. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	2.02	2.43	ns
t _{RCKH}	Input High Delay for Global Clock	2.09	2.65	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.40		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.65		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.56	ns

Notes:

- Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- 2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

Table 2-89 • AGLP125 Global Resource
Commercial-Case Conditions: T_J = 70°C, VCC = 1.14 V

		Std.		
Parameter	Description	Min. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	2.08	2.54	ns
t _{RCKH}	Input High Delay for Global Clock	2.15	2.77	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.40		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.65		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.62	ns

Notes:

- 1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- 2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

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Clock Conditioning Circuits

CCC Electrical Specifications

Timing Characteristics

Table 2-90 • IGLOO PLUS CCC/PLL Specification For IGLOO PLUS V2 or V5 devices, 1.5 V DC Core Supply Voltage

Min.	Тур.	Max.	Units
1.5		250	MHz
0.75		250	MHz
	360 ³		ps
		32	
		100	MHz
		1	ns
		300	μs
		6.0	ms
		2.5	ns
		1.5	ns
48.5		51.5	%
1.25		15.65	ns
0.469		15.65	ns
	3.5		ns
Maximum Peak-to-Peak Period Jitter ^{7,8,9}			l Jitter ^{7,8,9}
SSO ≤ 2	SSO ≤ 4	SSO ≤ 8	SSO ≤ 16
0.50%	0.60%	0.80%	1.20%
2.50%	4.00%	6.00%	12.00%
	1.5 0.75 48.5 1.25 0.469 Maximu SSO ≤ 2 0.50%	1.5 0.75 360 ³ 48.5 1.25 0.469 3.5 Maximum Peak-to- SSO ≤ 2 SSO ≤ 4 0.50% 0.60%	1.5 250 0.75 250 360^3 32 100 1 300 6.0 2.5 1.5 48.5 51.5 1.25 15.65 0.469 15.65 3.5 Maximum Peak-to-Peak Period SSO ≤ 2 SSO ≤ 4 SSO ≤ 8 0.50% 0.60% 0.80%

Notes:

- 1. This delay is a function of voltage and temperature. See Table 2-6 on page 2-6 and Table 2-7 on page 2-6 for deratings.
- 2. $T_J = 25^{\circ}C$, VCC = 1.5 V
- 3. When the CCC/PLL core is generated by Microsemi core generator software, not all delay values of the specified delay increments are available. Refer to the Libero SoC Online Help associated with the core for more information.
- 4. Maximum value obtained for a STD speed grade device in Worst Case Commercial Conditions. For specific junction temperature and voltage supply, refer to Table 2-6 on page 2-6 and Table 2-7 on page 2-6 for derating values.
- 5. The AGLP030 device does not support a PLL.
- 6. Tracking jitter is defined as the variation in clock edge position of PLL outputs with reference to the PLL input clock edge. Tracking jitter does not measure the variation in PLL output period, which is covered by the period jitter parameter.
- 7. VCO output jitter is calculated as a percentage of the VCO frequency. The jitter (in ps) can be calculated by multiplying the VCO period by the per cent jitter. The VCO jitter (in ps) applies to CCC_OUT regardless of the output divider settings. For example, if the jitter on VCO is 300 ps, the jitter on CCC_OUT is also 300 ps, regardless of the output divider settings.
- 8. Measurements done with LVTTL 3.3 V 8 mA I/O drive strength and high slew rate, VCC/VCCPLL = 1.425 V, VCCI = 3.3 V, VQ/PQ/TQ type of packages, 20 pF load.
- 9. SSO are outputs that are synchronous to a single clock domain and have clock-to-out times that are within ±200 ps of each other. Switching I/Os are placed outside of the PLL bank. Refer to the "Simultaneously Switching Outputs (SSOs) and Printed Circuit Board Layout" section in the IGLOO PLUS FPGA Fabric User's Guide.



IGLOO PLUS DC and Switching Characteristics

Table 2-91 • IGLOO PLUS CCC/PLL Specification
For IGLOO PLUS V2 Devices, 1.2 V DC Core Supply Voltage

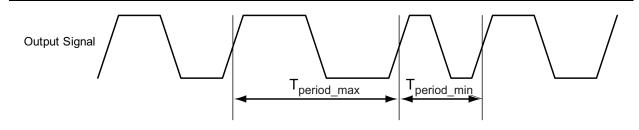
Parameter	Min.	Тур.	Max.	Units
Clock Conditioning Circuitry Input Frequency f _{IN_CCC}	1.5		160	MHz
Clock Conditioning Circuitry Output Frequency f _{OUT_CCC}	0.75		160	MHz
Delay Increments in Programmable Delay Blocks ^{1, 2}		580 ³		ps
Number of Programmable Values in Each Programmable Delay Block			32	
Serial Clock (SCLK) for Dynamic PLL ^{4,5}			60	MHz
Input Cycle-to-Cycle Jitter (peak magnitude)			.25	ns
Acquisition Time				
LockControl = 0			300	μs
LockControl = 1			6.0	ms
Tracking Jitter ⁶				
LockControl = 0			4	ns
LockControl = 1			3	ns
Output Duty Cycle	48.5		51.5	%
Delay Range in Block: Programmable Delay 1 ^{1, 2}	2.3		20.86	ns
Delay Range in Block: Programmable Delay 2 ^{1, 2}	0.863		20.86	ns
Delay Range in Block: Fixed Delay ^{1, 2}		5.7		ns
/CO Output Peak-to-Peak Period Jitter F _{CCC_OUT} ⁷ Maximum Peak-to-Peak Pe		Peak Period	Jitter ^{7,8,9}	
	SSO ≤ 2	SSO ≤ 4	SSO ≤ 8	SSO ≤ 16
0.75 MHz to 50 MHz	0.50%	1.20%	2.00%	3.00%
50 MHz to 160 MHz	2.50%	5.00%	7.00%	15.00%

Notes:

- 1. This delay is a function of voltage and temperature. See Table 2-6 on page 2-6 and Table 2-7 on page 2-6 for deratings.
- 2. $T_{.J} = 25^{\circ}C$, VCC = 1.2 V
- 3. When the CCC/PLL core is generated by Microsemi core generator software, not all delay values of the specified delay increments are available. Refer to the online help associated with the core for more information.
- 4. Maximum value obtained for a STD speed grade device in Worst Case Commercial Conditions. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 and Table 2-7 on page 2-6 for derating values.
- 5. The AGLP030 device does not support PLL.
- 6. Tracking jitter is defined as the variation in clock edge position of PLL outputs with reference to PLL input clock edge. Tracking jitter does not measure the variation in PLL output period, which is covered by period jitter parameter.
- 7. VCO output jitter is calculated as a percentage of the VCO frequency. The jitter (in ps) can be calculated by multiplying the VCO period by the per cent jitter. The VCO jitter (in ps) applies to CCC_OUT regardless of the output divider settings. For example, if the jitter on VCO is 300 ps, the jitter on CCC_OUT is also 300 ps, regardless of the output divider settings.
- 8. Measurements are done with LVTTL 3.3 V, 8 mA, I/O drive strength and high slew rate. VCC/VCCPLL = 1.14 V, VCCI = 3.3 V, VQ/PQ/TQ type of packages, 20 pF load.
- 9. SSO are outputs that are synchronous to a single clock domain, and have their clock-to-out times within ±200 ps of each other. Switching I/Os are placed outside of the PLL bank. Refer to the "Simultaneously Switching Outputs (SSOs) and Printed Circuit Board Layout" section in the IGLOO PLUS FPGA Fabric User's Guide

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Note: Peak-to-peak jitter measurements are defined by $T_{peak-to-peak} = T_{period_max} - T_{period_min}$

Figure 2-22 • Peak-to-Peak Jitter Definition

Embedded SRAM and FIFO Characteristics

SRAM

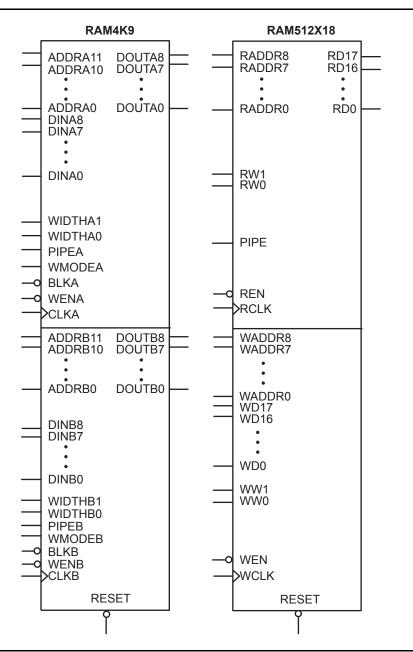


Figure 2-23 • RAM Models

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Timing Waveforms

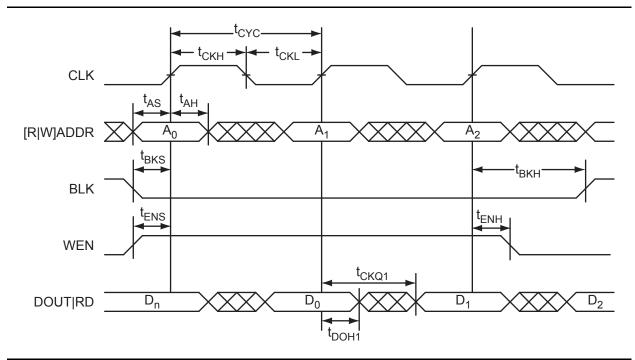


Figure 2-24 • RAM Read for Pass-Through Output. Applicable to Both RAM4K9 and RAM512x18.

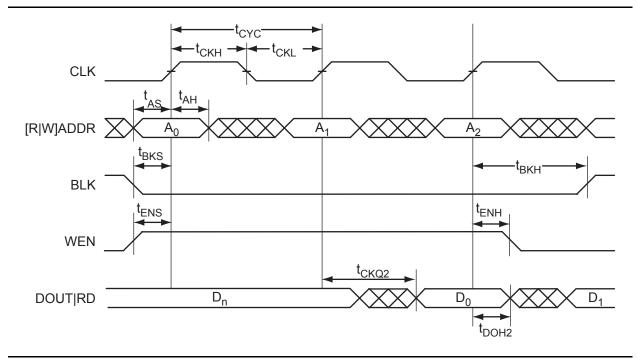


Figure 2-25 • RAM Read for Pipelined Output. Applicable to Both RAM4K9 and RAM512x18.

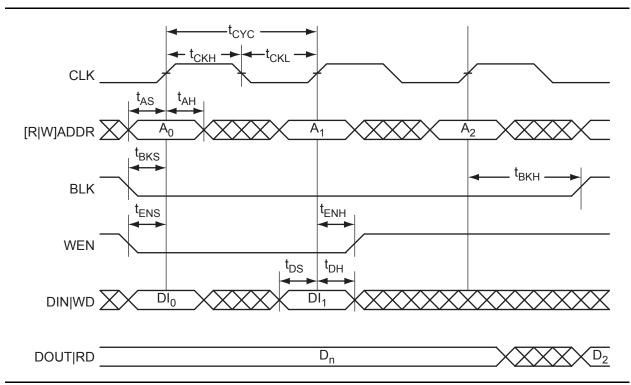


Figure 2-26 • RAM Write, Output Retained. Applicable to Both RAM4K9 and RAM512x18.

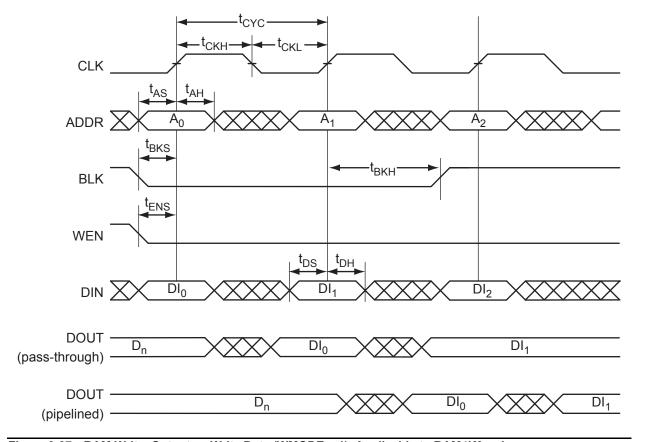


Figure 2-27 • RAM Write, Output as Write Data (WMODE = 1). Applicable to RAM4K9 only.

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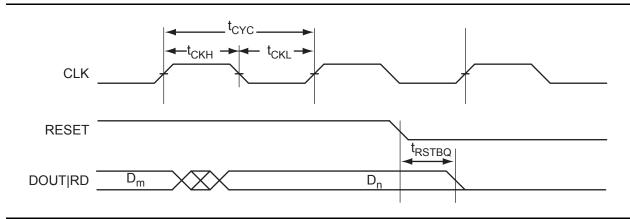


Figure 2-28 • RAM Reset



IGLOO PLUS DC and Switching Characteristics

Timing Characteristics 1.5 V DC Core Voltage

Table 2-92 • RAM4K9

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

Parameter	Description	Std.	Units
t _{AS}	Address setup time	0.69	ns
t _{AH}	Address hold time	0.13	ns
t _{ENS}	REN, WEN setup time	0.68	ns
t _{ENH}	REN, WEN hold time	0.13	ns
t _{BKS}	BLK setup time	1.37	ns
t _{BKH}	BLK hold time	0.13	ns
t _{DS}	Input data (DIN) setup time	0.59	ns
t _{DH}	Input data (DIN) hold time	0.30	ns
t _{CKQ1}	Clock High to new data valid on DOUT (output retained, WMODE = 0)	2.94	ns
	Clock High to new data valid on DOUT (flow-through, WMODE = 1)	2.55	ns
t _{CKQ2}	Clock High to new data valid on DOUT (pipelined)	1.51	ns
t _{C2CWWL} 1	Address collision clk-to-clk delay for reliable write after write on same address – applicable to closing edge	0.29	ns
t _{C2CRWH} 1	Address collision clk-to-clk delay for reliable read access after write on same address – applicable to opening edge	0.24	ns
t _{C2CWRH} 1	Address collision clk-to-clk delay for reliable write access after read on same address – applicable to opening edge	0.40	ns
t _{RSTBQ}	RESET Low to data out Low on DOUT (flow-through)	1.72	ns
	RESET Low to data out Low on DOUT (pipelined)	1.72	ns
t _{REMRSTB}	RESET removal	0.51	ns
t _{RECRSTB}	RESET recovery	2.68	ns
t _{MPWRSTB}	RESET minimum pulse width	0.68	ns
t _{CYC}	Clock cycle time	6.24	ns
F _{MAX}	Maximum frequency	160	MHz

Notes:

- For more information, refer to the application note Simultaneous Read-Write Operations in Dual-Port SRAM for Flash-Based cSoCs and FPGAs.
- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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Table 2-93 • RAM512X18 Commercial-Case Conditions: $T_J = 70$ °C, Worst-Case VCC = 1.425 V

Parameter	Description	Std.	Units
t _{AS}	Address setup time	0.69	ns
t _{AH}	Address hold time	0.13	ns
t _{ENS}	REN, WEN setup time	0.61	ns
t _{ENH}	REN, WEN hold time	0.07	ns
t _{DS}	Input data (WD) setup time	0.59	ns
t _{DH}	Input data (WD) hold time	0.30	ns
t _{CKQ1}	Clock High to new data valid on RD (output retained)	3.51	ns
t _{CKQ2}	Clock High to new data valid on RD (pipelined)	1.43	ns
t _{C2CRWH} 1	Address collision clk-to-clk delay for reliable read access after write on same address – applicable to opening edge	0.21	ns
t _{C2CWRH} 1	Address collision clk-to-clk delay for reliable write access after read on same address – applicable to opening edge	0.25	ns
t _{RSTBQ}	RESET Low to data out Low on RD (flow-through)	1.72	ns
	RESET Low to data out Low on RD (pipelined)	1.72	ns
t _{REMRSTB}	RESET removal	0.51	ns
t _{RECRSTB}	RESET recovery	2.68	ns
t _{MPWRSTB}	RESET minimum pulse width	0.68	ns
t _{CYC}	Clock cycle time	6.24	ns
F _{MAX}	Maximum frequency	160	MHz

Notes:

- 1. For more information, refer to the application note Simultaneous Read-Write Operations in Dual-Port SRAM for Flash-Based cSoCs and FPGAs.
- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.



IGLOO PLUS DC and Switching Characteristics

1.2 V DC Core Voltage

Table 2-94 • RAM4K9

Commercial-Case Conditions: $T_J = 70^{\circ}C$, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{AS}	Address setup time	1.28	ns
t _{AH}	Address hold time	0.25	ns
t _{ENS}	REN, WEN setup time		ns
t _{ENH}	REN, WEN hold time	0.25	ns
t _{BKS}	BLK setup time	2.54	ns
t _{BKH}	BLK hold time	0.25	ns
t _{DS}	Input data (DIN) setup time	1.10	ns
t _{DH}	Input data (DIN) hold time	0.55	ns
t _{CKQ1}	Clock High to new data valid on DOUT (output retained, WMODE = 0)	5.51	ns
	Clock High to new data valid on DOUT (flow-through, WMODE = 1)	4.77	ns
t _{CKQ2}	Clock High to new data valid on DOUT (pipelined)	2.82	ns
t _{C2CWWL} 1	Address collision clk-to-clk delay for reliable write after write on same address – applicable to closing edge		ns
t _{C2CRWH} 1	Address collision clk-to-clk delay for reliable read access after write on same address – applicable to opening edge	0.32	ns
t _{C2CWRH} 1	Address collision clk-to-clk delay for reliable write access after read on same address – applicable to opening edge	0.44	ns
t _{RSTBQ}	RESET Low to data out Low on DOUT (flow-through)	3.21	ns
	RESET Low to data out Low on DOUT (pipelined)	3.21	ns
t _{REMRSTB}	RESET removal	0.93	ns
t _{RECRSTB}	RESET recovery	4.94	ns
t _{MPWRSTB}	RESET minimum pulse width	1.18	ns
t _{CYC}	Clock cycle time	10.90	ns
F _{MAX}	Maximum frequency	92	MHz

Notes:

2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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For more information, refer to the application note Simultaneous Read-Write Operations in Dual-Port SRAM for Flash-Based cSoCs and FPGAs.



Table 2-95 • RAM512X18 Commercial-Case Conditions: $T_J = 70^{\circ}\text{C}$, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{AS}	Address setup time	1.28	ns
t _{AH}	Address hold time	0.25	ns
t _{ENS}	REN, WEN setup time	1.13	ns
t _{ENH}	REN, WEN hold time	0.13	ns
t _{DS}	Input data (WD) setup time	1.10	ns
t _{DH}	Input data (WD) hold time	0.55	ns
t _{CKQ1}	Clock High to new data valid on RD (output retained)	6.56	ns
t _{CKQ2}	Clock High to new data valid on RD (pipelined)	2.67	ns
t _{C2CRWH} 1	Address collision clk-to-clk delay for reliable read access after write on same address – applicable to opening edge	0.29	ns
t _{C2CWRH} 1	Address collision clk-to-clk delay for reliable write access after read on same address – applicable to opening edge		ns
t _{RSTBQ}	RESET Low to data out Low on RD (flow through)	3.21	ns
	RESET Low to data out Low on RD (pipelined)	3.21	ns
t _{REMRSTB}	RESET removal	0.93	ns
t _{RECRSTB}	RESET recovery	4.94	ns
t _{MPWRSTB}	RESET minimum pulse width	1.18	ns
t _{CYC}	Clock cycle time	10.90	ns
F _{MAX}	Maximum frequency	92	MHz

Notes:

- 1. For more information, refer to the application note Simultaneous Read-Write Operations in Dual-Port SRAM for Flash-Based cSoCs and FPGAs.
- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.



FIFO

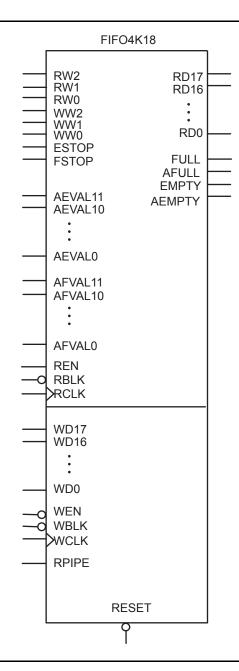


Figure 2-29 • FIFO Model

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Timing Waveforms

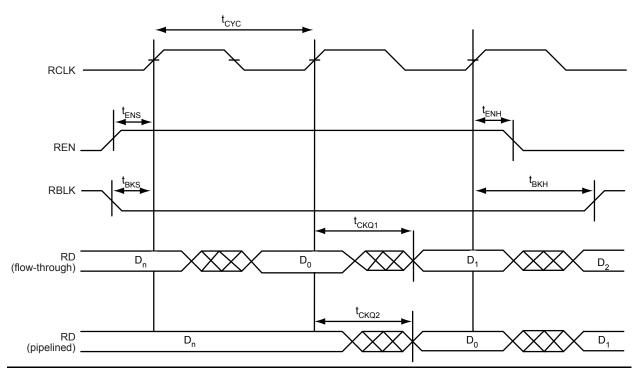


Figure 2-30 • FIFO Read

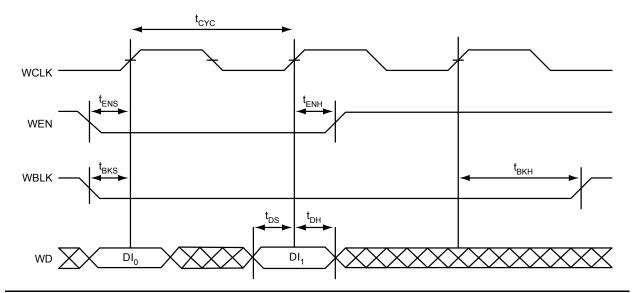


Figure 2-31 • FIFO Write



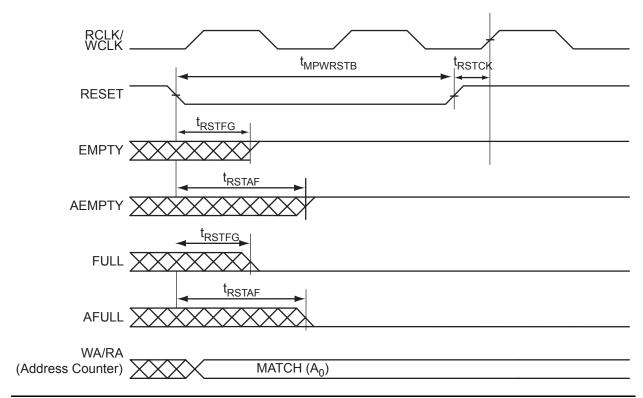


Figure 2-32 • FIFO Reset

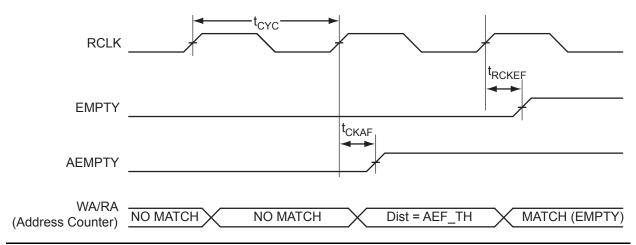


Figure 2-33 • FIFO EMPTY Flag and AEMPTY Flag Assertion

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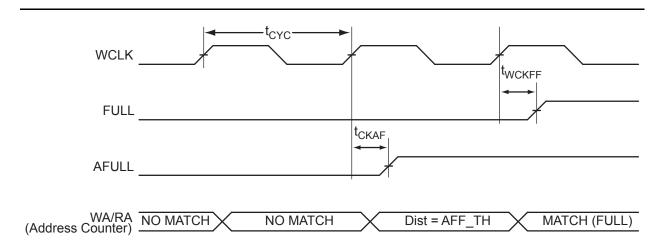


Figure 2-34 • FIFO FULL Flag and AFULL Flag Assertion

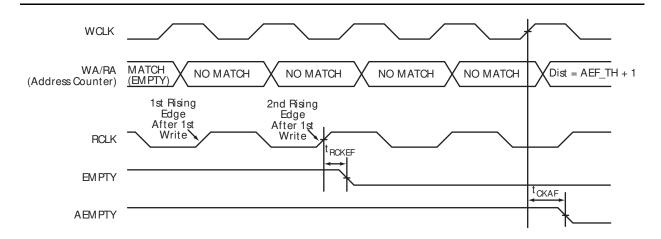


Figure 2-35 • FIFO EMPTY Flag and AEMPTY Flag Deassertion

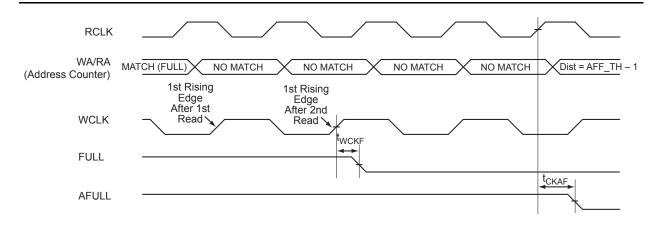


Figure 2-36 • FIFO FULL Flag and AFULL Flag Deassertion



IGLOO PLUS DC and Switching Characteristics

Timing Characteristics 1.5 V DC Core Voltage

Table 2-96 • FIFO

Worst Commercial-Case Conditions: $T_J = 70$ °C, VCC = 1.425 V

Parameter	Description	Std.	Units
t _{ENS}	REN, WEN Setup Time	1.66	ns
t _{ENH}	REN, WEN Hold Time	0.13	ns
t _{BKS}	BLK Setup Time	0.30	ns
t _{BKH}	BLK Hold Time	0.00	ns
t _{DS}	Input Data (WD) Setup Time	0.63	ns
t _{DH}	Input Data (WD) Hold Time	0.20	ns
t _{CKQ1}	Clock High to New Data Valid on RD (flow-through)	2.77	ns
t _{CKQ2}	Clock High to New Data Valid on RD (pipelined)	1.50	ns
t _{RCKEF}	RCLK High to Empty Flag Valid	2.94	ns
t _{WCKFF}	WCLK High to Full Flag Valid	2.79	ns
t _{CKAF}	Clock High to Almost Empty/Full Flag Valid	10.71	ns
t _{RSTFG}	RESET Low to Empty/Full Flag Valid	2.90	ns
t _{RSTAF}	RESET Low to Almost Empty/Full Flag Valid	10.60	ns
t _{RSTBQ}	RESET Low to Data Out Low on RD (flow-through)	1.68	ns
	RESET Low to Data Out Low on RD (pipelined)	1.68	ns
t _{REMRSTB}	RESET Removal	0.51	ns
t _{RECRSTB}	RESET Recovery	2.68	ns
t _{MPWRSTB}	RESET Minimum Pulse Width	0.68	ns
t _{CYC}	Clock Cycle Time	6.24	ns
F _{MAX}	Maximum Frequency for FIFO	160	MHz

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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1.2 V DC Core Voltage

Table 2-97 • FIFO

Worst Commercial-Case Conditions: $T_J = 70$ °C, VCC = 1.14 V

Parameter	Description	Std.	Units
t _{ENS}	REN, WEN Setup Time	3.44	ns
t _{ENH}	REN, WEN Hold Time	0.26	ns
t _{BKS}	BLK Setup Time	0.30	ns
t _{BKH}	BLK Hold Time	0.00	ns
t _{DS}	Input Data (WD) Setup Time	1.30	ns
t _{DH}	Input Data (WD) Hold Time	0.41	ns
t _{CKQ1}	Clock High to New Data Valid on RD (flow-through)	5.67	ns
t _{CKQ2}	Clock High to New Data Valid on RD (pipelined)	3.02	ns
t _{RCKEF}	RCLK High to Empty Flag Valid	6.02	ns
t _{WCKFF}	WCLK High to Full Flag Valid	5.71	ns
t _{CKAF}	Clock High to Almost Empty/Full Flag Valid	22.17	ns
t _{RSTFG}	RESET Low to Empty/Full Flag Valid	5.93	ns
t _{RSTAF}	RESET Low to Almost Empty/Full Flag Valid	21.94	ns
t _{RSTBQ}	RESET Low to Data Out Low on RD (flow-through)	3.41	ns
	RESET Low to Data Out Low on RD (pipelined)	3.41	ns
t _{REMRSTB}	RESET Removal	1.02	ns
t _{RECRSTB}	RESET Recovery	5.48	ns
t _{MPWRSTB}	RESET Minimum Pulse Width	1.18	ns
t _{CYC}	Clock Cycle Time	10.90	ns
F _{MAX}	Maximum Frequency for FIFO	92	MHz

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.



Embedded FlashROM Characteristics

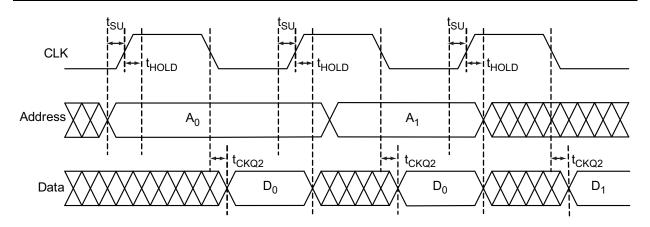


Figure 2-37 • Timing Diagram

Timing Characteristics

1.5 V DC Core Voltage

Table 2-98 • Embedded FlashROM Access Time Worst Commercial-Case Conditions: $T_J = 70$ °C, VCC = 1.425 V

Parameter	Description	Std.	Units
t _{SU}	Address Setup Time	0.57	ns
t _{HOLD}	Address Hold Time	0.00	ns
t _{CK2Q}	Clock to Out	17.58	ns
F _{MAX}	Maximum Clock Frequency	15	MHz

1.2 V DC Core Voltage

Table 2-99 • Embedded FlashROM Access Time Worst Commercial-Case Conditions: $T_J = 70^{\circ}C$, VCC = 1.14 V

Parameter	Description	Std.	Units
t _{SU}	Address Setup Time	0.59	ns
t _{HOLD}	Address Hold Time	0.00	ns
t _{CK2Q}	Clock to Out	30.94	ns
F _{MAX}	Maximum Clock Frequency	10	MHz

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JTAG 1532 Characteristics

JTAG timing delays do not include JTAG I/Os. To obtain complete JTAG timing, add I/O buffer delays to the corresponding standard selected; refer to the I/O timing characteristics in the "User I/O Characteristics" section on page 2-15 for more details.

Timing Characteristics

1.5 V DC Core Voltage

Table 2-100 • JTAG 1532

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V

Parameter	Description		Std.	Units
t _{DISU}	Test Data Input Setup Time		1.00	ns
t _{DIHD}	Test Data Input Hold Time		2.00	ns
t _{TMSSU}	Test Mode Select Setup Time		1.00	ns
t _{TMDHD}	Test Mode Select Hold Time		2.00	ns
t _{TCK2Q}	Clock to Q (data out)		8.00	ns
t _{RSTB2Q}	Reset to Q (data out)	Reset to Q (data out)		ns
F _{TCKMAX}	TCK Maximum Frequency		15	MHz
t _{TRSTREM}	ResetB Removal Time		0.58	ns
t _{TRSTREC}	ResetB Recovery Time	ResetB Recovery Time		ns
t _{TRSTMPW}	ResetB Minimum Pulse TBD		ns	

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

1.2 V DC Core Voltage

Table 2-101 • JTAG 1532

Commercial-Case Conditions: $T_J = 70$ °C, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{DISU}	Test Data Input Setup Time	1.50	ns
t _{DIHD}	Test Data Input Hold Time	3.00	ns
t _{TMSSU}	Test Mode Select Setup Time	1.50	ns
t _{TMDHD}	Test Mode Select Hold Time	3.00	ns
t _{TCK2Q}	Clock to Q (data out)	11.00	ns
t _{RSTB2Q}	Reset to Q (data out)	30.00	ns
F _{TCKMAX}	TCK Maximum Frequency	9.00	MHz
t _{TRSTREM}	ResetB Removal Time	1.18	ns
t _{TRSTREC}	ResetB Recovery Time	0.00	ns
t _{TRSTMPW}	ResetB Minimum Pulse	TBD	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.



3 - Pin Descriptions and Packaging

Supply Pins

GND Ground

Ground supply voltage to the core, I/O outputs, and I/O logic.

GNDQ Ground (quiet)

Quiet ground supply voltage to input buffers of I/O banks. Within the package, the GNDQ plane is decoupled from the simultaneous switching noise originated from the output buffer ground domain. This minimizes the noise transfer within the package and improves input signal integrity. GNDQ must always be connected to GND on the board.

VCC Core Supply Voltage

Supply voltage to the FPGA core, nominally 1.5 V for IGLOO PLUS V5 devices, and 1.2 V or 1.5 V for IGLOO PLUS V2 devices. VCC is required for powering the JTAG state machine in addition to VJTAG. Even when a device is in bypass mode in a JTAG chain of interconnected devices, both VCC and VJTAG must remain powered to allow JTAG signals to pass through the device.

For IGLOO PLUS V2 devices, VCC can be switched dynamically from 1.2 V to 1.5 V or vice versa. This allows in-system programming (ISP) when VCC is at 1.5 V and the benefit of low power operation when VCC is at 1.2 V.

VCCIBx I/O Supply Voltage

Supply voltage to the bank's I/O output buffers and I/O logic. Bx is the I/O bank number. There are four I/O banks on low power flash devices plus a dedicated VJTAG bank. Each bank can have a separate VCCI connection. All I/Os in a bank will run off the same VCCIBx supply. VCCI can be 1.2 V, 1.5 V, 1.8 V, 2.5 V, or 3.3 V, nominal voltage. Unused I/O banks should have their corresponding VCCI pins tied to GND.

VMVx I/O Supply Voltage (quiet)

Quiet supply voltage to the input buffers of each I/O bank. *x* is the bank number. Within the package, the VMV plane biases the input stage of the I/Os in the I/O banks. This minimizes the noise transfer within the package and improves input signal integrity. Each bank must have at least one VMV connection, and no VMV should be left unconnected. All I/Os in a bank run off the same VMVx supply. VMV is used to provide a quiet supply voltage to the input buffers of each I/O bank. VMVx can be 1.2 V, 1.5 V, 1.8 V, 2.5 V, or 3.3 V, nominal voltage. Unused I/O banks should have their corresponding VMV pins tied to GND. VMV and VCCI should be at the same voltage within a given I/O bank. Used VMV pins must be connected to the corresponding VCCI pins of the same bank (i.e., VMV0 to VCCIB0, VMV1 to VCCIB1, etc.).

VCCPLA/B/C/D/E/F PLL Supply Voltage

Supply voltage to analog PLL, nominally 1.5 V or 1.2 V, depending on the device.

- · 1.5 V for IGLOO PLUS V5 devices
- 1.2 V or 1.5 V for IGLOO PLUS V2 devices

When the PLLs are not used, the Microsemi Designer place-and-route tool automatically disables the unused PLLs to lower power consumption. The user should tie unused VCCPLx and VCOMPLx pins to ground. Microsemi recommends tying VCCPLx to VCC and using proper filtering circuits to decouple VCC noise from the PLLs. Refer to the PLL Power Supply Decoupling section of the "Clock Conditioning Circuits in Low Power Flash Devices and Mixed signal FPGAs " chapter of the IGLOO PLUS FPGA Fabric User's Guide for a complete board solution for the PLL analog power supply and ground.

There is one VCCPLF pin on IGLOO PLUS devices.



Pin Descriptions and Packaging

VCOMPLA/B/C/D/E/F PLL Ground

Ground to analog PLL power supplies. When the PLLs are not used, the Designer place-and-route tool automatically disables the unused PLLs to lower power consumption. The user should tie unused VCCPLx and VCOMPLx pins to ground.

There is one VCOMPLF pin on IGLOO PLUS devices.

VJTAG

JTAG Supply Voltage

Low power flash devices have a separate bank for the dedicated JTAG pins. The JTAG pins can be run at any voltage from 1.5 V to 3.3 V (nominal). Isolating the JTAG power supply in a separate I/O bank gives greater flexibility in supply selection and simplifies power supply and PCB design. If the JTAG interface is neither used nor planned for use, the VJTAG pin together with the TRST pin could be tied to GND. It should be noted that VCC is required to be powered for JTAG operation; VJTAG alone is insufficient. If a device is in a JTAG chain of interconnected boards, the board containing the device can be powered down, provided both VJTAG and VCC to the part remain powered; otherwise, JTAG signals will not be able to transition the device, even in bypass mode.

Microsemi recommends that VPUMP and VJTAG power supplies be kept separate with independent filtering capacitors rather than supplying them from a common rail.

VPLIMP

Programming Supply Voltage

IGLOO PLUS devices support single-voltage ISP of the configuration flash and FlashROM. For programming, VPUMP should be 3.3 V nominal. During normal device operation, VPUMP can be left floating or can be tied (pulled up) to any voltage between 0 V and the VPUMP maximum. Programming power supply voltage (VPUMP) range is listed in the datasheet.

When the VPUMP pin is tied to ground, it will shut off the charge pump circuitry, resulting in no sources of oscillation from the charge pump circuitry.

For proper programming, $0.01~\mu F$ and $0.33~\mu F$ capacitors (both rated at 16 V) are to be connected in parallel across VPUMP and GND, and positioned as close to the FPGA pins as possible.

Microsemi recommends that VPUMP and VJTAG power supplies be kept separate with independent filtering capacitors rather than supplying them from a common rail.

User Pins

I/O

User Input/Output

The I/O pin functions as an input, output, tristate, or bidirectional buffer. Input and output signal levels are compatible with the I/O standard selected.

During programming, I/Os become tristated and weakly pulled up to VCCI. With VCCI, VMV, and VCC supplies continuously powered up, when the device transitions from programming to operating mode, the I/Os are instantly configured to the desired user configuration.

Unused I/Os are configured as follows:

- Output buffer is disabled (with tristate value of high impedance)
- · Input buffer is disabled (with tristate value of high impedance)
- · Weak pull-up is programmed

GL

Globals

GL I/Os have access to certain clock conditioning circuitry (and the PLL) and/or have direct access to the global network (spines). Additionally, the global I/Os can be used as regular I/Os, since they have identical capabilities. Unused GL pins are configured as inputs with pull-up resistors.

See more detailed descriptions of global I/O connectivity in the "Clock Conditioning Circuits in Low Power Flash Devices and Mixed Signal FPGAs" chapter of the IGLOO PLUS FPGA Fabric User's Guide. All inputs labeled GC/GF are direct inputs into the quadrant clocks. For example, if GAA0 is used for an input, GAA1 and GAA2 are no longer available for input to the quadrant globals. All inputs labeled GC/GF are direct inputs into the chip-level globals, and the rest are connected to the quadrant globals. The inputs to the global network are multiplexed, and only one input can be used as a global input.

Refer to the I/O Structure chapter of the IGLOO PLUS FPGA Fabric User's Guide for an explanation of the naming of global pins.

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FF Flash*Freeze Mode Activation Pin

The FF pin is a dedicated input pin used to enter and exit Flash*Freeze mode. The FF pin is active low, has the same characteristics as a single-ended I/O, and must meet the maximum rise and fall times. When Flash*Freeze mode is not used in the design, the FF pin is available as a regular I/O.

When Flash*Freeze mode is used, the FF pin must not be left floating to avoid accidentally entering Flash*Freeze mode. While in Flash*Freeze mode, the Flash*Freeze pin should be constantly asserted.

The Flash*Freeze pin can be used with any single-ended I/O standard supported by the I/O bank in which the pin is located, and input signal levels compatible with the I/O standard selected. The FF pin should be treated as a sensitive asynchronous signal. When defining pin placement and board layout, simultaneously switching outputs (SSOs) and their effects on sensitive asynchronous pins must be considered.

Unused FF or I/O pins are tristated with weak pull-up. This default configuration applies to both Flash*Freeze mode and normal operation mode. No user intervention is required.

Table 3-1 shows the Flash*Freeze pin location on the available packages for IGLOO and ProASIC3L devices. The Flash*Freeze pin location is independent of device (except for a PQ208 package), allowing migration to larger or smaller IGLOO devices while maintaining the same pin location on the board. Refer to the "Flash*Freeze Technology and Low Power Modes" chapter of the *IGLOO PLUS Device Family User's Guide* for more information on I/O states during Flash*Freeze mode.

Table 3-1 • Flash*Freeze Pin Location in IGLOO PLUS Devices

Package	Flash*Freeze Pin
CS281	W2
CS201	R4
CS289	U1
VQ128	34
VQ176	47



Pin Descriptions and Packaging

JTAG Pins

Low power flash devices have a separate bank for the dedicated JTAG pins. The JTAG pins can be run at any voltage from 1.5 V to 3.3 V (nominal). VCC must also be powered for the JTAG state machine to operate, even if the device is in bypass mode; VJTAG alone is insufficient. Both VJTAG and VCC to the part must be supplied to allow JTAG signals to transition the device. Isolating the JTAG power supply in a separate I/O bank gives greater flexibility in supply selection and simplifies power supply and PCB design. If the JTAG interface is neither used nor planned for use, the VJTAG pin together with the TRST pin could be tied to GND.

TCK Test Clock

Test clock input for JTAG boundary scan, ISP, and UJTAG. The TCK pin does not have an internal pull-up/-down resistor. If JTAG is not used, Microsemi recommends tying off TCK to GND through a resistor placed close to the FPGA pin. This prevents JTAG operation in case TMS enters an undesired state.

Note that to operate at all VJTAG voltages, 500 Ω to 1 k Ω will satisfy the requirements. Refer to Table 3-2 for more information.

Table 3-2 • Recommended Tie-Off Values for the TCK and TRST Pins

VJTAG	Tie-Off Resistance
VJTAG at 3.3 V	200 Ω to 1 kΩ
VJTAG at 2.5 V	200 Ω to 1 kΩ
VJTAG at 1.8 V	500 Ω to 1 kΩ
VJTAG at 1.5 V	500 Ω to 1 kΩ

Notes:

- 1. Equivalent parallel resistance if more than one device is on the JTAG chain
- 2. The TCK pin can be pulled up/down.
- 3. The TRST pin is pulled down.

DI Test Data Input

Serial input for JTAG boundary scan, ISP, and UJTAG usage. There is an internal weak pull-up resistor on the TDI pin.

TDO Test Data Output

Serial output for JTAG boundary scan, ISP, and UJTAG usage.

TMS Test Mode Select

The TMS pin controls the use of the IEEE 1532 boundary scan pins (TCK, TDI, TDO, TRST). There is an internal weak pull-up resistor on the TMS pin.

TRST Boundary Scan Reset Pin

The TRST pin functions as an active-low input to asynchronously initialize (or reset) the boundary scan circuitry. There is an internal weak pull-up resistor on the TRST pin. If JTAG is not used, an external pull-down resistor could be included to ensure the test access port (TAP) is held in reset mode. The resistor values must be chosen from Table 3-2 and must satisfy the parallel resistance value requirement. The values in Table 3-2 correspond to the resistor recommended when a single device is used, and the equivalent parallel resistor when multiple devices are connected via a JTAG chain.

In critical applications, an upset in the JTAG circuit could allow entrance to an undesired JTAG state. In such cases, Microsemi recommends tying off TRST to GND through a resistor placed close to the FPGA pin.

Note that to operate at all VJTAG voltages, 500 Ω to 1 k Ω will satisfy the requirements.

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Special Function Pins

NC No Connect

This pin is not connected to circuitry within the device. These pins can be driven to any voltage or can be left floating with no effect on the operation of the device.

DC Do Not Connect

This pin should not be connected to any signals on the PCB. These pins should be left unconnected.

Packaging

Semiconductor technology is constantly shrinking in size while growing in capability and functional integration. To enable next-generation silicon technologies, semiconductor packages have also evolved to provide improved performance and flexibility.

Microsemi consistently delivers packages that provide the necessary mechanical and environmental protection to ensure consistent reliability and performance. Microsemi IC packaging technology efficiently supports high-density FPGAs with large-pin-count Ball Grid Arrays (BGAs), but is also flexible enough to accommodate stringent form factor requirements for Chip Scale Packaging (CSP). In addition, Microsemi offers a variety of packages designed to meet your most demanding application and economic requirements for today's embedded and mobile systems.

Related Documents

IGLOO PLUS Device Family User's Guide

http://www.microsemi.com/soc/documents/IGLOOPLUS UG.pdf

The following documents provide packaging information and device selection for low power flash devices.

Product Catalog

http://www.microsemi.com/soc/documents/ProdCat PIB.pdf

Lists devices currently recommended for new designs and the packages available for each member of the family. Use this document or the datasheet tables to determine the best package for your design, and which package drawing to use.

Package Mechanical Drawings

http://www.microsemi.com/soc/documents/PckgMechDrwngs.pdf

This document contains the package mechanical drawings for all packages currently or previously supplied by Microsemi. Use the bookmarks to navigate to the package mechanical drawings.

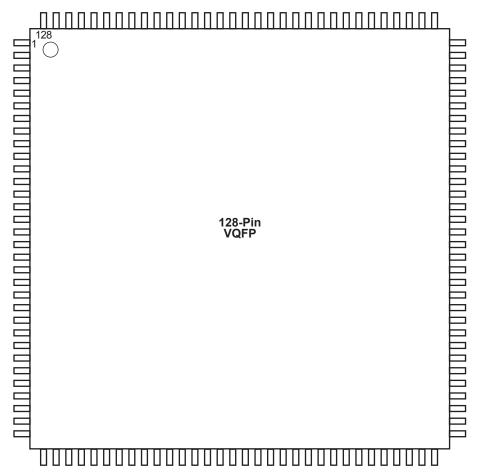
Additional packaging materials are available at

http://www.microsemi.com/soc/products/solutions/package/docs.aspx.



4 - Package Pin Assignments

VQ128



Note: This is the top view of the package.

Note

For Package Manufacturing and Environmental information, visit the Resource Center at http://www.microsemi.com/soc/products/solutions/package/docs.aspx.

Pin information is in the "Pin Descriptions" chapter of the IGLOO PLUS FPGA Fabric User's Guide.



VQ128		V	Q128	V	/Q128
Pin Number	AGLP030 Function	Pin Number	AGLP030 Function	Pin Number	AGLP030 Function
1	IO119RSB3	36	IO88RSB2	71	IO57RSB1
2	IO118RSB3	37	IO86RSB2	72	VCCIB1
3	IO117RSB3	38	IO84RSB2	73	GND
4	IO115RSB3	39	IO83RSB2	74	IO55RSB1
5	IO116RSB3	40	GND	75	IO54RSB1
6	IO113RSB3	41	VCCIB2	76	IO53RSB1
7	IO114RSB3	42	IO82RSB2	77	IO52RSB1
8	GND	43	IO81RSB2	78	IO51RSB1
9	VCCIB3	44	IO79RSB2	79	IO50RSB1
10	IO112RSB3	45	IO78RSB2	80	IO49RSB1
11	IO111RSB3	46	IO77RSB2	81	VCC
12	IO110RSB3	47	IO75RSB2	82	GDB0/IO48RSB1
13	IO109RSB3	48	IO74RSB2	83	GDA0/IO47RSB1
14	GEC0/IO108RSB3	49	VCC	84	GDC0/IO46RSB1
15	GEA0/IO107RSB3	50	IO73RSB2	85	IO45RSB1
16	GEB0/IO106RSB3	51	IO72RSB2	86	IO44RSB1
17	VCC	52	IO70RSB2	87	IO43RSB1
18	IO104RSB3	53	IO69RSB2	88	IO42RSB1
19	IO103RSB3	54	IO68RSB2	89	VCCIB1
20	IO102RSB3	55	IO66RSB2	90	GND
21	IO101RSB3	56	IO65RSB2	91	IO40RSB1
22	IO100RSB3	57	GND	92	IO41RSB1
23	IO99RSB3	58	VCCIB2	93	IO39RSB1
24	GND	59	IO63RSB2	94	IO38RSB1
25	VCCIB3	60	IO61RSB2	95	IO37RSB1
26	IO97RSB3	61	IO59RSB2	96	IO36RSB1
27	IO98RSB3	62	TCK	97	IO35RSB0
28	IO95RSB3	63	TDI	98	IO34RSB0
29	IO96RSB3	64	TMS	99	IO33RSB0
30	IO94RSB3	65	VPUMP	100	IO32RSB0
31	IO93RSB3	66	TDO	101	IO30RSB0
32	IO92RSB3	67	TRST	102	IO28RSB0
33	IO91RSB2	68	IO58RSB1	103	IO27RSB0
34	FF/IO90RSB2	69	VJTAG	104	VCCIB0
35	IO89RSB2	70	IO56RSB1	105	GND

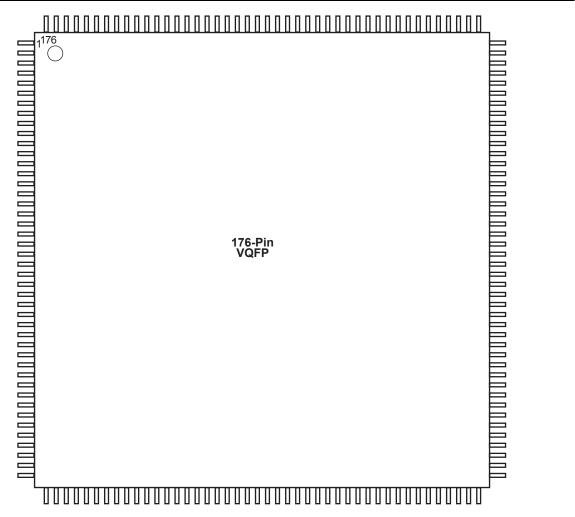
4-2 Revision 17



VQ128		
Pin Number	AGLP030 Function	
106	IO26RSB0	
107	IO25RSB0	
108	IO23RSB0	
109	IO22RSB0	
110	IO21RSB0	
111	IO19RSB0	
112	IO18RSB0	
113	VCC	
114	IO17RSB0	
115	IO16RSB0	
116	IO14RSB0	
117	IO13RSB0	
118	IO12RSB0	
119	IO10RSB0	
120	IO09RSB0	
121	VCCIB0	
122	GND	
123	IO07RSB0	
124	IO05RSB0	
125	IO03RSB0	
126	IO02RSB0	
127	IO01RSB0	
128	IO00RSB0	



VQ176



Note: This is the bottom view of the package.

Note

For Package Manufacturing and Environmental information, visit the Resource Center at http://www.microsemi.com/soc/products/solutions/package/docs.aspx.

4-4 Revision 17



VQ176		
	AGLP060	
Pin Number	Function	
1	GAA2/IO156RSB3	
2	IO155RSB3	
3	GAB2/IO154RSB3	
4	IO153RSB3	
5	GAC2/IO152RSB3	
6	GND	
7	VCCIB3	
8	IO149RSB3	
9	IO147RSB3	
10	IO145RSB3	
11	IO144RSB3	
12	IO143RSB3	
13	VCC	
14	IO141RSB3	
15	GFC1/IO140RSB3	
16	GFB1/IO138RSB3	
17	GFB0/IO137RSB3	
18	VCOMPLF	
19	GFA1/IO136RSB3	
20	VCCPLF	
21	GFA0/IO135RSB3	
22	GND	
23	VCCIB3	
24	GFA2/IO134RSB3	
25	GFB2/IO133RSB3	
26	GFC2/IO132RSB3	
27	IO131RSB3	
28	IO130RSB3	
29	IO129RSB3	
30	IO127RSB3	
31	IO126RSB3	
32	IO125RSB3	
33	IO123RSB3	
34	IO122RSB3	
35	IO121RSB3	

VQ176		
AGLP060		
Pin Number	Function	
36	IO119RSB3	
37	GND	
38	VCCIB3	
39	GEC1/IO116RSB3	
40	GEB1/IO114RSB3	
41	GEC0/IO115RSB3	
42	GEB0/IO113RSB3	
43	GEA1/IO112RSB3	
44	GEA0/IO111RSB3	
45	GEA2/IO110RSB2	
46	NC	
47	FF/GEB2/IO109R SB2	
48	GEC2/IO108RSB2	
49	IO106RSB2	
50	IO107RSB2	
51	IO104RSB2	
52	IO105RSB2	
53	IO102RSB2	
54	IO103RSB2	
55	GND	
56	VCCIB2	
57	IO101RSB2	
58	IO100RSB2	
59	IO99RSB2	
60	IO98RSB2	
61	IO97RSB2	
62	IO96RSB2	
63	IO95RSB2	
64	IO94RSB2	
65	IO93RSB2	
66	VCC	
67	IO92RSB2	
68	IO91RSB2	
69	IO90RSB2	

VQ176		
Pin Number	AGLP060 Function	
70	IO89RSB2	
71	IO88RSB2	
72	IO87RSB2	
73	IO86RSB2	
74	IO85RSB2	
75	IO84RSB2	
76	GND	
77	VCCIB2	
78	IO83RSB2	
79	IO82RSB2	
80	GDC2/IO80RSB2	
81	IO81RSB2	
82	GDA2/IO78RSB2	
83	GDB2/IO79RSB2	
84	NC	
85	NC	
86	TCK	
87	TDI	
88	TMS	
89	VPUMP	
90	TDO	
91	TRST	
92	VJTAG	
93	GDA1/IO76RSB1	
94	GDC0/IO73RSB1	
95	GDB1/IO74RSB1	
96	GDC1/IO72RSB1	
97	VCCIB1	
98	GND	
99	IO70RSB1	
100	IO69RSB1	
101	IO67RSB1	
102	IO66RSB1	
103	IO65RSB1	
104	IO63RSB1	



Pin Number AGLP060 Function 105 IO62RSB1 106 IO61RSB1 107 GCC2/IO60RSB1 108 GCB2/IO59RSB1 109 GCA2/IO58RSB1 110 GCA0/IO57RSB1 111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC	VQ176		
105 IO62RSB1 106 IO61RSB1 107 GCC2/IO60RSB1 108 GCB2/IO59RSB1 109 GCA2/IO58RSB1 110 GCA0/IO57RSB1 111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBB0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC		AGLP060	
106 IO61RSB1 107 GCC2/IO60RSB1 108 GCB2/IO59RSB1 109 GCA2/IO58RSB1 110 GCA0/IO57RSB1 111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	Pin Number	Function	
107 GCC2/IO60RSB1 108 GCB2/IO59RSB1 109 GCA2/IO58RSB1 110 GCA0/IO57RSB1 111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0	105	IO62RSB1	
108 GCB2/IO59RSB1 109 GCA2/IO58RSB1 110 GCA0/IO57RSB1 111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 110 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0	106	IO61RSB1	
109 GCA2/IO58RSB1 110 GCA0/IO57RSB1 111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0	107	GCC2/IO60RSB1	
110 GCA0/IO57RSB1 111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 120 GBB2/IO38RSB1 131 IO37RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	108	GCB2/IO59RSB1	
111 GCA1/IO56RSB1 112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	109	GCA2/IO58RSB1	
112 VCCIB1 113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	110	GCA0/IO57RSB1	
113 GND 114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	111	GCA1/IO56RSB1	
114 GCB0/IO55RSB1 115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	112	VCCIB1	
115 GCB1/IO54RSB1 116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	113	GND	
116 GCC0/IO53RSB1 117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	114	GCB0/IO55RSB1	
117 GCC1/IO52RSB1 118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	115	GCB1/IO54RSB1	
118 IO51RSB1 119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	116	GCC0/IO53RSB1	
119 IO50RSB1 120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	117	GCC1/IO52RSB1	
120 VCC 121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	118	IO51RSB1	
121 IO48RSB1 122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	119	IO50RSB1	
122 IO47RSB1 123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	120	VCC	
123 IO45RSB1 124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	121	IO48RSB1	
124 IO44RSB1 125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	122	IO47RSB1	
125 IO43RSB1 126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	123	IO45RSB1	
126 VCCIB1 127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	124	IO44RSB1	
127 GND 128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	125	IO43RSB1	
128 GBC2/IO40RSB1 129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	126	VCCIB1	
129 IO39RSB1 130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	127	GND	
130 GBB2/IO38RSB1 131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	128	GBC2/IO40RSB1	
131 IO37RSB1 132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	129	IO39RSB1	
132 GBA2/IO36RSB1 133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	130	GBB2/IO38RSB1	
133 GBA1/IO35RSB0 134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	131	IO37RSB1	
134 NC 135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	132	GBA2/IO36RSB1	
135 GBA0/IO34RSB0 136 NC 137 GBB1/IO33RSB0 138 NC	133	GBA1/IO35RSB0	
136 NC 137 GBB1/IO33RSB0 138 NC	134	NC	
137 GBB1/IO33RSB0 138 NC	135	GBA0/IO34RSB0	
138 NC	136	NC	
	137	GBB1/IO33RSB0	
139 GBC1/IO31RSB0	138	NC	
	139	GBC1/IO31RSB0	

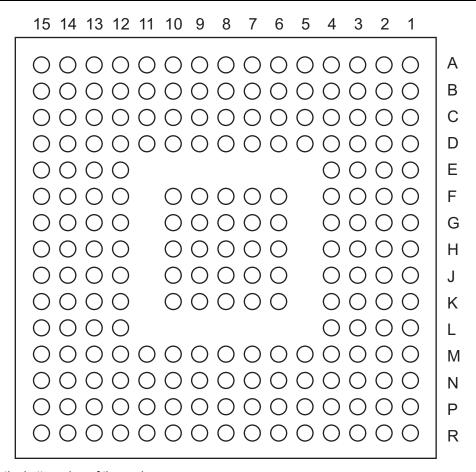
VQ176		
Pin Number	AGLP060 Function	
140	GBB0/IO32RSB0	
141	GBC0/IO30RSB0	
142	IO29RSB0	
143	IO28RSB0	
144	IO27RSB0	
145	VCCIB0	
146	GND	
147	IO26RSB0	
148	IO25RSB0	
149	IO24RSB0	
150	IO23RSB0	
151	IO22RSB0	
152	IO21RSB0	
153	IO20RSB0	
154	IO19RSB0	
155	IO18RSB0	
156	VCC	
157	IO17RSB0	
158	IO16RSB0	
159	IO15RSB0	
160	IO14RSB0	
161	IO13RSB0	
162	IO12RSB0	
163	IO11RSB0	
164	IO10RSB0	
165	IO09RSB0	
166	VCCIB0	
167	GND	
168	IO07RSB0	
169	IO08RSB0	
170	GAC1/IO05RSB0	
171	IO06RSB0	
172	GAB1/IO03RSB0	
173	GAC0/IO04RSB0	
174	GAB0/IO02RSB0	
117	J, (20/100211000	

VQ176		
Pin Number	AGLP060 Function	
175	GAA1/IO01RSB0	
176	GAA0/IO00RSB0	

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CS201



Note: This is the bottom view of the package.

Note

For Package Manufacturing and Environmental information, visit the Resource Center at http://www.microsemi.com/soc/products/solutions/package/docs.aspx.



CS201		CS201		CS201	
Pin Number	AGLP030 Function	Pin Number	AGLP030 Function	Pin Number	AGLP030 Function
A1	NC	C6	IO12RSB0	F3	IO119RSB3
A2	IO04RSB0	C7	IO23RSB0	F4	IO111RSB3
A3	IO06RSB0	C8	IO19RSB0	F6	GND
A4	IO09RSB0	C9	IO28RSB0	F7	VCC
A5	IO11RSB0	C10	IO32RSB0	F8	VCCIB0
A6	IO13RSB0	C11	IO35RSB0	F9	VCCIB0
A7	IO17RSB0	C12	NC	F10	VCCIB0
A8	IO18RSB0	C13	GND	F12	NC
A9	IO24RSB0	C14	IO41RSB1	F13	NC
A10	IO26RSB0	C15	IO37RSB1	F14	IO40RSB1
A11	IO27RSB0	D1	IO117RSB3	F15	IO38RSB1
A12	IO31RSB0	D2	IO118RSB3	G1	NC
A13	NC	D3	NC	G2	IO112RSB3
A14	NC	D4	GND	G3	IO110RSB3
A15	NC	D5	IO01RSB0	G4	IO109RSB3
B1	NC	D6	IO03RSB0	G6	VCCIB3
B2	NC	D7	IO10RSB0	G7	GND
B3	IO08RSB0	D8	IO21RSB0	G8	VCC
B4	IO05RSB0	D9	IO25RSB0	G9	GND
B5	IO07RSB0	D10	IO30RSB0	G10	GND
В6	IO15RSB0	D11	IO33RSB0	G12	NC
В7	IO14RSB0	D12	GND	G13	NC
B8	IO16RSB0	D13	NC	G14	IO42RSB1
В9	IO20RSB0	D14	IO36RSB1	G15	IO44RSB1
B10	IO22RSB0	D15	IO39RSB1	H1	NC
B11	IO34RSB0	E1	IO115RSB3	H2	GEB0/IO106RSB3
B12	IO29RSB0	E2	IO114RSB3	H3	GEC0/IO108RSB3
B13	NC	E3	NC	H4	NC
B14	NC	E4	NC	H6	VCCIB3
B15	NC	E12	NC	H7	GND
C1	NC	E13	NC	H8	VCC
C2	NC	E14	GDC0/IO46RSB1	H9	GND
C3	GND	E15	GDB0/IO48RSB1	H10	VCCIB1
C4	IO00RSB0	F1	IO113RSB3	H12	IO54RSB1
C5	IO02RSB0	F2	IO116RSB3	H13	GDA0/IO47RSB1

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CS201			
Pin Number	AGLP030 Function		
H14	IO45RSB1		
H15	IO43RSB1		
J1	GEA0/IO107RSB3		
J2	IO105RSB3		
J3	IO104RSB3		
J4	IO102RSB3		
J6	VCCIB3		
J7	GND		
J8	VCC		
J9	GND		
J10	VCCIB1		
J12	NC		
J13	NC		
J14	IO52RSB1		
J15	IO50RSB1		
K1	IO103RSB3		
K2	IO101RSB3		
K3	IO99RSB3		
K4	IO100RSB3		
K6	GND		
K7	VCCIB2		
K8	VCCIB2		
K9	VCCIB2		
K10	VCCIB1		
K12	NC		
K13	IO57RSB1		
K14	IO49RSB1		
K15	IO53RSB1		
L1	IO96RSB3		
L2	IO98RSB3		
L3	IO95RSB3		
L4	IO94RSB3		
L12	NC		
L13	NC		
L14	IO51RSB1		

CS201		
Pin Number	AGLP030 Function	
L15	IO58RSB1	
M1	IO93RSB3	
M2	IO92RSB3	
M3	IO97RSB3	
M4	GND	
M5	NC	
M6	IO79RSB2	
M7	IO77RSB2	
M8	IO72RSB2	
M9	IO70RSB2	
M10	IO61RSB2	
M11	IO59RSB2	
M12	GND	
M13	NC	
M14	IO55RSB1	
M15	IO56RSB1	
N1	NC	
N2	NC	
N3	GND	
N4	NC	
N5	IO88RSB2	
N6	IO81RSB2	
N6 N7	IO81RSB2 IO75RSB2	
N7	IO75RSB2	
N7 N8	IO75RSB2 IO68RSB2	
N7 N8 N9	IO75RSB2 IO68RSB2 IO66RSB2	
N7 N8 N9 N10	IO75RSB2 IO68RSB2 IO66RSB2 IO65RSB2	
N7 N8 N9 N10 N11	IO75RSB2 IO68RSB2 IO66RSB2 IO65RSB2 IO71RSB2	
N7 N8 N9 N10 N11	IO75RSB2 IO68RSB2 IO66RSB2 IO65RSB2 IO71RSB2 IO63RSB2	
N7 N8 N9 N10 N11 N12 N13	IO75RSB2 IO68RSB2 IO66RSB2 IO65RSB2 IO71RSB2 IO63RSB2 GND	
N7 N8 N9 N10 N11 N12 N13 N14	IO75RSB2 IO68RSB2 IO66RSB2 IO65RSB2 IO71RSB2 IO63RSB2 GND TDO	
N7 N8 N9 N10 N11 N12 N13 N14 N15	IO75RSB2 IO68RSB2 IO66RSB2 IO65RSB2 IO71RSB2 IO63RSB2 GND TDO VJTAG	
N7 N8 N9 N10 N11 N12 N13 N14 N15 P1	IO75RSB2 IO68RSB2 IO66RSB2 IO65RSB2 IO71RSB2 IO63RSB2 GND TDO VJTAG NC	

00004			
CS201			
Pin Number	AGLP030 Function		
P5	IO87RSB2		
P6	IO86RSB2		
P7	IO84RSB2		
P8	IO80RSB2		
P9	IO74RSB2		
P10	IO73RSB2		
P11	IO76RSB2		
P12	IO67RSB2		
P13	IO64RSB2		
P14	VPUMP		
P15	TRST		
R1	NC		
R2	NC		
R3	IO91RSB2		
R4	FF/IO90RSB2		
R5	IO89RSB2		
R6	IO83RSB2		
R7	IO82RSB2		
R8	IO85RSB2		
R9	IO78RSB2		
R10	IO69RSB2		
R11	IO62RSB2		
R12	IO60RSB2		
R13	TMS		
R14	TDI		
R15	TCK		



CS201			
Pin Number	AGLP060 Function	Piı	
A1	IO150RSB3		
A2	GAA0/IO00RSB0		
A3	GAC0/IO04RSB0		
A4	IO08RSB0		
A5	IO11RSB0		
A6	IO15RSB0		
A7	IO17RSB0		
A8	IO18RSB0		
A9	IO22RSB0		
A10	IO26RSB0		
A11	IO29RSB0		
A12	GBC1/IO31RSB0		
A13	GBA2/IO36RSB1		
A14	IO41RSB1		
A15	NC		
B1	IO151RSB3		
B2	GAB2/IO154RSB3		
В3	IO06RSB0		
B4	IO09RSB0		
B5	IO13RSB0		
В6	IO10RSB0		
В7	IO12RSB0		
B8	IO20RSB0		
В9	IO23RSB0		
B10	IO25RSB0		
B11	IO24RSB0		
B12	IO27RSB0		
B13	IO37RSB1		
B14	IO46RSB1		
B15	IO42RSB1		
C1	IO155RSB3		
C2	GAA2/IO156RSB3		
C3	GND		
C4	GAA1/IO01RSB0		
C5	GAB1/IO03RSB0		

CS201		
Pin Number	AGLP060 Function	
C6	IO07RSB0	
C7	IO16RSB0	
C8	IO21RSB0	
C9	IO28RSB0	
C10	GBB1/IO33RSB0	
C11	GBA1/IO35RSB0	
C12	GBB2/IO38RSB1	
C13	GND	
C14	IO48RSB1	
C15	IO39RSB1	
D1	IO146RSB3	
D2	IO144RSB3	
D3	IO148RSB3	
D4	GND	
D5	GAB0/IO02RSB0	
D6	GAC1/IO05RSB0	
D7	IO14RSB0	
D8	IO19RSB0	
D9	GBC0/IO30RSB0	
D10	GBB0/IO32RSB0	
D11	GBA0/IO34RSB0	
D12	GND	
D13	GBC2/IO40RSB1	
D14	IO51RSB1	
D15	IO44RSB1	
E1	IO142RSB3	
E2	IO149RSB3	
E3	IO153RSB3	
E4	GAC2/IO152RSB3	
E12	IO43RSB1	
E13	IO49RSB1	
E14	GCC0/IO53RSB1	
E15	GCB0/IO55RSB1	
F1	IO141RSB3	
F2	GFC1/IO140RSB3	

CS201		
AGLP060 Function		
IO145RSB3		
IO147RSB3		
GND		
VCC		
VCCIB0		
VCCIB0		
VCCIB0		
IO47RSB1		
IO45RSB1		
GCC1/IO52RSB1		
GCA1/IO56RSB1		
VCOMPLF		
GFB0/IO137RSB3		
GFC0/IO139RSB3		
IO143RSB3		
VCCIB3		
GND		
VCC		
GND		
GND		
IO50RSB1		
GCB1/IO54RSB1		
GCC2/IO60RSB1		
GCA2/IO58RSB1		
VCCPLF		
GFA1/IO136RSB3		
GFB1/IO138RSB3		
NC		
VCCIB3		
GND		
VCC		
GND		
VCCIB1		
GCB2/IO59RSB1		
GCA0/IO57RSB1		

Note: *Pin numbers G1 and H1 must be connected to ground because a PLL is not supported for AGLP060-CS/G201.

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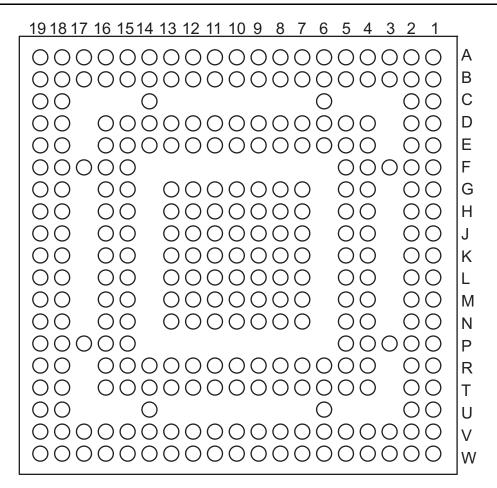
CS201		
	AGLP060	
Pin Number	Function	
H14	IO64RSB1	
H15	IO62RSB1	
J1	GFA2/IO134RSB3	
J2	GFA0/IO135RSB3	
J3	GFB2/IO133RSB3	
J4	IO131RSB3	
J6	VCCIB3	
J7	GND	
J8	VCC	
J9	GND	
J10	VCCIB1	
J12	IO61RSB1	
J13	IO63RSB1	
J14	IO68RSB1	
J15	IO66RSB1	
K1	IO130RSB3	
K2	GFC2/IO132RSB3	
K3	IO127RSB3	
K4	IO129RSB3	
K6	GND	
K7	VCCIB2	
K8	VCCIB2	
K9	VCCIB2	
K10	VCCIB1	
K12	IO65RSB1	
K13	IO67RSB1	
K14	IO69RSB1	
K15	IO70RSB1	
L1	IO126RSB3	
L2	IO128RSB3	
L3	IO121RSB3	
L4	IO123RSB3	
L12	GDB1/IO74RSB1	
L13	GDC1/IO72RSB1	
L14	IO71RSB1	

CS201		
Pin Number	AGLP060 Function	
L15	GDC0/IO73RSB1	
M1	IO122RSB3	
M2	IO124RSB3	
M3	IO119RSB3	
M4	GND	
M5	IO125RSB3	
M6	IO98RSB2	
M7	IO96RSB2	
M8	IO91RSB2	
M9	IO89RSB2	
M10	IO82RSB2	
M11	GDA2/IO78RSB2	
M12	GND	
M13	GDA1/IO76RSB1	
M14	GDA0/IO77RSB1	
M15	GDB0/IO75RSB1	
N1	IO117RSB3	
N2	IO120RSB3	
N3	GND	
N4	GEB1/IO114RSB3	
N5	IO107RSB2	
N6	IO100RSB2	
N7	IO94RSB2	
N8	IO87RSB2	
N9	IO85RSB2	
N10	GDC2/IO80RSB2	
N11	IO90RSB2	
N12	IO84RSB2	
N13	GND	
N14	TDO	
N15	VJTAG	
P1	GEC0/IO115RSB3	
P2	GEC1/IO116RSB3	
P3	GEA0/IO111RSB3	
P4	GEA1/IO112RSB3	

CS201			
	AGLP060		
Pin Number	Function		
P5	IO106RSB2		
P6	IO105RSB2		
P7	IO103RSB2		
P8	IO99RSB2		
P9	IO93RSB2		
P10	IO92RSB2		
P11	IO95RSB2		
P12	IO86RSB2		
P13	IO83RSB2		
P14	VPUMP		
P15	TRST		
R1	IO118RSB3		
R2	GEB0/IO113RSB3		
R3	GEA2/IO110RSB2		
R4	FF/GEB2/IO109RS B2		
R5	GEC2/IO108RSB2		
R6	IO102RSB2		
R7	IO101RSB2		
R8	IO104RSB2		
R9	IO97RSB2		
R10	IO88RSB2		
R11	IO81RSB2		
R12	GDB2/IO79RSB2		
R13	TMS		
R14	TDI		
R15	TCK		
N			



CS281



Note: This is the bottom view of the package.

Note

For Package Manufacturing and Environmental information, visit the Resource Center at http://www.microsemi.com/soc/products/solutions/package/docs.aspx

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CS281	
Pin Number	AGLP125 Function
A1	GND
A2	GAB0/IO02RSB0
A3	GAC1/IO05RSB0
A4	IO09RSB0
A5	IO13RSB0
A6	IO15RSB0
A7	IO18RSB0
A8	IO23RSB0
A9	IO25RSB0
A10	VCCIB0
A11	IO33RSB0
A12	IO41RSB0
A13	IO43RSB0
A14	IO46RSB0
A15	IO55RSB0
A16	IO56RSB0
A17	GBC1/IO58RSB0
A18	GBA0/IO61RSB0
A19	GND
B1	GAA2/IO211RSB3
B2	VCCIB0
В3	GAB1/IO03RSB0
B4	GAC0/IO04RSB0
B5	IO11RSB0
В6	GND
B7	IO21RSB0
B8	IO22RSB0
В9	IO28RSB0
B10	IO32RSB0
B11	IO36RSB0
B12	IO39RSB0
B13	IO42RSB0
B14	GND
B15	IO52RSB0
B16	GBC0/IO57RSB0
B17	GBA1/IO62RSB0

CS281	
Pin Number	AGLP125 Function
B18	VCCIB1
B19	IO64RSB1
C1	GAB2/IO209RSB3
C2	IO210RSB3
C6	IO12RSB0
C14	IO47RSB0
C18	IO54RSB0
C19	GBB2/IO65RSB1
D1	IO206RSB3
D2	IO208RSB3
D4	GAA0/IO00RSB0
D5	GAA1/IO01RSB0
D6	IO10RSB0
D7	IO17RSB0
D8	IO24RSB0
D9	IO27RSB0
D10	GND
D11	IO31RSB0
D12	IO40RSB0
D13	IO49RSB0
D14	IO45RSB0
D15	GBB0/IO59RSB0
D16	GBA2/IO63RSB1
D18	GBC2/IO67RSB1
D19	IO66RSB1
E1	IO203RSB3
E2	IO205RSB3
E4	IO07RSB0
E5	IO06RSB0
E6	IO14RSB0
E7	IO20RSB0
E8	IO29RSB0
E9	IO34RSB0
E10	IO30RSB0
E11	IO37RSB0
E12	IO38RSB0

CS281		
Pin Number	AGLP125 Function	
E13	IO48RSB0	
E14	GBB1/IO60RSB0	
E15	IO53RSB0	
E16	IO69RSB1	
E18	IO68RSB1	
E19	IO71RSB1	
F1	IO198RSB3	
F2	GND	
F3	IO201RSB3	
F4	IO204RSB3	
F5	IO16RSB0	
F15	IO50RSB0	
F16	IO74RSB1	
F17	IO72RSB1	
F18	GND	
F19	IO73RSB1	
G1	IO195RSB3	
G2	IO200RSB3	
G4	IO202RSB3	
G5	IO08RSB0	
G7	GAC2/IO207RSB3	
G8	VCCIB0	
G9	IO26RSB0	
G10	IO35RSB0	
G11	IO44RSB0	
G12	VCCIB0	
G13	IO51RSB0	
G15	IO70RSB1	
G16	IO75RSB1	
G18	GCC0/IO80RSB1	
G19	GCB1/IO81RSB1	
H1	GFB0/IO191RSB3	
H2	IO196RSB3	
H4	GFC1/IO194RSB3	
H5	GFB1/IO192RSB3	
H7	VCCIB3	



CS281	
Pin Number AGLP125 Function	
H8	VCC
H9	VCCIB0
H10	VCC
H11	VCCIB0
H12	VCC
H13	VCCIB1
H15	IO77RSB1
H16	GCB0/IO82RSB1
H18	GCA1/IO83RSB1
H19	GCA2/IO85RSB1
J1	VCOMPLF
J2	GFA0/IO189RSB3
J4	VCCPLF
J5	GFC0/IO193RSB3
J7	GFA2/IO188RSB3
J8	VCCIB3
J9	GND
J10	GND
J11	GND
J12	VCCIB1
J13	GCC1/IO79RSB1
J15	GCA0/IO84RSB1
J16	GCB2/IO86RSB1
J18	IO76RSB1
J19	IO78RSB1
K1	VCCIB3
K2	GFA1/IO190RSB3
K4	GND
K5	IO19RSB0
K7	IO197RSB3
K8	VCC
K9	GND
K10	GND
K11	GND
K12	VCC
K13	GCC2/IO87RSB1

CS281	
Pin Number	AGLP125 Function
K15	IO89RSB1
K16	GND
K18	IO88RSB1
K19	VCCIB1
L1	GFB2/IO187RSB3
L2	IO185RSB3
L4	GFC2/IO186RSB3
L5	IO184RSB3
L7	IO199RSB3
L8	VCCIB3
L9	GND
L10	GND
L11	GND
L12	VCCIB1
L13	IO95RSB1
L15	IO91RSB1
L16	NC
L18	IO90RSB1
L19	NC
M1	IO180RSB3
M2	IO179RSB3
M4	IO181RSB3
M5	IO183RSB3
M7	VCCIB3
M8	VCC
M9	VCCIB2
M10	VCC
M11	VCCIB2
M12	VCC
M13	VCCIB1
M15	IO122RSB2
M16	IO93RSB1
M18	IO92RSB1
M19	NC
N1	IO178RSB3
N2	IO175RSB3

00004		
CS281		
Pin Number	AGLP125 Function	
N4	IO182RSB3	
N5	IO161RSB2	
N7	GEA2/IO164RSB2	
N8	VCCIB2	
N9	IO137RSB2	
N10	IO135RSB2	
N11	IO131RSB2	
N12	VCCIB2	
N13	VPUMP	
N15	IO117RSB2	
N16	IO96RSB1	
N18	IO98RSB1	
N19	IO94RSB1	
P1	IO174RSB3	
P2	GND	
P3	IO176RSB3	
P4	IO177RSB3	
P5	GEA0/IO165RSB3	
P15	IO111RSB2	
P16	IO108RSB2	
P17	GDC1/IO99RSB1	
P18	GND	
P19	IO97RSB1	
R1	IO173RSB3	
R2	IO172RSB3	
R4	GEC1/IO170RSB3	
R5	GEB1/IO168RSB3	
R6	IO154RSB2	
R7	IO149RSB2	
R8	IO146RSB2	
R9	IO138RSB2	
R10	IO134RSB2	
R11	IO132RSB2	
R12	IO130RSB2	
R13	IO118RSB2	
R14	IO112RSB2	

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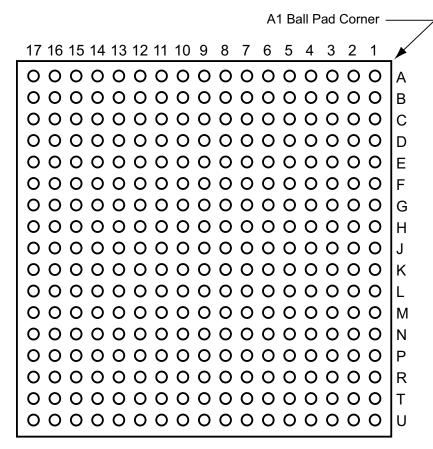


CS281	
Pin Number	AGLP125 Function
R15	IO109RSB2
R16	GDA1/IO103RSB1
R18	GDB0/IO102RSB1
R19	GDC0/IO100RSB1
T1	IO171RSB3
T2	GEC0/IO169RSB3
T4	GEB0/IO167RSB3
T5	IO157RSB2
T6	IO158RSB2
T7	IO148RSB2
Т8	IO145RSB2
Т9	IO143RSB2
T10	GND
T11	IO129RSB2
T12	IO126RSB2
T13	IO125RSB2
T14	IO116RSB2
T15	GDC2/IO107RSB2
T16	TMS
T18	VJTAG
T19	GDB1/IO101RSB1
U1	IO160RSB2
U2	GEA1/IO166RSB3
U6	IO151RSB2
U14	IO121RSB2
U18	TRST
U19	GDA0/IO104RSB1
V1	IO159RSB2
V2	VCCIB3
V3	GEC2/IO162RSB2
V4	IO156RSB2
V5	IO153RSB2
V6	GND
V7	IO144RSB2
V8	IO141RSB2
V9	IO140RSB2

CS281	
Pin Number	AGLP125 Function
V10	IO133RSB2
V11	IO127RSB2
V12	IO123RSB2
V13	IO120RSB2
V14	GND
V15	IO113RSB2
V16	GDA2/IO105RSB2
V17	TDI
V18	VCCIB2
V19	TDO
W1	GND
W2	FF/GEB2/IO163RSB 2
W3	IO155RSB2
W4	IO152RSB2
W5	IO150RSB2
W6	IO147RSB2
W7	IO142RSB2
W8	IO139RSB2
W9	IO136RSB2
W10	VCCIB2
W11	IO128RSB2
W12	IO124RSB2
W13	IO119RSB2
W14	IO115RSB2
W15	IO114RSB2
W16	IO110RSB2
W17	GDB2/IO106RSB2
W18	TCK
W19	GND



CS289



Note: This is the bottom view of the package.

Note

For Package Manufacturing and Environmental information, visit the Resource Center at $\label{eq:http://www.microsemi.com/soc/products/solutions/package/docs.aspx \ .$

4-16 Revision 17



CS289	
	AGLP030
Pin Number	Function
A1	IO03RSB0
A2	NC
A3	NC
A4	GND
A5	IO10RSB0
A6	IO14RSB0
A7	IO16RSB0
A8	IO18RSB0
A9	GND
A10	IO23RSB0
A11	IO27RSB0
A12	NC
A13	NC
A14	GND
A15	NC
A16	NC
A17	IO30RSB0
B1	IO01RSB0
B2	GND
В3	NC
B4	NC
B5	IO07RSB0
B6	NC
В7	VCCIB0
B8	IO17RSB0
В9	IO19RSB0
B10	IO24RSB0
B11	IO28RSB0
B12	VCCIB0
B13	NC
B14	NC
B15	NC
B16	IO31RSB0
B17	GND
C1	NC
C2	IO00RSB0
C3	IO04RSB0

CS289		
Pin Number	AGLP030 Function	
C4	NC	
C5	VCCIB0	
C6	IO09RSB0	
C7	IO13RSB0	
C8	IO15RSB0	
C9	IO21RSB0	
C10	GND	
C11	IO29RSB0	
C12	NC	
C13	NC	
C14	NC	
C15	GND	
C16	IO34RSB0	
C17	NC	
D1	NC	
D2	IO119RSB3	
D3	GND	
D4	IO02RSB0	
D5	NC	
D6	NC	
D7	NC	
D8	GND	
D9	IO20RSB0	
D10	IO25RSB0	
D11	NC	
D12	NC	
D13	GND	
D14	IO32RSB0	
D15	IO35RSB0	
D16	NC	
D17	NC	
E1	VCCIB3	
E2	IO114RSB3	
E3	IO115RSB3	
E4	IO118RSB3	
E5	IO05RSB0	
E6	NC	

CS289	
Pin Number	AGLP030 Function
E7	IO06RSB0
E8	IO11RSB0
E9	IO22RSB0
E10	IO26RSB0
E11	VCCIB0
E12	NC
E13	IO33RSB0
E14	IO36RSB1
E15	IO38RSB1
E16	VCCIB1
E17	NC
F1	IO111RSB3
F2	NC
F3	IO116RSB3
F4	VCCIB3
F5	IO117RSB3
F6	NC
F7	NC
F8	IO08RSB0
F9	IO12RSB0
F10	NC
F11	NC
F12	NC
F13	NC
F14	GND
F15	NC
F16	IO37RSB1
F17	IO41RSB1
G1	IO110RSB3
G2	GND
G3	IO113RSB3
G4	NC
G5	NC
G6	NC
G7	GND
G8	GND
G9	VCC
1	1



CS289	
AGLP030	
Pin Number	Function
G10	GND
G11	GND
G12	IO40RSB1
G13	NC
G14	IO39RSB1
G15	IO44RSB1
G16	NC
G17	GND
H1	NC
H2	GEC0/IO108RSB3
H3	NC
H4	IO112RSB3
H5	NC
H6	IO109RSB3
H7	GND
H8	GND
H9	GND
H10	GND
H11	GND
H12	NC
H13	NC
H14	IO45RSB1
H15	VCCIB1
H16	GDB0/IO48RSB1
H17	IO42RSB1
J1	NC
J2	GEA0/IO107RSB3
J3	VCCIB3
J4	IO105RSB3
J5	NC
J6	NC
J7	VCC
J8	GND
J9	GND
J10	GND
J11	VCC
J12	IO50RSB1

CS289		
Pin Number	AGLP030 Function	
J13	IO43RSB1	
J14	IO51RSB1	
J15	IO52RSB1	
J16	GDC0/IO46RSB1	
J17	GDA0/IO47RSB1	
K1	GND	
K2	GEB0/IO106RSB3	
K3	IO102RSB3	
K4	IO104RSB3	
K5	IO99RSB3	
K6	NC	
K7	GND	
K8	GND	
K9	GND	
K10	GND	
K11	GND	
K12	NC	
K13	NC	
K14	NC	
K15	IO53RSB1	
K16	GND	
K17	IO49RSB1	
L1	IO103RSB3	
L2	IO101RSB3	
L3	NC	
L4	GND	
L5	NC	
L6	NC	
L7	GND	
L8	GND	
L9	VCC	
L10	GND	
L11	GND	
L12	IO58RSB1	
L13	IO54RSB1	
L14	VCCIB1	
L15	NC	

CS289		
Pin Number	AGLP030 Function	
L16	NC	
L17	NC	
M1	NC	
M2	VCCIB3	
M3	IO100RSB3	
M4	IO98RSB3	
M5	IO93RSB3	
M6	IO97RSB3	
M7	NC	
M8	NC	
M9	IO71RSB2	
M10	NC	
M11	IO63RSB2	
M12	NC	
M13	IO57RSB1	
M14	NC	
M15	NC	
M16	NC	
M17	VCCIB1	
N1	NC	
N2	NC	
N3	IO95RSB3	
N4	IO96RSB3	
N5	GND	
N6	NC	
N7	IO85RSB2	
N8	IO79RSB2	
N9	IO77RSB2	
N10	VCCIB2	
N11	NC	
N12	NC	
N13	IO59RSB2	
N14	NC	
N15	GND	
N16	IO56RSB1	
N17	IO55RSB1	
P1	IO94RSB3	

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CS289		
	AGLP030	
Pin Number	Function	
P2	NC	
P3	GND	
P4	NC	
P5	NC	
P6	IO87RSB2	
P7	IO80RSB2	
P8	GND	
P9	IO72RSB2	
P10	IO67RSB2	
P11	IO61RSB2	
P12	NC	
P13	VCCIB2	
P14	NC	
P15	IO60RSB2	
P16	IO62RSB2	
P17	VJTAG	
R1	GND	
R2	IO91RSB2	
R3	NC	
R4	NC	
R5	NC	
R6	VCCIB2	
R7	IO83RSB2	
R8	IO78RSB2	
R9	IO74RSB2	
R10	IO70RSB2	
R11	GND	
R12	NC	
R13	NC	
R14	NC	
R15	NC	
R16	TMS	
R17	TRST	
T1	IO92RSB3	
T2	IO89RSB2	
Т3	NC	
T4	GND	
Т3	NC	

CS289		
AGLP030		
Pin Number	Function	
T5	NC	
Т6	IO84RSB2	
T7	IO81RSB2	
Т8	IO76RSB2	
Т9	VCCIB2	
T10	IO69RSB2	
T11	IO65RSB2	
T12	IO64RSB2	
T13	NC	
T14	GND	
T15	NC	
T16	TDI	
T17	TDO	
U1	FF/IO90RSB2	
U2	GND	
U3	NC	
U4	IO88RSB2	
U5	IO86RSB2	
U6	IO82RSB2	
U7	GND	
U8	IO75RSB2	
U9	IO73RSB2	
U10	IO68RSB2	
U11	IO66RSB2	
U12	GND	
U13	NC	
U14	NC	
U15	NC	
U16	TCK	
U17	VPUMP	



CS289		CS289		CS289	
Pin Number	AGLP060 Function	Pin Number	AGLP060 Function	Pin Number	AGLP060 Function
A1	GAB1/IO03RSB0	C5	VCCIB0	E9	IO22RSB0
A1 A2	NC	C6	IO09RSB0	E10	IO22RSB0
A2 A3	NC NC	C6	IO13RSB0	E10	VCCIB0
A4	GND	C8	IO15RSB0	E12	NC
A5	IO10RSB0	C9	IO21RSB0	E13	GBB1/IO33RSB0
A6	IO14RSB0	C10	GND	E14	GBA2/IO36RSB1
A7	IO16RSB0	C11	IO29RSB0	E15	GBB2/IO38RSB1
A8	IO18RSB0	C12	NC	E16	VCCIB1
A9	GND	C13	NC	E17	IO44RSB1
A10	IO23RSB0	C14	NC	F1	GFC1/IO140RSB3
A11	IO27RSB0	C15	GND	F2	IO142RSB3
A12	NC	C16	GBA0/IO34RSB0	F3	IO149RSB3
A13	NC	C17	IO39RSB1	F4	VCCIB3
A14	GND	D1	IO150RSB3	F5	GAB2/IO154RSB3
A15	NC	D2	IO151RSB3	F6	IO153RSB3
A16	NC	D3	GND	F7	NC
A17	GBC0/IO30RSB0	D4	GAB0/IO02RSB0	F8	IO08RSB0
B1	GAA1/IO01RSB0	D5	NC	F9	IO12RSB0
B2	GND	D6	NC	F10	NC
В3	NC	D7	NC	F11	NC
B4	NC	D8	GND	F12	NC
B5	IO07RSB0	D9	IO20RSB0	F13	GBC2/IO40RSB1
B6	NC	D10	IO25RSB0	F14	GND
В7	VCCIB0	D11	NC	F15	IO43RSB1
B8	IO17RSB0	D12	NC	F16	IO46RSB1
В9	IO19RSB0	D13	GND	F17	IO45RSB1
B10	IO24RSB0	D14	GBB0/IO32RSB0	G1	GFC0/IO139RSB3
B11	IO28RSB0	D15	GBA1/IO35RSB0	G2	GND
B12	VCCIB0	D16	IO37RSB1	G3	IO144RSB3
B13	NC	D17	IO42RSB1	G4	IO145RSB3
B14	NC	E1	VCCIB3	G5	IO146RSB3
B15	NC	E2	IO147RSB3	G6	IO148RSB3
B16	GBC1/IO31RSB0	E3	GAC2/IO152RSB3	G7	GND
B17	GND	E4	GAA2/IO156RSB3	G8	GND
C1	IO155RSB3	E5	GAC1/IO05RSB0	G9	VCC
C2	GAA0/IO00RSB0	E6	NC NC	G10	GND
C3	GAC0/IO04RSB0	E7	IO06RSB0	G11	GND
C4	NC NC	E8	IO11RSB0	G12	IO48RSB1
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CS289 (CS289	CS289		
Pin Number	AGLP060 Function	Pin Number	AGLP060 Function	Pin Number	AGLP060 Function
G13	IO41RSB1	J17	GCA1/IO56RSB1	M4	IO122RSB3
G14	IO47RSB1	K1	GND	M5	GEB0/IO113RSB3
G15	IO49RSB1	K2	GFA0/IO135RSB3	M6	GEB1/IO114RSB3
G16	IO50RSB1	K3	GFB2/IO133RSB3	M7	NC
G17	GND	K4	IO128RSB3	M8	NC
H1	VCOMPLF	K5	IO123RSB3	M9	IO90RSB2
H2	GFB0/IO137RSB3	K6	IO125RSB3	M10	NC
H3	NC	K7	GND	M11	IO83RSB2
H4	IO141RSB3	K8	GND	M12	NC
H5	IO143RSB3	K9	GND	M13	GDA1/IO76RSB1
H6	GFB1/IO138RSB3	K10	GND	M14	GDA0/IO77RSB1
H7	GND	K11	GND	M15	IO71RSB1
H8	GND	K12	IO64RSB1	M16	IO69RSB1
H9	GND	K13	IO61RSB1	M17	VCCIB1
H10	GND	K14	IO66RSB1	N1	IO119RSB3
H11	GND	K15	IO65RSB1	N2	IO120RSB3
H12	GCC1/IO52RSB1	K16	GND	N3	GEC0/IO115RSB3
H13	IO51RSB1	K17	GCC2/IO60RSB1	N4	GEA0/IO111RSB3
H14	GCA0/IO57RSB1	L1	GFA2/IO134RSB3	N5	GND
H15	VCCIB1	L2	GFC2/IO132RSB3	N6	NC
H16	GCA2/IO58RSB1	L3	IO127RSB3	N7	IO104RSB2
H17	GCC0/IO53RSB1	L4	GND	N8	IO98RSB2
J1	VCCPLF	L5	IO121RSB3	N9	IO96RSB2
J2	GFA1/IO136RSB3	L6	GEC1/IO116RSB3	N10	VCCIB2
J3	VCCIB3	L7	GND	N11	NC
J4	IO131RSB3	L8	GND	N12	NC
J5	IO130RSB3	L9	VCC	N13	GDB2/IO79RSB2
J6	IO129RSB3	L10	GND	N14	NC
J7	VCC	L11	GND	N15	GND
J8	GND	L12	GDC1/IO72RSB1	N16	GDB0/IO75RSB1
J9	GND	L13	GDB1/IO74RSB1	N17	GDC0/IO73RSB1
J10	GND	L14	VCCIB1	P1	IO118RSB3
J11	VCC	L15	IO70RSB1	P2	IO117RSB3
J12	GCB2/IO59RSB1	L16	IO68RSB1	P3	GND
J13	GCB1/IO54RSB1	L17	IO67RSB1	P4	NC
J14	IO62RSB1	M1	IO126RSB3	P5	NC
J15	IO63RSB1	M2	VCCIB3	P6	IO106RSB2
J16	GCB0/IO55RSB1	M3	IO124RSB3	P7	IO99RSB2



00000		
CS289		
Pin Number	AGLP060 Function	
P8	GND	
P9	IO91RSB2	
P10	IO86RSB2	
P11	IO81RSB2	
P12	NC	
P13	VCCIB2	
P14	NC	
P15	GDA2/IO78RSB2	
P16	GDC2/IO80RSB2	
P17	VJTAG	
R1	GND	
R2	GEA2/IO110RSB2	
R3	NC	
R4	NC	
R5	NC	
R6	VCCIB2	
R7	IO102RSB2	
R8	IO97RSB2	
R9	IO93RSB2	
R10	IO89RSB2	
R11	GND	
R12	NC	
R13	NC	
R14	NC	
R15	NC	
R16	TMS	
R17	TRST	
T1	GEA1/IO112RSB3	
T2	GEC2/IO108RSB2	
T3	NC	
T4	GND	
T5	NC	
T6	IO103RSB2	
T7	IO100RSB2	
T8	IO95RSB2	
T9	VCCIB2	
T10	IO88RSB2	
T11	IO84RSB2	

CS289		
Pin Number AGLP060 Funct		
T12	IO82RSB2	
T13	NC	
T14	GND	
T15	NC	
T16	TDI	
T17	TDO	
U1	FF/GEB2/IO109RS B2	
U2	GND	
U3	NC	
U4	IO107RSB2	
U5	IO105RSB2	
U6	IO101RSB2	
U7	GND	
U8	IO94RSB2	
U9	IO92RSB2	
U10	IO87RSB2	
U11	IO85RSB2	
U12	GND	
U13	NC	
U14	NC	
U15	NC	
U16	TCK	
U17	VPUMP	

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CS289		
Pin Number	AGLP125 Function	
A1	GAB1/IO03RSB0	
A2	IO11RSB0	
A3	IO08RSB0	
A4	GND	
A5	IO19RSB0	
A6	IO24RSB0	
A7	IO26RSB0	
A8	IO30RSB0	
A9	GND	
A10	IO35RSB0	
A11	IO38RSB0	
A12	IO40RSB0	
A13	IO42RSB0	
A14	GND	
A15	IO48RSB0	
A16	IO54RSB0	
A17	GBC0/IO57RSB0	
B1	GAA1/IO01RSB0	
B2	GND	
В3	IO06RSB0	
B4	IO13RSB0	
B5	IO15RSB0	
B6	IO21RSB0	
B7	VCCIB0	
B8	IO28RSB0	
B9	IO31RSB0	
B10	IO37RSB0	
B11	IO39RSB0	
B12	VCCIB0	
B13	IO44RSB0	
B14	IO46RSB0	
B15	IO49RSB0	
B16	GBC1/IO58RSB0	
B17	GND	
C1	IO210RSB3	
C2	GAA0/IO00RSB0	
C3	GAC0/IO04RSB0	
C4	IO09RSB0	

CS289		
Pin Number	AGLP125 Function	
C5	VCCIB0	
C6	IO17RSB0	
C7	IO23RSB0	
C8	IO27RSB0	
C9	IO33RSB0	
C10	GND	
C11	IO43RSB0	
C12	IO45RSB0	
C13	IO50RSB0	
C14	IO52RSB0	
C15	GND	
C16	GBA0/IO61RSB0	
C17	IO68RSB1	
D1	IO204RSB3	
D2	IO205RSB3	
D3	GND	
D4	GAB0/IO02RSB0	
D5	IO07RSB0	
D6	IO10RSB0	
D7	IO18RSB0	
D8	GND	
D9	IO34RSB0	
D10	IO41RSB0	
D11	IO47RSB0	
D12	IO55RSB0	
D13	GND	
D14	GBB0/IO59RSB0	
D15	GBA1/IO62RSB0	
D16	IO66RSB1	
D17	IO70RSB1	
E1	VCCIB3	
E2	IO200RSB3	
E3	GAC2/IO207RSB3	
E4	GAA2/IO211RSB3	
E5	GAC1/IO05RSB0	
E6	IO12RSB0	
E7	IO16RSB0	
E8	IO22RSB0	
	10221.020	

CS289		
Pin Number AGLP125 Function		
E9	IO32RSB0	
E10	IO36RSB0	
E11	VCCIB0	
E12	IO56RSB0	
E13	GBB1/IO60RSB0	
E14	GBA2/IO63RSB1	
E15	GBB2/IO65RSB1	
E16	VCCIB1	
E17	IO73RSB1	
F1	GFC1/IO194RSB3	
F2	IO196RSB3	
F3	IO202RSB3	
F4	VCCIB3	
F5	GAB2/IO209RSB3	
F6	IO208RSB3	
F7	IO14RSB0	
F8	IO20RSB0	
F9	IO25RSB0	
F10	IO29RSB0	
F11	IO51RSB0	
F12	IO53RSB0	
F13	GBC2/IO67RSB1	
F14	GND	
F15	IO75RSB1	
F16	IO71RSB1	
F17	IO77RSB1	
G1	GFC0/IO193RSB3	
G2	GND	
G3	IO198RSB3	
G4	IO203RSB3	
G5	IO201RSB3	
G6	IO206RSB3	
G7	GND	
G8	GND	
G9	VCC	
G10	GND	
G11	GND	
G12	IO72RSB1	
G 12	IOTZNOBI	



CS289		
Pin Number AGLP125 Function		
G13	IO64RSB1	
G14	IO69RSB1	
G15	IO78RSB1	
G16	IO76RSB1	
G17	GND	
H1	VCOMPLF	
H2	GFB0/IO191RSB3	
H3	IO195RSB3	
H4	IO197RSB3	
H5	IO199RSB3	
H6	GFB1/IO192RSB3	
H7	GND	
H8	GND	
H9	GND	
H10	GND	
H11	GND	
H12	GCC1/IO79RSB1	
H13	IO74RSB1	
H14	GCA0/IO84RSB1	
H15	VCCIB1	
H16	GCA2/IO85RSB1	
H17	GCC0/IO80RSB1	
J1	VCCPLF	
J2	GFA1/IO190RSB3	
J3	VCCIB3	
J4	IO185RSB3	
J5	IO183RSB3	
J6	IO181RSB3	
J7	VCC	
J8	GND	
J9	GND	
J10	GND	
J11	VCC	
J12	GCB2/IO86RSB1	
J13	GCB1/IO81RSB1	
J14	IO90RSB1	
J15	IO89RSB1	
J16	GCB0/IO82RSB1	

	CS289	
Pin Number	AGLP125 Function	
J17	GCA1/IO83RSB1	
K1	GND	
K2	GFA0/IO189RSB3	
K3	GFB2/IO187RSB3	
K4	IO179RSB3	
K5	IO175RSB3	
K6	IO177RSB3	
K7	GND	
K8	GND	
K9	GND	
K10	GND	
K11	GND	
K12	IO88RSB1	
K13	IO94RSB1	
K14	IO95RSB1	
K15	IO93RSB1	
K16	GND	
K17	GCC2/IO87RSB1	
L1	GFA2/IO188RSB3	
L2	GFC2/IO186RSB3	
L3	IO182RSB3	
L4	GND	
L5	IO173RSB3	
L6	GEC1/IO170RSB3	
L7	GND	
L8	GND	
L9	VCC	
L10	GND	
L11	GND	
L12	GDC1/IO99RSB1	
L13	GDB1/IO101RSB1	
L14	VCCIB1	
L15	IO98RSB1	
L16	IO92RSB1	
L17	IO91RSB1	
M1	IO184RSB3	
M2	VCCIB3	
M3	IO176RSB3	

CS289		
Pin Number	AGLP125 Function	
M4	IO172RSB3	
M5	GEB0/IO167RSB3	
M6	GEB1/IO168RSB3	
M7	IO159RSB2	
M8	IO161RSB2	
M9	IO135RSB2	
M10	IO128RSB2	
M11	IO121RSB2	
M12	IO113RSB2	
M13	GDA1/IO103RSB1	
M14	GDA0/IO104RSB1	
M15	IO97RSB1	
M16	IO96RSB1	
M17	VCCIB1	
N1	IO180RSB3	
N2	IO178RSB3	
N3	GEC0/IO169RSB3	
N4	GEA0/IO165RSB3	
N5	GND	
N6	IO156RSB2	
N7	IO148RSB2	
N8	IO144RSB2	
N9	IO137RSB2	
N10	VCCIB2	
N11	IO119RSB2	
N12	IO111RSB2	
N13	GDB2/IO106RSB2	
N14	IO109RSB2	
N15	GND	
N16	GDB0/IO102RSB1	
N17	GDC0/IO100RSB1	
P1	IO174RSB3	
P2	IO171RSB3	
P3	GND	
P4	IO160RSB2	
P5	IO157RSB2	
P6	IO154RSB2	
P7	IO152RSB2	

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	CS289
Pin Number	AGLP125 Function
P8	GND
P9	IO132RSB2
P10	IO125RSB2
P11	IO126RSB2
P12	IO112RSB2
P13	VCCIB2
P14	IO108RSB2
P15	GDA2/IO105RSB2
P16	GDC2/IO107RSB2
P17	VJTAG
R1	GND
R2	GEA2/IO164RSB2
R3	IO158RSB2
R4	IO155RSB2
R5	IO150RSB2
R6	VCCIB2
R7	IO145RSB2
R8	IO141RSB2
R9	IO134RSB2
R10	IO130RSB2
R11	GND
R12	IO118RSB2
R13	IO116RSB2
R14	IO114RSB2
R15	IO110RSB2
R16	TMS
R17	TRST
T1	GEA1/IO166RSB3
T2	GEC2/IO162RSB2
Т3	IO153RSB2
T4	GND
T5	IO147RSB2
T6	IO143RSB2
T7	IO140RSB2
Т8	IO139RSB2
Т9	VCCIB2
T10	IO131RSB2
T11	IO127RSB2

	00000		
	CS289		
Pin Number	AGLP125 Function		
T12	IO124RSB2		
T13	IO122RSB2		
T14	GND		
T15	IO115RSB2		
T16	TDI		
T17	TDO		
U1	FF/GEB2/IO163RS B2		
U2	GND		
U3	IO151RSB2		
U4	IO149RSB2		
U5	IO146RSB2		
U6	IO142RSB2		
U7	GND		
U8	IO138RSB2		
U9	IO136RSB2		
U10	IO133RSB2		
U11	IO129RSB2		
U12	GND		
U13	IO123RSB2		
U14	IO120RSB2		
U15	IO117RSB2		
U16	TCK		
U17	VPUMP		



5 — Datasheet Information

List of Changes

The following table lists critical changes that were made in each revision of the IGLOO PLUS datasheet.

Revision	Changes	Page
Revision 17 (December 2015)	Updated Commercial and Industrial temperature range to show junction temperature in "IGLOO PLUS Ordering Information" section and "Temperature Grade Offerings" section (SAR 73547).	1-III, 1-IV
	Removed Ambient temperature parameter in Table 2-2 • Recommended Operating Conditions ^{1,2} (SAR 73547).	2-2
	Table notes are added to Table 2-2 • Recommended Operating Conditions 1,2 stating that:	2-2
	VMV pins must be connected to the corresponding VCCI pins.	
	• Software default junction temperature range in the Libero SoC software is set to 0°C to +70°C for commercial, and -40°C to +85°C for industrial.	
	Updated Table 2-5 • Package Thermal Resistivities (SAR 60078).	2-6
	Added 2 mA drive strength information in the following tables (SAR 57182): • Table 2-36 • 3.3 V LVTTL / 3.3 V LVCMOS Low Slew – Applies to 1.5 V DC Core	2-28, 2-28,
	 Voltage Table 2-37 • 3.3 V LVTTL / 3.3 V LVCMOS High Slew – Applies to 1.5 V DC Core Voltage 	2-28, 2-29
	Table 2-38 • 3.3 V LVTTL / 3.3 V LVCMOS Low Slew – Applies to 1.2 V DC Core Voltage	
	Table 2-39 • 3.3 V LVTTL / 3.3 V LVCMOS High Slew – Applies to 1.2 V DC Core Voltage	
	Fixed typo for "VQ128" section in "Package Pin Assignments" section	4-1
Revision 16 (December 2012)	The "IGLOO PLUS Ordering Information" section has been updated to mention "Y" as "Blank" mentioning "Device Does Not Include License to Implement IP Based on the Cryptography Research, Inc. (CRI) Patent Portfolio" (SAR 43175).	≡
	The note in Table 2-90 • IGLOO PLUS CCC/PLL Specification and Table 2-91 • IGLOO PLUS CCC/PLL Specification referring the reader to SmartGen was revised to refer instead to the online help associated with the core (SAR 42566).	2-61, 2-62
	Live at Power-Up (LAPU) has been replaced with 'Instant On'.	NA
Revision 15 (October 2012)	Values updated for IGLOO PLUS V2 or V5 Devices, 1.5 V Core Supply Voltage in Table 2-15 • Different Components Contributing to Dynamic Power Consumption in IGLOO PLUS Devices and for IGLOO PLUS V2 Devices, 1.2 V Core Supply Voltage in Table 2-17 • Different Components Contributing to Dynamic Power Consumption in IGLOO PLUS Devices (SAR 31988). Also added a new Note to the two tables.	2-10, 2-11
	Libero Integrated Design Environment (IDE) was changed to Libero System-on-Chip (SoC) throughout the document (SAR 40277).	N/A
Revision 14 (September 2012)	The "Security" section was modified to clarify that Microsemi does not support readback of programmed data.	1-2



Revision	Changes	Page
Revision 13 (June 2012)	Figure 2-30 • FIFO Read and Figure 2-31 • FIFO Write have been added (SAR 34843).	2-73
	Updated the terminology used in Timing Characteristics in the following tables: Table 2-96 • FIFO and Table 2-97 • FIFO (SAR 38236).	2-76
	The following sentence was removed from the "VMVx I/O Supply Voltage (quiet)" section in the "Pin Descriptions and Packaging" section: "Within the package, the VMV plane is decoupled from the simultaneous switching noise originating from the output buffer VCCI domain" and replaced with "Within the package, the VMV plane biases the input stage of the I/Os in the I/O banks" (SAR 38320). The datasheet mentions that "VMV pins must be connected to the corresponding VCCI pins" for an ESD enhancement.	3-1
Revision 12 (March 2012)	The "In-System Programming (ISP) and Security" section and "Security" section were revised to clarify that although no existing security measures can give an absolute guarantee, Microsemi FPGAs implement the best security available in the industry (SAR 34664).	I, 1-2
	The Y security option and Licensed DPA Logo were added to the "IGLOO PLUS Ordering Information" section. The trademarked Licensed DPA Logo identifies that a product is covered by a DPA counter-measures license from Cryptography Research (SAR 34724).	III
	The "Specifying I/O States During Programming" section is new (SAR 34695).	1-7
	The following sentence was removed from the "Advanced Architecture" section: "In addition, extensive on-chip programming circuitry allows for rapid, single-voltage (3.3 V) programming of IGLOO PLUS devices via an IEEE 1532 JTAG interface" (SAR 34684).	1-3

5-2 Revision 17



Revision	Changes	Page
Revision 12 (continued)	The reference to guidelines for global spines and VersaTile rows, given in the "Global Clock Contribution—P _{CLOCK} " section, was corrected to the "Spine Architecture" section of the Global Resources chapter in the <i>IGLOO PLUS FPGA Fabric User's Guide</i> (SAR 34733).	2-12
	t_{DOUT} was corrected to t_{DIN} in Figure 2-4 • Input Buffer Timing Model and Delays (example) (SAR 37107).	2-16
	The AC Loading figures in the "Single-Ended I/O Characteristics" section were updated to match tables in the "Summary of I/O Timing Characteristics – Default I/O Software Settings" section (SAR 34887).	2-27
	Minimum pulse width High and Low values were added to the tables in the "Global Tree Timing Characteristics" section. The maximum frequency for global clock parameter was removed from these tables because a frequency on the global is only an indication of what the global network can do. There are other limiters such as the SRAM, I/Os, and PLL. SmartTime software should be used to determine the design frequency (SAR 36963).	2-58
	Table 2-90 • IGLOO PLUS CCC/PLL Specification and Table 2-91 • IGLOO PLUS CCC/PLL Specification were updated. A note was added to both tables indicating that when the CCC/PLL core is generated by Microsemi core generator software, not all delay values of the specified delay increments are available (SAR 34820).	2-61, 2-62
	The value for serial clock was missing from these tables and has been restored. The value and units for input cycle-to-cycle jitter were incorrect and have been restored. The note to Table 2-90 • IGLOO PLUS CCC/PLL Specification giving specifications for which measurements done was corrected from VCC/VCCPLL = 1.14 V to VCC/VCCPLL = 1.425 V. The Delay Range in Block: Programmable Delay 2 value in Table 2-91 • IGLOO PLUS CCC/PLL Specification was corrected from 0.025 to 0.863 (SAR 37058).	
	Figure 2-28 • Write Access after Read onto Same Address was deleted. Reference was made to a new application note, <i>Simultaneous Read-Write Operations in Dual-Port SRAM for Flash-Based cSoCs and FPGAs</i> , which covers these cases in detail (SAR 34868).	2-65,
	The port names in the SRAM "Timing Waveforms", SRAM "Timing Characteristics" tables, Figure 2-32 • FIFO Reset, and the FIFO "Timing Characteristics" tables were revised to ensure consistency with the software names (SAR 35748).	2-68, 2-74, 2-76
	The "Pin Descriptions and Packaging" chapter has been added (SAR 34769).	3-1
	Package names used in the "Package Pin Assignments" section were revised to match standards given in <i>Package Mechanical Drawings</i> (SAR 34769).	4-1
Revision 11 (July 2010)	The versioning system for datasheets has been changed. Datasheets are assigned a revision number that increments each time the datasheet is revised. The "IGLOO PLUS Device Status" table indicates the status for each device in the family.	N/A
	The "Reprogrammable Flash Technology" section was revised to add "250 MHz (1.5 V systems) and 160 MHz (1.2 V systems) System Performance."	I
	The "I/Os with Advanced I/O Standards" section was revised to add definitions for hot-swap and cold-sparing.	1-6
	Conditional statements regarding hot insertion were removed from the description of VI in Table 2-1 • Absolute Maximum Ratings, since all IGLOO PLUS devices are hot insertion enabled.	2-1



Revision	Changes	Page
Revision 11 (continued)	Table 2-2 • Recommended Operating Conditions 1,2 was revised. 1.2 V DC wide range supply voltage and 3.3 V wide range supply voltage (SAR 26270) were added for VCCI. VJTAG DC Voltage was revised (SAR 24052). The value range for VPUMP programming voltage for operation was changed from "0 to 3.45" to "0 to 3.6" (SAR 25220).	2-2
	Table 2-6 • Temperature and Voltage Derating Factors for Timing Delays (normalized to TJ = 70° C, VCC = 1.425 V) and Table 2-7 • Temperature and Voltage Derating Factors for Timing Delays (normalized to TJ = 70° C, VCC = 1.14 V) were revised.	2-6, 2-6
	Table 2-8 • Power Supply State per Mode is new.	2-7
	The tables in the "Quiescent Supply Current" section were updated (SARs 24882 and 24112). Some of the table notes were changed or deleted.	2-7
	VIH maximum values in tables were updated as needed to 3.6 V (SARs 20990, 79370).	N/A
	The values in the following tables were updated. 3.3 V LVCMOS and 1.2 V LVCMOS wide range were added to the tables where applicable.	
	Table 2-13 • Summary of I/O Input Buffer Power (per pin) – Default I/O Software Settings	2-9
	Table 2-14 • Summary of I/O Output Buffer Power (per pin) – Default I/O Software Settings ¹	2-9
	Table 2-21 • Summary of Maximum and Minimum DC Input and Output Levels Applicable to Commercial and Industrial Conditions—Software Default Settings	2-19 2-20
	Table 2-22 • Summary of Maximum and Minimum DC Input Levels Table 2-23 • Summary of AC Measuring Points	2-20
	Table 2-25 • Summary of I/O Timing Characteristics—Software Default Settings, STD Speed Grade, Commercial-Case Conditions: $T_J = 70^{\circ}\text{C}$, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V	2-22
	Table 2-26 • Summary of I/O Timing Characteristics—Software Default Settings, STD Speed Grade Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 3.0 V	2-23
	Table 2-28 • I/O Output Buffer Maximum Resistances ¹	2-24
	A table note was added to Table 2-16 • Different Components Contributing to the	2-10,
	Static Power Consumption in IGLOO PLUS Devices and Table 2-18 • Different Components Contributing to the Static Power Consumption in IGLOO PLUS Devices stating the value for PDC4 is the minimum contribution of the PLL when operating at lowest frequency.	2-11
	Table 2-29 • I/O Weak Pull-Up/Pull-Down Resistances was revised, including addition of 3.3 V and 1.2 V LVCMOS wide range.	2-25
	The notes defining $R_{WEAK\ PULL\text{-}UP\text{-}MAX}$ and $R_{WEAK\ PULLDOWN\text{-}MAX}$ were revised (SAR 21348).	
	Table 2-30 • I/O Short Currents IOSH/IOSL was revised to include data for 3.3 V and 1.2 V LVCMOS wide range (SAR 79353 and SAR 79366).	2-25
	Table 2-31 • Duration of Short Circuit Event before Failure was revised to change the maximum temperature from 110°C to 100°C, with an example of six months instead of three months (SAR 26259).	2-26

5-4 Revision 17



Revision	Changes	Page
Revision 11 (continued)	The tables in the "Single-Ended I/O Characteristics" section were updated. Notes clarifying IIL and IIH were added.	2-27
	Tables for 3.3 V LVCMOS and 1.2 V LVCMOS wide range were added (SAR 79370, SAR 79353, and SAR 79366).	
	Notes in the wide range tables state that the minimum drive strength for any LVCMOS 3.3 V (or LVCMOS 1.2 V) software configuration when run in wide range is $\pm 100~\mu A$. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models (SAR 25700).	
	The following sentence was deleted from the "2.5 V LVCMOS" section: It uses a 5 V-tolerant input buffer and push-pull output buffer (SAR 24916).	2-32
	The tables in the "Input Register" section, "Output Register" section, and "Output Enable Register" section were updated. The tables in the "VersaTile Characteristics" section were updated.	2-45 through 2-56
	The following tables were updated in the "Global Tree Timing Characteristics" section:	2-58
	Table 2-85 • AGLP060 Global Resource (1.5 V)	
	Table 2-86 • AGLP125 Global Resource (1.5 V)	
	Table 2-88 • AGLP060 Global Resource (1.2 V)	
	Table 2-90 • IGLOO PLUS CCC/PLL Specification and Table 2-91 • IGLOO PLUS CCC/PLL Specification were revised (SAR 79388). VCO output jitter and maximum peak-to-peak jitter data were changed. Three notes were added to the table in connection with these changes.	2-61
	Figure 2-28 • Write Access after Write onto Same Address and Figure 2-29 • Write Access after Read onto Same Address were deleted.	N/A
	The tables in the "SRAM", "FIFO" and "Embedded FlashROM Characteristics" sections were updated.	2-68, 2-78

Revision	Changes	Page
Revision 10 (Apr 2009) Product Brief v1.5 DC and Switching Characteristics Advance v0.5	The –F speed grade is no longer offered for IGLOO PLUS devices. References to it have been removed from the document. The speed grade column and note regarding –F speed grade were removed from "IGLOO PLUS Ordering Information". The "Speed Grade and Temperature Grade Matrix" section was removed.	III, IV
Revision 9 (Feb 2009) Product Brief v1.4	The "Advanced I/O" section was revised to add two bullets regarding support of wide range power supply voltage.	I
	The "I/Os with Advanced I/O Standards" section was revised to add 3.0 V wide range to the list of supported voltages. The "Wide Range I/O Support" section is new.	1-7
Revision 8 (Jan 2009) Packaging v1.5	The "CS201" pin table was revised to add a note regarding pins G1 and H1.	4-8
Revision 7 (Dec 2008) Product Brief v1.3	A note was added to IGLOO PLUS Devices: "AGLP060 in CS201 does not support the PLL."	I
	Table 2 • IGLOO PLUS FPGAs Package Size Dimensions was updated to change the nominal size of VQ176 from 100 to 400 mm ² .	II
Revision 6 (Oct 2008) DC and Switching Characteristics Advance v0.4	Data was revised significantly in the following tables: Table 2-25 • Summary of I/O Timing Characteristics—Software Default Settings, STD Speed Grade, Commercial-Case Conditions: T _J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V	2-22, 2-33
	Table 2-26 • Summary of I/O Timing Characteristics—Software Default Settings, STD Speed Grade Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 3.0 V Table 2-50 • 2.5 LVCMOS Low Slew – Applies to 1.2 V DC Core Voltage Table 2-51 • 2.5 V LVCMOS High Slew – Applies to 1.2 V DC Core Voltage	
Revision 5 (Aug 2008) Product Brief v1.2	The VQ128 and VQ176 packages were added to Table 1 • IGLOO PLUS Product Family, the "I/Os Per Package ¹ " table, Table 2 • IGLOO PLUS FPGAs Package Size Dimensions, "IGLOO PLUS Ordering Information", and the "Temperature Grade Offerings" table.	I to IV
Packaging v1.4	The "VQ128" package drawing and pin table are new.	4-2
	The "VQ176" package drawing and pin table are new.	4-5
Revision 4 (Jul 2008) Product Brief v1.1 DC and Switching Characteristics Advance v0.3	As a result of the Libero IDE v8.4 release, Actel now offers a wide range of core voltage support. The document was updated to change 1.2 V / 1.5 V to 1.2 V to 1.5 V.	N/A
Revision 3 (Jun 2008) DC and Switching Characteristics Advance v0.2	Tables have been updated to reflect default values in the software. The default I/O capacitance is 5 pF. Tables have been updated to include the LVCMOS 1.2 V I/O set.	N/A
	Table note 3 was updated in Table 2-2 • Recommended Operating Conditions ^{1,2} to add the sentence, "VCCI should be at the same voltage within a given I/O bank." References to table notes 5, 6, 7, and 8 were added. Reference to table note 3 was removed from VPUMP Operation and placed next to VCC.	2-2
	Table 2-4 • Overshoot and Undershoot Limits ¹ was revised to remove "as measured on quiet I/Os" from the title. Table note 2 was revised to remove "estimated SSO density over cycles." Table note 3 was deleted.	2-3

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Revision	Changes	Page
Revision 3 (continued)	The table note for Table 2-9 • Quiescent Supply Current (IDD) Characteristics, IGLOO PLUS Flash*Freeze Mode* to remove the sentence stating that values do not include I/O static contribution.	2-7
	The table note for Table 2-10 • Quiescent Supply Current (IDD) Characteristics, IGLOO PLUS Sleep Mode* was updated to remove VJTAG and VCCI and the statement that values do not include I/O static contribution.	2-7
	The table note for Table 2-11 • Quiescent Supply Current (IDD) Characteristics, IGLOO PLUS Shutdown Mode was updated to remove the statement that values do not include I/O static contribution.	2-7
	Note 2 of Table 2-12 • Quiescent Supply Current (IDD), No IGLOO PLUS Flash*Freeze Mode 1 was updated to include VCCPLL. Table note 4 was deleted.	2-8
	Table 2-13 • Summary of I/O Input Buffer Power (per pin) – Default I/O Software Settings and Table 2-14 • Summary of I/O Output Buffer Power (per pin) – Default I/O Software Settings ¹ were updated to remove static power. The table notes were updated to reflect that power was measured on VCC _I . Table note 2 was added to Table 2-13 • Summary of I/O Input Buffer Power (per pin) – Default I/O Software Settings.	2-9, 2-9
	Table 2-16 • Different Components Contributing to the Static Power Consumption in IGLOO PLUS Devices and Table 2-18 • Different Components Contributing to the Static Power Consumption in IGLOO PLUS Devices were updated to change the definition for P_{DC5} from bank static power to bank quiescent power. Table subtitles were added for Table 2-16 • Different Components Contributing to the Static Power Consumption in IGLOO PLUS Devices, Table 2-17 • Different Components Contributing to Dynamic Power Consumption in IGLOO PLUS Devices, and Table 2-18 • Different Components Contributing to the Static Power Consumption in IGLOO PLUS Devices.	2-10, 2-11
	The "Total Static Power Consumption—P _{STAT} " section was revised.	2-12
	Table 2-32 • Schmitt Trigger Input Hysteresis is new.	2-26
Packaging v1.3	The "CS281" package drawing is new.	4-13
	The "CS281" table for the AGLP125 device is new.	4-13
Revision 3 (continued)	The "CS289" package drawing was incorrect. The graphic was showing the CS281 mechanical drawing and not the CS289 mechanical drawing. This has now been corrected.	4-17
Revision 2 (Jun 2008) Packaging v1.2	The "CS289" table for the AGLP030 device is new.	4-17
Revision 1 (Jun 2008)	The "CS289" table for the AGLP060 device is new.	4-20
Packaging v1.1	The "CS289" table for the AGLP125 device is new.	4-23



Datasheet Categories

Categories

In order to provide the latest information to designers, some datasheet parameters are published before data has been fully characterized from silicon devices. The data provided for a given device, as highlighted in the "IGLOO PLUS Device" table on page II, is designated as either "Product Brief," "Advance," "Preliminary," or "Production." The definitions of these categories are as follows:

Product Brief

The product brief is a summarized version of a datasheet (advance or production) and contains general product information. This document gives an overview of specific device and family information.

Advance

This version contains initial estimated information based on simulation, other products, devices, or speed grades. This information can be used as estimates, but not for production. This label only applies to the DC and Switching Characteristics chapter of the datasheet and will only be used when the data has not been fully characterized.

Preliminary

The datasheet contains information based on simulation and/or initial characterization. The information is believed to be correct, but changes are possible.

Production

This version contains information that is considered to be final.

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